



FCC 47 CFR § 2.1093

**RF EXPOSURE EVALUATION REPORT
(Part 2: Test Under Dynamic Transmission Condition)**

FOR

GSM/WCDMA/LTE/5G NR Phone + BT/BLE, DTS/UNII a/b/g/n/ac/ax, NFC, WPT and UWB

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Attestation of Test Results

Applicant Name	SAMSUNG ELECTRONICS CO.,LTD.
FCC ID	A3LSMF946U
Model Number	SM-F946U, SM-F946U1
Applicable Standards	FCC 47 CFR § 2.1093
Date Tested	5/5/2023 to 5/17/2023
Test Results	Pass

UL Korea, Ltd. tested the above equipment in accordance with the requirements set forth in the above standards. All indications of Pass/Fail in this report are opinions expressed by UL Korea, Ltd. based on interpretations and/or observations of test results. Measurement Uncertainties were not taken into account and are published for informational purposes only. The test results show that the equipment tested is capable of demonstrating compliance with the requirements as documented in this report.

Note: The results documented in this report apply only to the tested sample, under the conditions and modes of operation as described herein. This document may not be altered or revised in any way unless done so by UL Korea, Ltd. and all revisions are duly noted in the revisions section. Any alteration of this document not carried out by UL Korea, Ltd. will constitute fraud and shall nullify the document. This report must not be used by the client to claim product certification, approval, or endorsement by IAS, any agency of the Federal Government, or any agency of any government.

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1. Introduction

The equipment under test (EUT) is SM-F946U & SM-F946U1 (FCC ID : A3LSMF946U), it contains the Qualcomm modems supporting 2G/3G/4G/5G technologies and WLAN/BT technologies. these modems are enabled with Qualcomm Smart Transmit feature to control and manage transmitting power in real time and to ensure at all times the time-averaged RF exposure is in compliance with the FCC requirement.

DUT contains embedded file system (EFS) version 20 configured for the Second generation (GEN2).

EFS v19 Verification

Per Qualcomm's 80-w2112-5 document, embeded file system (EFS) version 20 products are required to be verified for Smart Tx generation for relevant MCC setting. It was confirmed that this DUT contains embedded file system (EFS) version 20 configured for Smart Tx Second generation (GEN2) for Sub6 with MCC settings for the US market.

EFS v20 Generation	MCC
GEN2_SUB6_MMW	310

This purpose of the Part 2 report is to demonstrate the EUT complies with FCC RF exposure requirement under Tx varying transmission scenarios, thereby validity of Qualcomm Smart Transmit feature for FCC equipment authorization of A3LSMF946U.

1.1 Part.2 Test Case Reduction for Multiple filings

The number of test cases in Part 2 can be reduced in the case of multiple filings using same chipset and same EFS version (post full part 2 test on the first filing), the essential test cases in power measurement are required to ensure the Smart Transmit performs as expected in the new design, but the RF exposure measurement can be excluded.

So, This models (SM-F946U & SM-F946U1) used a same chipset and EFS version that had fully tested to Part.2 on first filing. Therefore, This model follow Part.2 Test case reduction procedures according to Qualcomm document (80-W2112-5). Please refer to section.4.1 for test case reduction scenarios.

1.2 Configurable parameters

Tx power at SAR design target (Plimit in dBm) for Tx transmitting frequency < 6GHz

The maximum time-average transmit power, in dBm, at which this radio configuration reaches the *SAR_design_target*. This *SAR_design_target* is pre-determined for the specific device and it shall be less than regulatory SAR limit after accounting for all design related tolerances. The time-averaged SAR is assessed against this *SAR_design_target* in real time to determine the compliance. The Plimit could vary with technology, band, antenna and DSI, therefore it has the unique value for each technology, band, antenna and DSI.

input.power.limit (dBm) for Tx transmitting frequency ≥ 6GHz

The maximum time-average power at the input of antenna element port, in dBm, at which each beam meets the *PD_design_target* that is less than the regulatory power density limit after according for all design related tolerances.

Reserve power margin (dB) (EFS version 19 or higher)

The reserve margin for WWAN radios and WLAN/BT radios can be configured for each sub6 antenna group, and each exposure category as shown below:

- *TOTAL_MIN_RES_RATIO*

This entry corresponds to the minimum reserve margin for WWAN radio or WLAN radio when operating in standalone mode per antenna group.

Here, *TOTAL_MIN_RES_RATIO* is 0.5.

- *WWAN_PRI_SPLIT_RATIO*, *WWAN_SEC_SPLIT_RATIO*, *WLAN_SPLIT_RATIO*

In multi-Tx scenarios in the same antenna group, minimum reserve for each active radio (i.e., WWAN primary radio, WWAN secondary radio, WLAN radio) is a product of the corresponding fraction out of sum of active radio split ratios and *TOTAL_MIN_RES_RATIO*.

Here, *WWAN_PRI_SPLIT_RATIO* is 1, *WWAN_SEC_SPLIT_RATIO* is 1 and *WLAN_SPLIT_RATIO* is 1.

- *WLAN_MARGIN_IN_MODEM_APM*

When WWAN modem is turned off (say, in airplane mode – APM), then the RF exposure budget is split between WLAN and BT radios,

where WLAN RF exposure budget is *WLAN_MARGIN_IN_MODEM_APM* and

BT exposure budget is $(1 - \text{WLAN_MARGIN_IN_MODEM_APM})$.

Here, *WLAN_MARGIN_IN_MODEM_APM* is 0.7.

- *BT (Bluetooth) Config*

BT_STANDALONE : desired BT transmit power = $(\text{BT_STANDALONE} * \text{Plimit})$ in BT single radio transmission condition, where *Plimit* is BT *Tx_Power_at_SAR_design_target* in mW.

BT_AND_1_RADIO_SAME_AG: reduced BT transmit power = $(\text{BT_AND_1_RADIO_SAME_AG} * \text{Plimit})$ in a two-radio transmission condition.

BT_AND_2+_RADIO_SAME_AG: further reduced BT transmit power = $(\text{BT_AND_2+_RADIO_SAME_AG} * \text{Plimit})$ in a three (or more)-radio transmission condition.

Here, *BT_STANDALONE* is 0.95, *BT_AND_1_RADIO_SAME_AG* is 0.3 and *BT_AND_2+_RADIO_SAME_AG* is 0.2.

Multi Tx factor (EFS version 19 or higher)

In single Tx transmission scenarios, Smart Transmit ensures time-averaged RF exposure is $\leq (SAR_design_target * 10^{(+sub6\ device\ uncertainty / 10)}) < regulatory\ RF\ exposure\ limit$ for sub6 radio managed by Smart Transmit.

In simultaneous Tx transmission scenarios, Smart Transmit ensures time-averaged RF exposure is $\leq (SAR_design_target * multi_Tx_factor * 10^{(+sub6\ device\ uncertainty / 10)}) < regulatory\ RF\ exposure\ limit$ for sub6 radios managed by Smart Transmit. These simultaneous transmission scenarios are listed below:

- 2-or-more radio scenarios within WWAN like EN-DC, LTE ULCA, etc.
- 2-or-more-radio across technologies such as WWAN+WLAN, WWAN+BT, WLAN+BT and WWAN+WLAN+BT transmission scenarios (if WLAN/BT radios are also managed by Smart Transmit).

This model's multi Tx factor is 1.0.

Force peak for Tx transmitting frequency < 6GHz

The Smart Transmit feature applies time-averaging windows when the device detects an MCC that matches Time-averaged Exposure MCCs list. For each of the MCCs under Time-Averaged Exposure MCCs list, the Smart Transmit feature can limit either maximum instantaneous Tx power or maximum time-average power to P_{limit} per tech/band/antenna/DSI. If force peak is set to '1' for a given tech/band/antenna/DSI in the EFS, then the Smart Transmit feature limits the maximum instantaneous Tx power to P_{limit} for the selected tech/band/antenna/DSI. In other words, with force peak set to '1', under static condition and in single active Tx scenario, Smart Transmit can guarantee Tx power level of P_{limit} at all times.

2. Tx Varying Transmission Test Cases and Test Proposal

To validate time averaging feature and demonstrate the compliance in Tx varying transmission conditions, the following transmission scenarios are covered in Part 2 test:

1. During a time-varying Tx power transmission: To prove that the Smart Transmit feature accounts for Tx power variations in time accurately.
2. During a call disconnected and re-establish scenario: To prove that the Smart Transmit feature accounts for history of past Tx power transmissions accurately.
3. During technology/band handover: To prove that the Smart Transmit feature functions correctly during transitions in technology/band.
4. During antenna (or beam) switch: To prove that the Smart Transmit feature functions correctly during transitions in antenna (Such as AsDiv scenario) or beams (different antenna array configurations).
5. During change in device state: To prove that the Smart Transmit feature functions correctly during transitions in device state, say, from body-worn state to hotspot, or say, from extremity mode to body-worn state, etc. Devices state here refers to all the device configurations required to be tested by FCC, for example, head position, body-worn position, hotspot mode, and extremity.
6. During time window switch: To prove that the Smart Transmit feature correctly handles the transition from one time window to another specified by FCC, and maintains the normalized time-averaged RF exposure to be less than normalized FCC limit of 1.0 at all times.
7. SAR vs. PD exposure switching during sub-6 + mmW transmission: To prove that the Smart Transmit feature functions correctly and ensures total RF exposure compliance during transitions in SAR dominant exposure, SAR + PD exposure, and PD only exposure scenarios.
8. SAR exposure switching between two active radios (radio1 and radio2): To prove that the Smart Transmit feature functions correctly and ensures total RF exposure compliance when exposure varies among SAR_radio1 only, SAR_radio1 + SAR_radio2, and SAR_radio2 only scenarios.
9. SAR exposure switching between sub6 radios favor modes: To prove that the Smart Transmit feature functions correctly and ensures total RF exposure compliance when exposure varies among SAR_radio1 only, SAR_radio1 + SAR_radio2, and SAR_radio2 only scenarios.
10. System level compliance continuity :
 - a) Within terrestrial networks (WWAN, WLAN, BT, etc.): To demonstrate the time averaged RF exposure compliance continuity during technology transition in both single-radio and multi-radio transmission scenarios and under both modes of WWAN modem.

As described in Part 0 report (QRD SAR Char and PD Char for Qualcomm Smart Transmit, Using Combination of Simulation and Measurement (80-W2112-2), the RF exposure is proportional to the Tx power for a SAR- and/or PD-characterized wireless device. Thus, time-averaging algorithm validation can be effectively performed through conducted/radiated power measurement. To have high confidence in this validation, but also be practical, the strategy for the validation including both power measurement and RF exposure measurement is outlined as follows:

Conducted power / Radiated power measurement:

- Measure conducted Tx power for $f < 6\text{GHz}$ and radiated Tx power (EIRP) for $f > 10\text{GHz}$
- Convert it into RF exposure and divide by respective FCC limits to get normalized exposure
- Perform time-averaging over predefined time windows
- Demonstrate that the total normalized time-averaged RF exposure is less than 1.0 for all transmission scenarios (i.e., previous scenarios 1 to 8);

- For sub-6 transmission only:

$$1g_or_10gSAR(t) = \frac{\text{conducted_Tx_power}(t)}{\text{conducted_Tx_power_P_limit}} * 1g_or_10gSAR_P_limit \quad (1a)$$

$$\frac{\frac{1}{T_{SAR}} \int_{t-T_{SAR}}^t 1g_or_10gSAR(t) dt}{FCC\ SAR\ limit} \leq 1 \quad (1b)$$

- For sub-6 + mmW transmission:

$$1g_or_10gSAR(t) = \frac{\text{conducted_Tx_power}(t)}{\text{conducted_Tx_power_P_limit}} * 1g_or_10gSAR_P_limit \quad (2a)$$

$$4cm^2PD(t) = \frac{\text{radiated_Tx_power}(t)}{\text{radiated_Tx_power_input.power.limit}} * 4cm^2PD_input.power.limit \quad (2b)$$

$$\frac{\frac{1}{T_{SAR}} \int_{t-T_{SAR}}^t 1g_or_10gSAR(t) dt}{FCC\ SAR\ limit} + \frac{\frac{1}{T_{PD}} \int_{t-T_{PD}}^t 4cm^2PD(t) dt}{FCC\ 4cm^2\ PD\ limit} \leq 1 \quad (2c)$$

Where, $\text{conducted_Tx_power}(t)$, $\text{conducted_Tx_power_P_limit}$, and $1g_or_10gSAR_P_limit$ correspond to the measured instantaneous conducted Tx power, measured conducted Tx power at P_{limit} , and measured $1gSAR$ or $10gSAR$ values at P_{limit} for the worst-case radio configuration within the tested technology/band/Antenna/DSI. Similarly, $\text{radiated_Tx_power}(t)$, $\text{radiated_Tx_power_input.power.limit}$, and $4cm^2PD_input.power.limit$ correspond to the measured instantaneous radiated Tx power, radiated Tx power at input.power.limit , and $4cm^2PD$ value at input.power.limit . T_{SAR} is the time window for $f < 6\text{GHz}$ radio defined by FCC; T_{PD} is the time window for $f \geq 6\text{GHz}$ radio defined by FCC.

RF Exposure measurement:

- Demonstrate the total RF exposure averaged over predefined time windows does not exceed FCC's SAR and PD limits, through time-averaged SAR and PD measurements for only scenario 1 to add confidence in the Smart Transmit feature validation, while avoiding the complexity in SAR/PD measurement (in particular, for scenario 3 requiring change in SAR probe calibration file to accommodate different bands and/or tissue simulating liquid).
 - For $f < 6\text{GHz}$ transmission only (Scenario 1): measure instantaneous SAR versus time and demonstrate total time-averaged RF exposure is less than 1.0 at all times.

$$1g_or_10gSAR(t) = \frac{pointSAR(t)}{pointSAR_P_{limit}} * 1g_or_10gSAR(t)_P_{limit} \quad (3a)$$

$$\frac{\frac{1}{T_{SAR}} \int_{t-T_{SAR}}^t 1g_or_10gSAR(t) dt}{FCC\ SAR\ limit} \leq 1 \quad (3b)$$

- For $f < 6\text{GHz} + f \geq 6\text{GHz}$ transmission (Scenario 1): measure instantaneous E-field versus time for $f \geq$ radio and instantaneous conducted power versus time for $f < 6$ radio, calculate total normalized time-averaged RF exposure versus time using below equations and demonstrate it less than 1.0 at all times.

$$1g_or_10gSAR(t) = \frac{conducted_Tx_power(t)}{conducted_Tx_power_P_{limit}} * 1g_or_10gSAR_P_{limit} \quad (4a)$$

$$4cm^2PD(t) = \frac{[pointE(t)]^2}{[pointE_input.power.limit]^2} * 4cm^2PD_input.power.limit \quad (4b)$$

$$\frac{\frac{1}{T_{SAR}} \int_{t-T_{SAR}}^t 1g_or_10gSAR(t) dt}{FCC\ SAR\ limit} + \frac{\frac{1}{T_{PD}} \int_{t-T_{PD}}^t 4cm^2PD(t) dt}{FCC\ 4cm^2PD\ limit} \leq 1 \quad (4c)$$

Where, $pointSAR(t)$, $pointSAR_P_{limit}$, and $1g_or_10gSAR_P_{limit}$ correspond to the measured instantaneous point SAR, measured point SAR at P_{limit} and measured $1gSAR$ or $10gSAR$ values at P_{limit} corresponding to $f < 6\text{ GHz}$ transmission for the worst-case radio configuration within the tested technology/band/Antenna/DSI. Similarly, $pointE(t)$, $pointE_input.power.limit$, and $4cm^2PD_input.power.limit$ correspond to the measured instantaneous E-field, E-field at $input.power.limit$, and $4cm^2PD$ value at $input.power.limit$ corresponding to $f \geq$ transmission.

Note: cDASY PD measurement system by Schmid & Partner Engineering AG (SPEAG) of Zurich, Switzerland measures relative E-field, and provides ratio (in dB) given by $10 * \text{Log}_{10}\{ [pointE(t)]^2 / [pointE_input.power.limit]^2 \}$ versus time.

Peak Exposure Mode :

When Smart Transmit is configured for peak exposure mode, the Power operates P_{limit} level.

3. SAR Time Averaging Validation Test Procedures

This chapter provides the test plan and test procedures for validating Qualcomm Smart Transmit feature for sub-6 transmission. The 100 seconds time window for operating $f < 3\text{GHz}$ is used as an example to detail the test procedures in this chapter. The same test plan and test procedures described in this chapter apply to 60 seconds time window for $3\text{GHz} \leq f < 6\text{GHz}$.

3.1. Test sequence determination for validation

Following the FCC recommendation, two test sequences having time-variation in Tx power are predefined for sub-6 ($f < 6\text{GHz}$) validation:

- Test sequence 1 : request EUT's Tx power to be at maximum power, measured P_{max} , for 80s, then requesting for half of the maximum power, i.e., measured $P_{max}/2$, for the rest of the time.
- Test sequence 2 : request EUT's Tx power to vary with time. This sequence is generated relative to measured P_{max} , measured P_{limit} and Calculated $P_{reserve}$ (= measured P_{limit} in dBm – Reserve_power_margin in dB) of EUT based on measured P_{limit} .

For WLAN, Since WLAN radios do not have closed loop power control, average Tx power level of WLAN radios is indirectly varied by transmitting at varying duty cycles. Test sequence #1 described previously can be converted into duty cycle at P_{max} , i.e., duty cycle for an arbitrary Tx power level = (Tx power level / P_{max}). Test sequence #2 is not achievable due to current test capability. Therefore, in the interim, it is exempt.

For BT, Smart Transmit with EFS version 19 (or Higher) does not allow instantaneous Tx power of BT radio to exceed P_{limit} at any time instance, therefore, BT is not needed to be included in time-varying test.

The details for generating these Sub-6's two test sequences & WLAN's test sequence are described and listed in Section A.

Note: For test sequence generation, "measured P_{limit} " and "measured P_{max} " are used instead of the " P_{limit} " specified in EFS entry and " P_{max} " specified for the device, because Smart Transmit feature operates against the actual power level of the " P_{limit} " that was calibrated for the EUT. The "measured P_{limit} " accurately reflects what the feature is referencing to, therefore, it should be used during feature validation testing. The RF tune up and device-to-device variation are already considered in Part 0 report prior to determining P_{limit} .

3.2. Test configuration selection criteria for validation Smart Transmit feature

For validating Smart Transmit feature, this section provides a general guidance to select test cases. In practice, an adjustment can be made in test case selection. The justification/clarification may be provide.

3.2.1 Test configuration selection for time-varying Tx power transmission

The Smart Transmit time averaging feature operation is independent of bands, modes, and channels for a given technology. Hence, validation of Smart Transmit on one band/mode/channel per technology is sufficient. Two bands per technology are proposed and selected for this testing to provide high confidence in this validation.

The criteria for the selection are based on the P_{limit} values determined in Part 0 report. Select two bands* in each supported technology that correspond to least** and highest*** P_{limit} values that are less than P_{max} for validating Smart Transmit.

- * If one P_{limit} level applies to all the bands within a technology, then only one band needs to be tested. In this case, within the bands having the same P_{limit} , the radio configuration (e.g., # of RBs, channel#) and device position that correspond to the highest *measured 1g or 10gSAR* at P_{limit} shown in Part 1 report is selected.
- ** In case of multiple bands having the same least P_{limit} within the technology, then select the band having the highest *measured 1g or 10gSAR* at P_{limit} .
- *** The band having a higher P_{limit} needs to be properly selected so that the power limiting enforced by Smart Transmit can be validated using the pre-defined test sequences. If the highest P_{limit} in a technology is too high where the power limiting enforcement is not needed when testing with the pre-defined test sequences, then the next highest level is checked. This process is continued within the technology until second band for validation test is determined.

3.2.2 Test configuration selection for change in call

The criteria to select a test configuration for call-drop measurement is:

- Select technology/band with least P_{limit} among all supported technologies/bands, and select the radio configuration (e.g., # of RBs, channel#) in this technology/band that corresponds to the highest *measured 1g or 10gSAR* at P_{limit} listed in Part 1 report.
- In case of multiple bands having same least P_{limit} , then select the band having the highest *measured 1g or 10gSAR* at P_{limit} in Part 1 report.
- Test for change in call is not required if all $P_{limit} > P_{max}$

This test is performed with the EUT's Tx power requested to be at maximum power, the above band selection will result in Tx power enforcement (i.e., during the time when EUT is forced to have Tx power at $P_{reserve}$) for longest duration in one FCC defined window. The call change (call drop/reestablish) is performed during the Tx power enforcement duration (i.e., during the time when EUT is forced to have Tx power at $P_{reserve}$). One test is sufficient as the feature operation is independent of technology and band.

3.2.3 Test configuration selection for change in technology/band

The selection criteria for this measurement is, for a given antenna, to have EUT switch from a technology/band with lowest P_{limit} within the technology group (in case of multiple bands having the same P_{limit} , then select the band with highest *measured 1g or 10gSAR* at P_{limit}) to a technology/band with highest P_{limit} within the technology group, in case of multiple bands having the same P_{limit} , then select the band with lowest *measured 1g or 10gSAR* at P_{limit} in Part 1 report, or vice versa.

This test is performed with the EUT's Tx power requested to be at maximum power, the technology/band switch is performed during Tx power enforcement duration (i.e., during the time when EUT is forced to have Tx power at $P_{reserve}$).

3.2.4 Test configuration selection for change in antenna

The criteria to select a test configuration for antenna switch measurement is:

- Whenever possible and supported by the EUT, first antenna switch configuration within the same technology/band (i.e., same technology and band combination).
- Then, select any technology/band that supports multiple Tx antennas, and has the highest difference in P_{limit} among all supported antennas.
- In case of multiple bands having same difference in P_{limit} among supported antennas, then select the band having the highest *measured 1g or 10gSAR* at P_{limit} in Part 1 report.

This test is performed with the EUT's Tx power requested to be at maximum power in selected technology/band, and antenna change is conducted during Tx power enforcement duration (i.e., during the time when EUT is forced to have Tx power at $P_{reserve}$).

3.2.5 Test configuration selection for change in DSI

The criteria to select a test configuration for DSI change test is:

- Select a technology/band having the $P_{limit} < P_{max}$ within any technology and DSI group, and for same technology/band having a different P_{limit} in any other DSI group. Note that the selected DSI transition need to be supported by the device.

This test is performed with the EUT's Tx power requested to be at maximum power in selected technology/band, and DSI change is conducted during Tx power enforcement duration (i.e., during the time when EUT is forced to have Tx power at $P_{reserve}$).

3.2.6 Test configuration selection for change in time window

FCC specifies different time window for time averaging based on operation frequency. The criteria to select a test configuration for validating Smart Transmit feature and demonstrating the compliance during the change in time window is:

- Select any technology/band that has operation frequency classified in a different time window defined by FCC (such as 100-seconds time window), and its corresponding P_{limit} is less than P_{max} if possible.
- Select the 2nd technology/band that has operation frequency classified in a different time window defined by FCC (such as 60-seconds time window), and its corresponding P_{limit} is less than P_{max} if possible.
- Note it is preferred both P_{limit} values of two selected technology/band less than corresponding P_{max} , but if not possible, at least one of technologies/bands has its P_{limit} less than P_{max} .

This test is performed with the EUT's Tx power requested to be at maximum power in selected technology/band. Test for one pair of time windows selected is sufficient as the feature operation is the same.

3.2.7 Test configuration selection for SAR exposure switching

If supported, the test configuration for SAR exposure switching should cover:

1. SAR exposure switch when two active radios are in the same time window
2. SAR exposure switch when two active radios are in different time windows. One test with two active radios in any two different time windows is sufficient as Smart Transmit operation is the same for RF exposure switch in any combination of two different time windows.

The Smart Transmit time averaging operation is independent of the source of SAR exposure (for example, LTE vs. Sub6 NR) and ensures total time-averaged RF exposure compliance. Hence, validation of Smart Transmit in any one simultaneous SAR transmission scenario (i.e., one combination for LTE + Sub6 NR transmission) is sufficient, where the SAR exposure varies among SAR_{radio1} only, SAR_{radio1} + SAR_{radio2}, and SAR_{radio2} only scenarios.

The criteria to select a test configuration for validating Smart Transmit feature during SAR exposure switching scenarios is:

- Select any two < 6GHz technologies/bands that the EUT supports simultaneous transmission (for example, LTE + Sub NR)
- Among all supported simultaneous transmission configurations, the selection order is
 1. Select one configuration where both P_{limit} of radio1 and radio2 is less than their corresponding P_{max} , preferably, with different P_{limits} . If this configuration is not available, then,
 2. Select one configuration that has P_{limit} less than its P_{max} for at least one radio. If this cannot be found, then,
 3. Select one configuration that has P_{limit} of radio1 and radio2 greater than P_{max} but with least $(P_{limit} - P_{max})$ delta.

Test for one simultaneous transmission scenario is sufficient as the feature operation is the same. Additional details for testing for LTE+Sub6 NR non-standalone is provided in Section.B.

3.2.8 Test configuration selection for system level compliance continuity

3.2.8.1 Selection criteria for WWAN/WLAN/BT system level test

The purpose of system level compliance test is to demonstrate the compliance continuity in the following scenarios:

1. Across technology switch
2. During transition from single technology to multi-technology
3. In transition when WWAN went from On to airplane mode
4. Active WLAN radio and/or Bluetooth (BT) radio with WWAN in airplane mode
5. Time window transition when WWAN in airplane mode

Note: Technology in this section refers to WWAN, WLAN or BT

The selection criteria for radios to be tested is to select a radio which has the largest P_{max} / P_{limit} Ratio among all configurations supported (including SISO, MIMO, DBS, SISO+MIMO or DBS+MIMO whichever appropriate) within each technology and within the same antenna group.

3.3. Test procedures for conducted power measurements

This section provides general conducted power measurement procedures to perform compliance test under dynamic transmission scenarios described in Section 2. In practice, an adjustment can be made in these procedures. The justification/clarification may be provided.

3.3.1 Time-varying Tx power transmission scenario

This test is performed with the two pre-defined test sequences described in Section 3.1 for all the technologies and bands selected in Section 3.2.1. The purpose of the test is to demonstrate the effectiveness of power limiting enforcement and that the time-averaged SAR (corresponding time averaged Tx power) does not exceed the FCC limit at all times (see Eq. (1a) and (1b)).

Test procedure:

1. Measure P_{max} , measure P_{limit} and calculate $Reserve_power_margin$ (= measured P_{limit} in dBm – $Reserve_power_margin$ in dB) and follow Section 3.1 to generate the test sequences for all the technologies and bands selected in Section 3.2.1. Both test sequence 1 and test sequence 2 are created based on measured P_{max} and measured P_{limit} of the EUT. Test condition to measure P_{max} and P_{limit} is:
 - Measure P_{max} with Smart Transmit disable and callbox set to request maximum power.
 - Measure P_{limit} with Smart Transmit enable and $Reserve_power_margin$ set to 0 dB (Peak exposure mode); callbox set to request maximum power.
2. Set $Reserve_power_margin$ to actual (intended) value (3dB for this EUT based on Part 1 report) and reset power on EUT to enable Smart Transmit, establish radio link in desired radio configuration, with callbox requesting the EUT's Tx power to be at pre-defined test sequence 1, measure and record Tx power versus time, and then convert the conducted Tx power into 1gSAR or 10gSAR value (see Eq. (1a)) using measured P_{limit} from above Step 1. Perform running time average to determine time-averaged power and 1gSAR or 10gSAR versus time as illustrated in Figure A-1 where using 100-seconds time window as an example.

Note: In Eq.(1a), instantaneous Tx power is converted into instantaneous 1gSAR or 10gSAR value by applying the measured worst-case 1gSAR or 10gSAR value at P_{limit} for the corresponding technology/band/antenna/DSI reported in Part 1 report.

Note: For an easier computation of the running time average, 0 dBm can be added at the beginning of the test sequences the length of the responding time window, for example, add 0 dBm for 100-seconds so the running time average can be directly performed starting with the first 100-seconds data using excel spreadsheet. This technique applies to all tests performed in this Part 2 report for easier time-averaged computation using excel spreadsheet.

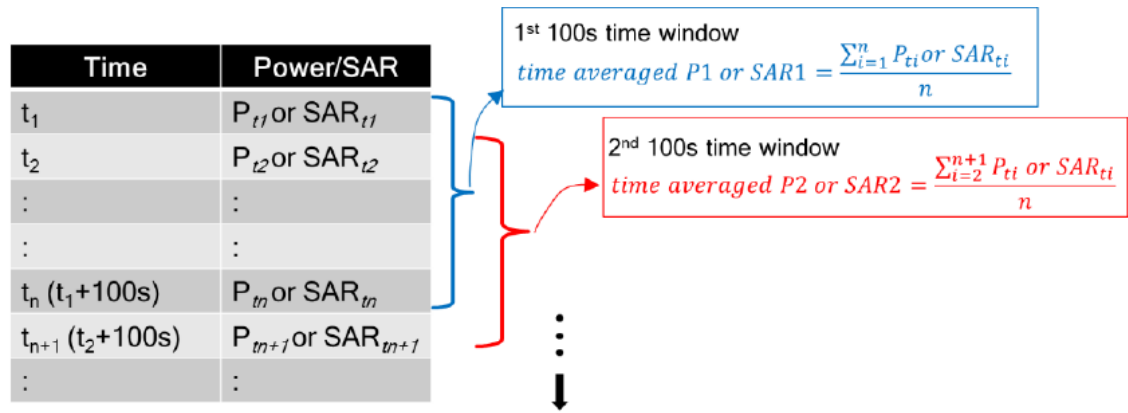


Figure A-1 100s running average illustration

3. Make one plot containing:
 - a. Computed time-averaged 1gSAR or 10gSAR versus time determined in Step 2
 - b. Corresponding regulatory 1g or 10gSAR_{limit} limit.
4. Repeated Steps 2 ~ 3 for pre-defined test sequence 2.
5. Repeat Steps 2 ~ 4 for all the selected technologies and bands.

The validation criteria is, at all times, the time-averaged 1gSAR or 10gSAR versus time shown in Step 2 (and plotted in Step 4) shall not exceed regulatory 1g or 10gSAR_{limit} limit.

3.3.2 Change in call scenario

This test is to demonstrate that Smart Transmit feature accurately accounts for the past Tx powers during time-averaging when a new call is established.

The call disconnects and re-establishment needs to be performed during power limit enforcement, i.e., when the EUT's Tx power is at $P_{reserve}$ level, to demonstrate the continuity of RF exposure management and limiting in call change scenario. In other words, the RF exposure averaged over any FCC defined time window (including the time windows containing the call change) doesn't exceed regulatory $1g$ or $10gSAR_{limit}$ limit.

Test procedure:

1. Measure P_{limit} for the technology/band selected in Section 3.2.2. measure P_{limit} with Smart Transmit enable and Reserve_power_margin set to 0 dB (Peak exposure mode); callbox set to request maximum power.
2. Set Reserve_power_margin to actual (intended) value and reset power on EUT to enable Smart Transmit.
3. Establish radio link with callbox in the selected technology/band.
4. Request EUT's Tx power at 0 dBm for at least one time window specified for the selected technology/band, followed by requesting EUT's Tx power to be at maximum power for about ~60 seconds, and then drop the call for ~10 seconds. Afterwards, re-establish another call in the same radio configuration (i.e., same technology/band/channel) and continue callbox requesting EUT's Tx power to be at maximum power for the remaining time of at least another full duration of the specified time window. Measure and record Tx power versus time.
5. Once the measurement is done, extract instantaneous Tx power versus time, and convert the conducted Tx power into 1g or 10gSAR value using Step 1 result, and then perform one time window specified running average to determine time-averaged 1g or 10gSAR value versus time.
6. Make one plot containing: (a) computed time-averaged 1g or 10gSAR versus time determine in Step 4 for the first call, (b) computed time-averaged 1g or 10gSAR versus time determine in Step 4 for the second call, (c) computed time-averaged 1g or 10gSAR of the first call and second call versus time and (d) corresponding regulatory $1g$ or $10gSAR_{limit}$ limit.

The validation criteria are, at all times, the combined time-averaged 1gSAR or 10gSAR versus time determined in Step 6c shall not exceed the regulatory $1g$ or $10gSAR_{limit}$ limit.

3.3.3 Change in technology and band

This test is to demonstrate the correct power control by Smart Transmit during technology and/or band handovers.

Similar to the change in call test in Section 3.3.2, to validate the continuity of RF exposure limiting during the transition, the technology and band handover needs to be performed when EUT's Tx power is at $P_{reserve}$ level (i.e., during Tx power enforcement) to make sure that the EUT's Tx power from previous $P_{reserve}$ level to the new $P_{reserve}$ level (corresponding to new technology/band). Since the P_{limit} could vary with technology and band, Eq.(1a) can be written as follows to convert the instantaneous Tx power in 1gSAR or 10gSAR exposure for the two given radios, respectively:

$$1g_or_10gSAR_1(t) = \frac{conducted_Tx_power_1(t)}{conducted_Tx_power_P_{limit_1}} * 1g_or_10gSAR_P_{limit_1}$$

$$1g_or_10gSAR_2(t) = \frac{conducted_Tx_power_2(t)}{conducted_Tx_power_P_{limit_2}} * 1g_or_10gSAR_P_{limit_2}$$

$$\frac{1}{T_{SAR}} \left[\int_{t-T_{SAR}}^{t_1} \frac{1g_or_10gSAR_1(t)}{FCC\ SAR\ limit} dt + \int_{t-T_{SAR}}^t \frac{1g_or_10gSAR_2(t)}{FCC\ SAR\ limit} dt \right] \leq 1$$

where, $conducted_Tx_power_1(t)$, $conducted_Tx_power_P_{limit_1}$, and $1g_or_10gSAR_P_{limit_1}$ correspond to the measured instantaneous conducted Tx power, measured conducted Tx power at P_{limit} , and measured $1g$ SAR or $10g$ SAR value at technology1/band1; $conducted_Tx_power_2(t)$, $conducted_Tx_power_P_{limit_2}$, and $1g_or_10gSAR_P_{limit_2}$ correspond to the measured instantaneous conducted Tx power, measured conducted Tx power at P_{limit} , and measured $1g$ SAR or $10g$ SAR value at P_{limit} of technology2/band2. Transition from technology1/band1 to the technology2/band2 happens at time-instant ' t_1 '.

Test procedure:

1. Measure P_{limit} for both the technologies and bands selected in Section 3.2.3. Measure P_{limit} with Smart Transmit enabled and *Reserve_power_margin* set to 0 dB (Peak exposure mode); callbox set to request maximum power.
2. Set *Reserve_power_margin* to actual(intended) value and reset power on EUT to enable Smart Transmit.
3. Establish radio link with callbox in first technology/band selected.
4. Request EUT's Tx power at 0 dBm for at least one time window specified for the selected technology/band, followed by requesting EUT's Tx power to be at maximum power for about ~60 second, and then switch to second technology/band selected. Continue with callbox requesting EUT's Tx power to be at maximum power for the remaining time of least another full duration of the specified time window. Measure and record Tx power versus time for the full duration of the test.
5. Once the measurement is done, extract instantaneous Tx power versus time, and convert the conducted Tx power into $1g$ SAR or $10g$ SAR value using Eq.(6a) and (6b) and corresponding measured P_{limit} values from Step 1 of this section. Perform the running time average to determine time-averaged power and $1g$ SAR or $10g$ SAR versus time.
 Note: In Eq.(6a) & (6b), instantaneous Tx power is converted into instantaneous $1g$ SAR or $10g$ SAR value by applying the measured the measured worst-case $1g$ SAR or $10g$ SAR value at P_{limit} for the corresponding technology/band reported in Part 1 report.
6. Make one plot containing: (a) computed time-averaged $1g$ SAR or $10g$ SAR of the first technology/band versus time determined in Step 5, (b) computed time-averaged $1g$ SAR or $10g$ SAR of the second technology/band versus time determined in Step 5, (c) combined time-averaged $1g$ or $10g$ SAR of the first technology/band and second technology/band versus time determined in Step 5 and (d) corresponding regulatory $1g$ or $10gSAR_{limit}$ limit.

The validation criteria are, at all times, the combined time-averaged $1g$ SAR or $10g$ SAR versus time determined in Step 6c shall not exceed the regulatory $1g$ or $10gSAR_{limit}$ limit.

3.3.4 Change in antenna

This test is to demonstrate the correct power control by Smart Transmit during antenna switches from primary to diversity. The test procedure is identical to Section 3.3.3, with switching antenna instead of technology/band. The validation criteria are, at all times, the time-average 1gSAR or 10gSAR versus time shall not exceed the regulatory *1g or 10gSAR_{limit}* limit.

Note: If the EUT does not support multiple transmitting WWAN antennas, the compliance plot for change in antenna should be similar to the plot for change in technology/band.

3.3.5 Change in DSI

This test is to demonstrate the correct power control by Smart Transmit during DSI switches from one DSI to another. The test procedure is identical to Section 3.3.3, with changing device state instead of technology/band. The validation criteria is, at all times, the time-averaged 1gSAR or 10gSAR versus time shall not exceed the regulatory *1g or 10gSAR_{limit}* limit.

Note: If the EUT does not support multiple device states, the compliance plot for change in device state should be similar to the plot for change in technology/band.

3.3.6 Change in time window

This test is to demonstrate the correct power control by Smart Transmit during the change in averaging time window when a specific band handover occurs. FCC specifies time-averaging window of 100s for Tx frequency < 3GHz, and 60s for Tx frequency between 3GHz and 6GHz. To validate the continuity of RF exposure limiting during the transition, the band handover test needs to be performed when EUT handovers from operation band less than 3GHz to greater than 3GHz and vice versa. The equations (3a) and (3b) in Section 2 can be written as follows for transmission scenario having change in time window:

$$1gSAR_1(t) = \frac{\text{conducted_Tx_power_1}(t)}{\text{conducted_Tx_power_P}_{limit_1}} * 1g_or\ 10g_SAR_P_{limit_1}$$

$$1gSAR_2(t) = \frac{\text{conducted_Tx_power_2}(t)}{\text{conducted_Tx_power_P}_{limit_2}} * 1g_or\ 10g_SAR_P_{limit_2}$$

$$\frac{1}{T1_{SAR}} \left[\int_{t-T1_{SAR}}^{t_1} \frac{1g_or\ 10g_SAR_1(t)}{FCC\ SAR\ limit} dt \right] + \frac{1}{T2_{SAR}} \left[\int_{t-T2_{SAR}}^t \frac{1g_or\ 10g_SAR_2(t)}{FCC\ SAR\ limit} dt \right] \leq 1$$

Where, *conducted_Tx_power_1(t)*, *conducted_Tx_power_P_{limit_1}(t)*, and *1g_or 10g_SAR_P_{limit_1}* correspond to the instantaneous Tx power, conducted Tx power at P_{limit}, and compliance *1g_or 10g_SAR* values at *P_{limit_1}* of band1 with time-averaging window '*T1_{SAR}*'; *conducted_Tx_power_2(t)*, *Conducted Tx power at P_{limit}*, and compliance *1g_or 10g_SAR* values at *P_{limit_2}* of Band2 with time-averaging window '*T2_{SAR}*'. One of the two bands is less than 3GHz, another is greater than 3GHz. Transition from first band with time-averaging window '*T1_{SAR}*' to the second band with time-averaging window '*T2_{SAR}*' happens at time-instant '*t₁*'.

Test procedure:

1. Measure P_{limit} for both the technologies and bands selected in Section 3.2.6 Measure P_{limit} with Smart Transmit enabled and *Reserve_power_margin* set to 0 dB(Peak exposure mode), callbox set to request maximum power.
2. Set *Reserve_power_margin* to actual (intended) value and enable Smart Transmit.

Transition from 100s time window to 60s time window, and vice versa

3. Establish radio link with callbox in the technology/band having 100s time window selected in Section 3.2.6.
4. Request EUT's Tx power to be at 0 dBm for at least 100 seconds, followed by requesting EUT's Tx power to be at maximum power for about ~140 seconds, and then switch to second technology/band (having 60s time window) selected in Section 3.2.6. Continue with callbox requesting EUT's Tx power to be at maximum power for at least another 100s. Measure and record Tx power versus time for the entire duration of the test.
5. Once the measurement is done, extract instantaneous Tx power versus time, and convert the conducted Tx power into 1gSAR or 10gSAR value (see Eq.(7a) and (7b)) using corresponding technology/band Step 1 result, and then perform 100s average to determine time-averaged 1gSAR or 10gSAR versus time. Note that in Eq.(7a) & (7B), instantaneous Tx power is converted into instantaneous 1gSAR or 10gSAR value by applying the worst-case 1gSAR or 10gSAR value tested in Part 1 for the selected technologies/bands at P_{limit} .
6. Make one plot containing: (a) computed time-averaged 1g or 10gSAR of the first technology/band (having 100s time window) versus time determined in Step 5, (c) computed time-averaged 1g or 10gSAR of the second technology/band (having 60s time window) versus time determined in Step 5, (c) combined time-averaged 1g or 10gSAR of (a) and (b), and (d) corresponding regulatory 1g or 10gSAR_{limit} limit.

Transition from 60s time window to 100s time window, and vice versa

7. Establish radio link with callbox in the technology/band having 60s time window selected in Section 3.2.6.
8. Request EUT's Tx power to be at 0 dBm for at least 60 seconds, followed by requesting EUT's Tx power to be at maximum power for about ~80 seconds, and then switch to second technology/band (having 100s time window) selected in Section 3.2.6. Continue with callbox requesting EUT's Tx power to transmit at maximum power for about 100s in this second technology/band, and then switch back to the first technology/band. Continue with callbox requesting EUT to transmit at maximum Tx power for at least another 140s. Measure and record Tx power versus time for the entire duration of the test.
9. Repeat above Step 5~6 procedures to generate the corresponding plots

The validation criteria is, at all times, the time-averaged 1gSAR or 10gSAR versus time shall not exceed the regulatory 1g or 10gSAR_{limit} limit.

3.3.7 SAR exposure switching

This test is to demonstrate that Smart Transmit feature is accurately accounts for switching in exposures among SAR from radio1 only, SAR from both radio1 and radio2, and SAR from radio2 only scenarios, and ensures total time-averaged RF exposure complies with the FCC limit. The detailed test procedure for SAR exposure switching in the case of LTE + Sub6 NR non-standalone mode transmission scenarios is provided in Section.B.

Test procedure:

1. Measure conducted Tx power corresponding to P_{limit} for radio 1 and radio 2 in selected band. Test condition to measure conducted P_{limit} is:
 - Establish device in call with the callbox for radio1 technology/band. Measure conducted Tx power corresponding to radio 1 P_{limit} with Smart Transmit enable and *Reserve_Power_margin* set to 0 dB(Peak exposure mode), callbox set to request maximum power.
 - Repeat above step to measure conducted Tx power corresponding to radio2 P_{limit} . If radio2 is dependent on radio1 (for example, non-standalone mode of Sub6 NR requiring radio1 LTE as anchor), then establish radio1 + radio2 call with callbox, and request all down bits for radio1 LTE. In this scenario, with callbox requesting maximum power from radio2 Sub6 NR, measured conducted Tx power corresponds to radio2 P_{limit} (as radio1 LTE is at all-down bits)
2. Set *Reserve_power_margin* to actual (intended) value, with EUT setup for radio1 + radio2 call. In this description, it is assumed that radio2 has lower priority than radio1. Establish device in radio1 + radio2 call, and request all-down bits or low power on radio1, with callbox requesting EUT's Tx power to be at maximum power in radio2 for at least one time window. After one time window, set callbox to request EUT's Tx power to be at maximum power on radio1, i.e., all-up bits. Continue radio1 + radio2 call with both radios at maximum power for at least one time window, and drop (or request all-down bits on) radio2. Continue radio1 at maximum power for at least one time window. Record the conducted Tx power for both radio1 and radio2 for the entire duration of this test.
3. Once the measurement is done, extract instantaneous Tx power versus time for both radio1 and radio2 links. Convert the conducted Tx power for both these radios into 1gSAR or 10gSAR value (see Eq.(6a) and (6b)) using corresponding technology/band P_{limit} measured in Step 1, and then perform the running time average to determine time-averaged 1gSAR or 10gSAR versus time.
4. Make one plot containing: (a) computed time-averaged 1g or 10gSAR versus time determined in Step 3, and combined time-averaged 1g or 10gSAR versus time, and (b) corresponding regulatory 1g or 10gSAR_{limit} limit.

The validation criteria is, at all times, the time-averaged 1gSAR or 10gSAR versus time shall not exceed the regulatory 1g or 10gSAR_{limit} limit.

Note: If multi_Tx_factor is set to > 1.0 with EFS version 19 (or higher), then in single Tx transmission scenarios, Smart Transmit ensures time-averaged RF exposure is $\leq (SAR_design_target * 10^{(+sub6\ device\ uncertainty / 10)}) < regulatory\ RF\ exposure\ limit\ for\ sub6\ radio\ managed\ by\ Smart\ Transmit.$

In simultaneous Tx transmission scenarios, Smart Transmit ensures time-averaged RF exposure is $\leq (SAR_design_target * multi_Tx_factor * 10^{(+sub6\ device\ uncertainty / 10)}) < regulatory\ RF\ exposure\ limit\ for\ sub6\ radios\ managed\ by\ Smart\ Transmit.$ These simultaneous transmission scenarios are listed below:

- 2-or-more radio scenarios within WWAN like EN-DC, LTE ULCA, etc.
- 2-or-more-radio across technologies such as WWAN+WLAN, WWAN+BT, WLAN+BT and WWAN+WLAN+BT transmission scenarios (if WLAN/BT radios are also managed by Smart Transmit).

This device's multi_Tx_factor is 1.0.

3.3.8 System level compliance continuity

3.3.8.1 WWAN/WLAN/BT radio system level compliance continuity

Below is the test flow outline of the system level compliance test. The test contains 6 sections and 5 transitions: Start with WWAN radio transmission (Section A), transition to WLAN transmission (Section B), transition to simultaneous transmission of WWAN + WLAN + BT (Section C), then drop off WWAN radio and set WWAN to airplane mode, at the same time transition to WLAN + BT transmission simultaneously (Section D), transition to BT only transmission (Section E), and finally transition to WLAN only transmission (Section F).



Figure S-1 Schematic of technology transitions for system level compliance continuity test.

It is recommended for OEMs to demonstrate compliance at system level, i.e., demonstrate compliance continuity across technologies, i.e., across WWAN, WLAN, BT, etc. In this regard, a new test case is designed to test the time-averaged RF exposure compliance continuity in the following scenarios with 5 transitions:

1. Across technology switch
2. During transition from single technology to multiple technology
3. In transition when WWAN went from ON to airplane mode
4. Active WLAN radio and/or BT radio without WWAN
5. Time window transition between WLAN and BT when WWAN is in airplane mode (this segment of test is not needed for ICNIRP as both WLAN and BT operate in same time averaging window)

Test configuration selection criteria:

If the device supports simultaneous transmission of WWAN, WLAN and BT, then the selection criteria for system level compliance continuity test is:

- For a given DSI and antenna group, select band/antenna configurations for WWAN, WLAN and BT technologies that have the largest ($P_{max} - P_{limit}$) delta. In case of multiple bands/antennas having the same difference between P_{max} and P_{limit} within a given technology, then select any one band/antenna out of them.

Note: The antennas corresponding to the selected technologies/bands for the system level compliance continuity test case should be in the same antenna group.

For this test, WLAN radio configuration is selected different from 2.4GHz band so as to not interfere with BT measurements. Therefore, select least P_{limit} configuration for WLAN outside the 2.4GHz band.

Test procedure:

1. Measure conducted Tx power corresponding to P_{limit} for all three (WWAN, WLAN & BT) technologies in the selected radio configurations. Test condition to measure conducted P_{limit} for each tech is :
 - Establish device in call with the callbox for the first technology in desired band. Measure conducted Tx power corresponding to the first technology P_{limit} with Smart Transmit Peak exposure mode enabled and callbox set to request maximum power (or maximum duty cycle in case of WLAN/BT).
 - Repeat above step to measure conducted Tx power corresponding to the remaining two technologies' P_{limit} . In the case of BT, measured conducted Tx power is compensated by tested duty cycle and $BT_STANDALONE$ EFS parameter, i.e., measured $P_{limit} = \text{conducted power measured in BT standalone condition} / BT_STANDALONE / BT_duty_cycle$.
2. Set EUT to the intended Smart Transmit exposure mode.
3. As depicted in Figure S-1, first
 - i. Section A: Establish WWAN connection with the callbox in selected WWAN radio configuration. Request EUT to transmit at 0 dBm for at least one WWAN time window (100s or 60s), followed by requesting EUT to transmit at maximum Tx power for {one WWAN time window ($T_{WWAN} = 100\text{s}$ if $f < 3\text{GHz}$ or 60s if $3\text{GHz} < f < 6\text{GHz}$ for FCC, 360s for ICNIRP) + the maximum high power duration allowed in one T_{WWAN} }, denoted as T_{A_WWAN} .
 - ii. Section B: After T_{A_WWAN} , drop WWAN connection and establish WLAN connection with the callbox in selected WLAN radio configuration and request EUT to transmit at maximum duty cycle (and maximum power) for {one WLAN time-window duration ($T_{WLAN} = 30\text{s}$ for all WLAN frequency bands for FCC, 360s for ICNIRP) + the maximum high power duration allowed in one T_{WLAN} }, denoted T_{B_WLAN} .
 - iii. Section C: After T_{B_WLAN} , add the selected WWAN and BT radios to have the simultaneous transmission of WWAN + WLAN + BT. Request WWAN radio to transmit at maximum power and request WLAN & BT radios to transmit at maximum duty cycle (and maximum power) for at least one $\max \{T_{A_WWAN}, T_{B_WLAN}, T_{BT}\}$, where, $T_{BT} = 100\text{s}$ for FCC, 360s for ICNIRP.
 - iv. Section D: Drop WWAN connection and set WWAN modem into airplane mode. Continue requesting WLAN & BT radios to transmit at maximum duty cycle (and maximum power) for at least two times the $\max \{T_{WLAN}, T_{BT}\}$.
 - v. Section E: Drop WLAN connection. Continue requesting BT radio to transmit at maximum duty cycle (and maximum power). Continue the test for at least one T_{BT} .
 - vi. Section F: In the case of FCC time windows, after at least one T_{BT} , drop BT connection and establish back WLAN connection in selected radio configuration. Continue requesting WLAN radio to transmit at maximum duty cycle (and maximum power). Continue the test for at least one $\max \{T_{WLAN}, T_{BT}\}$. In the case of ICNIRP time windows, Section F is not required.
4. Once the measurement is done, extract instantaneous Tx power versus time for all WWAN, WLAN and BT radios in selected configurations. Similar to technology/band switch test in Section 3.3.3, convert the conducted Tx power for both these radios into $1\text{g_or_}10\text{gSAR}$ value (see Eq. (7a) and (7b)) using corresponding technology/band P_{limit} measured in Step 1, and then perform running average over corresponding time-windows (i.e., 100s/60s for WWAN radio, 30s for WLAN radio and 100s for BT radio in case of FCC time-windows, and 360s for all of them in case of ICNIRP time-windows) to determine time-averaged $1\text{g_or_}10\text{gSAR}$ versus time as illustrated in Figure A-1.

5. Make one plot containing: (a) computed normalized time-averaged 1g_or_10gSAR for WWAN radio configuration versus time determined in Step 4, (b) computed normalized time-averaged 1g_or_10gSAR for WLAN radio configuration versus time determined in Step 4, (c) computed normalized time-averaged 1g_or_10gSAR for BT radio configuration versus time determined in Step 4, (d) computed total normalized time-averaged 1g_or_10gSAR versus time (sum of Steps (5.a), (5.b)) determined in Step 5, and (e) corresponding normalized regulatory 1g_or_10gSAR_{limit} limit of 1.0.

The validation criteria is, at all times, the time-averaged 1g_or_10gSAR versus time shall not exceed the regulatory 1g_or_10gSAR_{limit} limit.

Note: If multi_Tx_factor is set to > 1.0 with EFS version 19 (or higher), then in single Tx transmission scenarios, Smart Transmit ensures time-averaged RF exposure is $\leq (SAR_design_target * 10^{(+sub6\ device\ uncertainty / 10)}) < regulatory\ RF\ exposure\ limit$ for sub6 radio managed by Smart Transmit.

In simultaneous Tx transmission scenarios, Smart Transmit ensures time-averaged RF exposure is $\leq (SAR_design_target * multi_Tx_factor * 10^{(+sub6\ device\ uncertainty / 10)}) < regulatory\ RF\ exposure\ limit$ for sub6 radios managed by Smart Transmit. These simultaneous transmission scenarios are listed below:

- 2-or-more radio scenarios within WWAN like EN-DC, LTE ULCA, etc.
- 2-or-more-radio across technologies such as WWAN+WLAN, WWAN+BT, WLAN+BT and WWAN+WLAN+BT transmission scenarios (if WLAN/BT radios are also managed by Smart Transmit).

This device's multi_Tx_factor is 1.0.

4. PD Time Averaging Validation Test Procedures

This chapter provides the test plan and test procedures for validating Qualcomm Smart Transmit feature for mmW transmission, For this EUT, millimeter wave (mmW) transmission is only in non-standalone mode, i.e., it requires an LTE link as anchor.

4.1. Test sequence for validation in mmW NR transmission

In 5G mmW NR transmission, the test sequence for validation is with the callbox requesting EUT's Tx power in 5G mmW NR at maximum power all the time.

4.2. Test configuration selection criteria for validating Smart Transmit feature

4.2.1 Test configuration selection for time-varying Tx power transmission

The Smart Transmit time averaging feature operation is independent of bands, modes, channels, and antenna configurations (beams) for a given technology. Hence, validation of Smart Transmit in any one band/mode/channel per technology is sufficient.

4.2.2 Test configuration selection for change in antenna configuration (beam)

The Smart Transmit time averaging feature operation is independent of bands, modes, channels, and antenna configurations (beams) for a given technology. Hence, validation of Smart Transmit with beam switch between any two beams is sufficient.

4.2.3 Test configuration selection for SAR vs. PD exposure switch during transmission

The Smart Transmit time averaging feature operation is independent of the nature of exposure (SAR vs. PD) and ensures total time-average RF exposure compliance. Hence, validation of Smart Transmit in any one band/mode/channel/beam for mmW + sub-6 (LTE) transmission is sufficient, where the exposure varies among SAR dominant scenario, SAR + PD scenario, and PD dominant scenario.+

4.2.4 Test configuration selection for switch between sub6 and mmW favor modes

The purpose of the test is to demonstrate that Smart Transmit ensures time-averaged RF exposure compliance when the device is switching between sub6 favor mode, i.e., sub6 radio1 in AG0 + sub6 radio2 in AG1 and mmW favor mode, i.e., sub6 radio 1 in AG0 (or sub6 radio2 in AG1) + mmW radio. Note sub6 radio1 and sub6 radio2 are in different antenna groups.

The validation criteria is that the total normalized time-averaged exposure versus time meets at all times:

1. Normalized time-averaged exposure of sub6 radio1 in AG0 + normalized time averaged exposure of mmW radio ≤ 1.0
2. Normalized time-averaged exposure of sub6 radio2 in AG1 + normalized time averaged exposure of mmW radio ≤ 1.0

This test procedure is very similar to the SAR and PD exposure switching tests described in Section 3.3.7 and 4.3.2 with the EUT's RF exposure switching between radios.

4.3. Test procedures for mmW radiated power measurements

Perform conducted power measurement (for $f < 6\text{GHz}$) and radiated power measurement (for $f > 6\text{GHz}$) for LTE + mmW transmission to validate Smart Transmit time averaging feature in the various transmission scenarios described in Section 2.

This section provides general conducted power measurement procedures to perform compliance test under dynamic transmission scenarios described in Section 2. In practice, an adjustment can be made in these procedures. The justification/clarification may be provided.

4.3.1 Time-varying Tx power scenario

The purpose of the test is to demonstrate the effectiveness of power limiting enforcement and that the time-averaged Tx power when converted into RF exposure values does not exceed the FCC limit at all times (see Eq. (2a), (2b) & (2c) in Section 2).

Test procedure:

1. Measure conducted Tx power corresponding to P_{limit} for LTE in selected band, and measure radiated Tx power corresponding to *input.power.limit* in desired mmW band/channel/beam by following below steps:
 - a. Measure radiated power corresponding to mmW *input.power.limit* by setting up the EUT's Tx power in desired band/channel/beam at *input.power.limit* in Factory Test Mode (FTM). This test is performed in calibrated anechoic chamber. Rotate the EUT to obtain maximum radiated Tx power, keep the EUT in this position and do not disturb the position of the EUT inside the anechoic chamber for the rest of this test.
 - b. Reset EUT to place in online mode and establish radio link in LTE, measure conducted Tx power corresponding to LTE P_{limit} with Smart Transmit enabled and *Reserve_power_margin* set to 0 dB, callbox set to request maximum power.
2. Set *Reserve_power_margin* to actual (intended) value and reset power on EUT to enable Smart Transmit. With EUT setup for a mmW NR call in the desire/selected LTE band and mmW NR band, perform the following steps:
 - a. Establish LTE and mmW NR connection in desired band/channel/beam used in Step 1. As soon as the mmW connection is established, immediately request all-down bits on LTE link. With callbox requesting EUT's Tx power to be at maximum mmW power to test predominantly PD exposure scenario (as SAR exposure is less when LTE's Tx power is at low power).
 - b. After 120s, request LTE to go all-upbits for at least 100s. SAR exposure is dominant. There are two scenarios:
 - i. If $P_{limit} < P_{max}$ for LTE, then the RF exposure margin (provided to mmW NR) gradually runs out (due to high SAR exposure). This results in gradual reduction in the 5G mmW NR transmission power and eventually seized 5G mmW NR transmission when LTE goes to $P_{reserve}$ level.
 - ii. If $P_{limit} \geq P_{max}$ for LTE, then the 5G mmW NR transmission's averaged power should gradually reduce but the mmW NR connection can sustain all the time (assuming TxAGC uncertainty = 0 dB).
 - c. Record the conducted Tx power of LTE and radiated Tx power of mmW for the full duration of this test of least 300s.
3. Once the measurement is done, extract instantaneous Tx power versus time for both LTE and mmW links. Convert the conducted Tx power for LTE into 1gSAR or 10gSAR value using Eq.(2a)

and P_{limit} measured in Step 1.b, and then divide by FCC limit of 1.6W/kg for 1gSAR or 4.0W/kg for 10gSAR to obtain instantaneous normalized 1gSAR or 10gSAR versus time. Perform 100s running average to determine normalized 100s-averaged 1gSAR or 10gSAR versus time.

Note: In Eq.(2a), instantaneous Tx power is converted into instantaneous 1gSAR or 10gSAR Value by applying the measured worst-case 1gSAR or 10gSAR value at P_{limit} for the corresponding technology/band/antenna/DSI reported in Part 1 report.

4. Similarly, convert the radiated Tx power for mmW into $4\text{cm}^2\text{PD}$ value using Eq.(2b) and the radiated Tx power limit (i.e., radiated Tx power at *input.power.limit*) measured in Step 1.a, then divide by FCC $4\text{cm}^2\text{PD}$ limit of $10\text{W}/\text{m}^2$ to obtain instantaneous normalized $4\text{cm}^2\text{PD}$ versus time. Perform 4s running average to determine normalized 4s-averaged $4\text{cm}^2\text{PD}$ versus time.
Note: In Eq.(2b), instantaneous radiated Tx power is converted into instantaneous $4\text{cm}^2\text{PD}$ by applying the worst-case $4\text{cm}^2\text{PD}$ value measured at *input.power.limit* for the selected band/beam in Part 1 report.
5. Make one plot containing: (a) computed normalized 100s-averaged 1gSAR or 10gSAR versus time determined in Step 3, (b) computed normalized 4s-averaged $4\text{cm}^2\text{PD}$ versus time determined in Step 4, and (c) corresponding total normalized time-averaged RF exposure (sum of steps (6.a) and (6.b)) versus time.

The validation criteria are, at all times, the total normalized time-averaged RF exposure versus time determined in Step 6.c shall not exceed the normalized limit of 1.0 of FCC requirement (i.e., Eq. (2c)).

4.3.2 Switch in SAR vs. PD exposure during transmission

This test is to demonstrate that Smart Transmit feature is independent of the nature of exposure (SAR vs. PD), accurately accounts for switching in exposures among SAR dominant, SAR + PD, and PD dominant scenarios, and ensures total time-averaged RF exposure compliance.

Test procedure:

1. Measure conducted Tx power corresponding to P_{limit} for LTE in selected band, and measure radiated Tx power corresponding to *input.power.limit* in desired mmW band/channel/beam by following below steps:
 - a. Measure radiated power corresponding to *input.power.limit* by setting up the EUT's Tx power in desired band/channel/beam at *input.power.limit* in FTM. This test is performed in a calibrated anechoic chamber. Rotate the EUT to obtain maximum radiate Tx power, keep the EUT in this position and do not disturb the position of the EUT inside the anechoic chamber for the rest of this test.
 - b. Reset EUT to place in online mode and establish radio link in LTE, measure conducted Tx power corresponding to LTE P_{limit} with Smart Transmit enabled and *Reserve_power_margin* set to 0 dB, callbox set to request maximum power.
2. Set *Reserver_power_margin* to actual (intended) value and reset power in EUT, with EUT setup for LTE + mmW call, perform the following steps:
 - a. Establish LTE (sub-6) and mmW NR connection with callbox.
 - b. As soon as the mmW connection is established, immediately request all-down bits on LTE link. Continue LTE (all-down bits) + mmW transmission for more than 100s duration to test predominantly PD exposure scenario (as SAR exposure is negligible from all-down bits in LTE).
 - c. After 120s, request LTE to go all-up bits, mmW transmission should gradually run out of RF exposure margin if LTE's $P_{limit} < P_{max}$ and seize mmW transmission (SAR only scenario); or mmW transmission should gradually reduce in Tx power and will sustain the connection if LTE's $P_{limit} > P_{max}$.

- d. After 75s, request LTE to go all-down bits, mmW transmission should start getting back RF exposure margin and resume transmission again.
 - e. Record the conducted Tx power of LTE and radiated Tx power of mmW for the entire duration of this test of at least 300s.
3. Once the measurement is done, extract instantaneous Tx power versus time for both LTE and mmW links. Convert the conducted Tx power for LTE into 1gSAR or 10gSAR value using Eq.(2a) and P_{limit} measured in Step 1.b, and then divide by FCC limit of 1.6 W/kg for 1gSAR or 4.0 W/kg for 10gSAR to obtain instantaneous normalized 1gSAR or 10gSAR versus time. Perform 100s running average to determine normalized 100s-averaged 1gSAR or 10gSAR versus time. Note: In Eq.(2a), instantaneous Tx power is converted into instantaneous 1gSAR or 10gSAR value by applying the measured worst-case 1gSAR or 10gSAR value at P_{limit} for the corresponding technology/band/antenna/DSI reported in Part 1 report.
 4. Similarly, convert the radiated Tx power for mmW into 4cm²PD value using Eq.(2b) and the radiated Tx power limit (i.e., radiated Tx power at *input.power.limit*) measured in Step 1.a, then divide this by FCC 4cm²PD limit of 10W/m² to obtain instantaneous normalized 4cm²PD versus time. Perform 4s running average to determine normalized 4s-averaged 4cm²PD versus time.
 5. Make another plot containing: (a) computed normalized 100s-averaged 1gSAR or 10gSAR versus time determined in Step 3, (b) computed normalized 4s-averaged 4cm²PD versus time determined in Step 4, and (C) corresponding total normalized time-averaged RF exposure (sum of steps (6.a) and (6.b)) versus time.

The validation criteria are, at all times, the total normalized time-averaged RF exposure versus time determined in Step 6.c shall not exceed the normalized limit of 1.0 of FCC requirement (i.e., Eq. (2c)).

4.3.3 Change in antenna configuration (beam)

This test is to demonstrate the correct power control by Smart Transmit during changes in antenna configuration (beam). Since the *input.power.limit* varies with beam, the Eq. (2a), (2b) and (2c) in Section 2 are written as below for transmission scenario having change in beam:

$$1g_or_10gSAR(t) = \frac{conducted_Tx_power(t)}{conducted_Tx_power_P_{limit}} * 1g_or_10gSAR_P_{limit} \quad (8a)$$

$$4cm^2PD_1(t) = \frac{radiated_Tx_power_1(t)}{radiated_Tx_power_input.power.limit_1} * 4cm^2PD_input.power.limit_1 \quad (8b)$$

$$4cm^2PD_2(t) = \frac{radiated_Tx_power_2(t)}{radiated_Tx_power_input.power.limit_2} * 4cm^2PD_input.power.limit_2 \quad (8c)$$

$$\frac{\frac{1}{T_{SAR}} \int_{t-T_{SAR}}^t 1g_or_10gSAR(t) dt}{FCC\ SAR\ limit} + \frac{\frac{1}{T_{PD}} \left[\int_{t-T_{PD}}^{t_1} 4cm^2PD_1(t) dt + \int_{t_1}^t 4cm^2PD_2(t) dt \right]}{FCC\ 4cm^2\ PD\ limit} \leq 1 \quad (8d)$$

Where, *conducted_Tx_power(t)*, *conducted_Tx_power_P_{limit}*, and *1g_or_10gSAR_P_{limit}* correspond to the measured instantaneous conducted Tx power, measured conducted Tx power at P_{limit} , and measured 1gSAR or 10gSAR values at P_{limit} corresponding to LTE transmission. Similarly, *radiated_Tx_power_1(t)*, *radiated_Tx_power_input.power.limit_1*, and *4cm²PD_input.power.limit_1* correspond to the measured instantaneous radiated Tx power, radiated Tx power at *input.power.limit*, and 4cm²PD value at *input.power.limit* of beam 1; *radiated_Tx_power_2(t)*, *radiated_Tx_power_input.power.limit_2*, and *4cm²PD_input.power.limit_2* correspond to the measured instantaneous radiated Tx power, radiated Tx power at *input.power.limit*, and 4cm²PD value at *input.power.limit* of beam 2 corresponding to mmW transmission.

Test procedure:

1. Measure conducted Tx power corresponding to P_{limit} for LTE in selected band, and measure radiated Tx power corresponding to *input.power.limit* in desired mmW band/channel/beam by following below steps:
 - a. Measure radiated power corresponding to mmW *input.power.limit* by setting up the EUT's Tx power of the EUT inside the anechoic chamber for the rest of this test. Repeat this Step 1.a for beam 2.
 - b. Reset EUT to place in online mode and establish radio link in LTE, measure conducted Tx power corresponding to LTE P_{limit} with Smart Transmit enable and *Reserve_power_margin* set to 0 dB, callbox set to request maximum power.
2. Set *Reserve_power_margin* to actual (intended) value and reset power in EUT, With EUT setup for LTE + mmW connection, perform the following steps:
 - a. Establish LTE (sub-6) and mmW NR connection in beam 1. As soon as the mmW connection is established, immediately request all-down bits on LTE link with the callbox requesting EUT's Tx power to be at maximum mmW power.
 - b. After beam 1 continues transmission for at least 20s, request the EUT to change from beam 1 to beam 2, and continue transmitting with beam 2 for at least 20s.
 - c. Record the conducted Tx power of LTE and radiated Tx power of mmW for the entire duration of this test.
3. Once the measurement is done, extract instantaneous Tx power versus time for both LTE and mmW links. Convert the conducted Tx power for LTE into 1gSAR or 10gSAR value using the similar approach described in Step 3 of Section 4.3.2. Perform 100s running average to determine normalized 100s-averaged 1gSAR or 10gSAR versus time.
4. Similarly, convert the radiated Tx power for mmW NR into 4cm²PD value using Eq.(8b), (8c) and the radiated Tx power limits (i.e., radiated Tx power at *input.power.limit*) measured in Step 1.a for beam 1 and beam 2, respectively, and then divide the resulted PD values by FCC 4cm²PD limit of 10W/m² to obtain instantaneous normalized 4cm²PD versus time for beam 1 and beam 2. Perform 4s running average to determine normalized 4s-averaged 4cm²PD versus time.
 Note: In Eq.(8b) and (8c), instantaneous radiated Tx power of beam 1 and beam 2 is converted into instantaneous 4cm²PD by applying the worst-case 4cm²PD value measured at the *input.power.limit* of beam 1 and beam 2 in Part 1 report, respectively.
5. Since the measured radiated powers for beam 1 and beam 2 in Step 1.a were performed at an arbitrary rotation of EUT in anechoic chamber, repeat Step 1.a of this procedure by rotating the EUT to determine maximum radiated power at *input.power.limit* in FTM mode for both beams separately. Re-scale the measured instantaneous radiated power in Step 2.c by the delta in radiated power measured in Step 5 and the radiated power measured in Step 1.a for plotting purpose in next Step. In other words, this step essentially converts measured instantaneous radiated power during the measurement in Step 2 into maximum instantaneous radiated power for both beams. Perform 4s running average to compute 4s-averaged radiated Tx power. Additionally, use these EIRP values measured at *input.power.limit* at respective peak locations to determine the EIRP limits (using Eq. (5b)) for both these beams.
6. Make another plot containing: (a) computed normalized 100s-averaged 1gSAR or 10gSAR versus time determined in Step 3, (b) computed normalized 4s-averaged 4cm²PD versus time determined in Step 4, and (c) corresponding total normalized time-averaged RF exposure (sum of steps (6.a) and (6.b)) versus time.

The validation criteria are, at all times, the total normalized time-averaged RF exposure versus time determined in Step 6.c shall not exceed the normalized limit of 1.0 of FCC requirement (i.e., (8d)).

4.4. Test procedures for switch between sub6 and mmW favor modes with Smart Transmit

The purpose of the test is to demonstrate that Smart Transmit ensures time-averaged RF exposure compliance when the device is switching between sub6 favor mode, i.e., sub6 radio1 in AG0 + sub6 radio2 in AG1 and mmW favor mode, i.e., sub6 radio 1 in AG0 (or sub6 radio2 in AG1) + mmW radio. Note sub6 radio1 and sub6 radio2 are in different antenna groups.

Test procedure:

1. Select any LTE band/antenna and sub6 NR band/antenna combination such that LTE and FR1 transmitting antennas are in two different sub6 antenna groups. Measure conducted Tx power corresponding to Plimit for LTE and sub6 NR in selected band/antenna, and measure radiated Tx power corresponding to input.power.limit in desired mmW band/channel/beam. Test condition to measure conducted Plimit and radiated input.power.limit is:
 - a. Measure conducted Tx power corresponding to Plimit for LTE in selected band/antenna with Smart Transmit Peak exposure mode enabled. Establish device in call with the callbox for LTE in selected band/antenna and callbox set to request maximum power.
 - b. Repeat above step to measure conducted Tx power corresponding to sub6 NR Plimit in selected band/antenna with Smart Transmit Peak exposure mode enabled. Establish LTE + sub6 NR call with callbox, request all down bits for LTE, and callbox set to request maximum power from sub6 NR, measured conducted Tx power corresponds to sub6 NR Plimit (as LTE is at all-down bits)
 - c. Measure radiated.power corresponding to mmW input.power.limit by setting up the UE to transmit in desired band/channel/beam at input.power.limit in Factory Test Mode. Do not disturb the position of the EUT inside the anechoic chamber for the rest of this test.
2. Set EUT to the intended Smart Transmit exposure mode. Establish below radio links with callbox at desired transmission powers and time durations in the following order:
 - a. Establish LTE radio link with callbox in selected LTE band/antenna. Request EUT to transmit at 0 dBm for at least 100 seconds, followed by requesting EUT to transmit at LTE Plimit -4dB for a time duration of 120 seconds. Measure and record conducted LTE Tx power versus time.
 - b. Add mmW NR link in selected mmW NR band/beam. Request EUT to transmit at maximum Tx power in mmW NR for a time duration of 30 seconds, while LTE is requested to transmit at LTE Plimit-4dB. Measure and record radiated power of mmW NR versus time while continuing to measure conducted LTE Tx power versus time.
 - c. Handover (or drop link & immediately re-establish) from LTE + mmW NR to LTE + sub6 NR in selected sub6 NR band/antenna. Request EUT to transmit at maximum Tx power in sub6 NR for a time duration of 120 seconds, while LTE is requested to transmit at LTE Plimit – 4dB. Measure and record conducted power of sub6 NR versus time while continuing to measure conducted LTE Tx power versus time.
 - d. Handover (or drop link & immediately re-establish) from LTE + sub6 NR to LTE + mmW NR in selected mmW NR band/beam. Request EUT to transmit at maximum Tx power in mmW NR for a time duration of 120 seconds, while LTE is requested to transmit at LTE Plimit -4dBm. Measure and record radiated power of mmW NR versus time while continuing to measure conducted LTE Tx power versus time.

3. Once the measurement is done, extract instantaneous Tx power versus time for LTE, sub6 NR and mmW NR links. Convert the conducted Tx power for LTE into 1gSAR value using Step 1.b results, and then divide this by regulatory 1gSAR limit of 1.6W/kg to obtain instantaneous normalized 1gSAR versus time. Perform 100s running average to determine normalized 100s-averaged 1gSAR versus time. Note that in Eq.(4a), instantaneous Tx power is converted into instantaneous 1gSAR value by applying the worst-case 1gSAR value of the technology/band at Plimit as reported in RF exposure Part.1 (80-W2112-4).
4. Similarly, convert the conducted Tx power for sub6 NR into instantaneous 1gSAR value versus time using Step 1.c result, obtain instantaneous normalized 1g SAR versus time and determine normalized 100s-averaged 1gSAR versus time.
5. Similarly, convert the radiated Tx power for mmW into 4cm2PD value using Step 1.a result, and then divide this by regulatory 4cm2PD limit of 10W/m2 to obtain instantaneous normalized 4cm2PD versus time. Perform 4s running average to determine normalized 4s-averaged 4cm2PD versus time. Note that in Eq.(4b), instantaneous Tx power is converted into instantaneous 4cm2PD by applying the worst-case 4cm2PD value for the selected band/beam at input.power.limit as Part.1 report (80-W2112-4).
6. Since LTE+FR2 are in one antenna group, and FR1+FR2 are in one antenna group, check for total time-averaged RF exposure in below plots:
 - a. Make plot for LTE+FR2 containing: (a) computed normalized 100s-averaged 1gSAR versus time for LTE as determined in Step 3, (b) computed normalized 4s-averaged 4cm2PD versus time for mmW NR as determined in Step 5, and (c) corresponding total normalized time-averaged RF exposure (sum of steps (a) and (b)) versus time.
 - b. Make another plot for FR1+FR2 containing: (a) computed normalized 100s-averaged 1gSAR versus time for sub6 NR as determined in Step 4, (b) computed normalized 4s-averaged 4cm2PD versus time for mmW NR as determined in Step 5, and (c) corresponding total normalized time-averaged RF exposure (sum of steps (a) and (b)) versus time.

Note: If multi_Tx_factor is set to > 1.0 with EFS version 19 (or higher), then in single Tx transmission scenarios, Smart Transmit ensures time-averaged RF exposure is $\leq (SAR_design_target * 10^{(+sub6\ device\ uncertainty / 10)}) < regulatory\ RF\ exposure\ limit\ for\ sub6\ radio\ managed\ by\ Smart\ Transmit$.

In simultaneous Tx transmission scenarios, Smart Transmit ensures time-averaged RF exposure is $\leq (SAR_design_target * multi_Tx_factor * 10^{(+sub6\ device\ uncertainty / 10)}) < regulatory\ RF\ exposure\ limit\ for\ sub6\ radios\ managed\ by\ Smart\ Transmit$. These simultaneous transmission scenarios are listed below:

- 2-or-more radio scenarios within WWAN like EN-DC, LTE ULCA, etc.
- 2-or-more-radio across technologies such as WWAN+WLAN, WWAN+BT, WLAN+BT and WWAN+WLAN+BT transmission scenarios (if WLAN/BT radios are also managed by Smart Transmit).

In the case of sub6 + mmW radio, multi_Tx_factor is only applicable to sub6 radios, In other words, multu_Tx_factor is applicable to sub6 contribution.

This device's multi_Tx_factor is 1.0.

5. Test Configurations

5.1. WWAN (sub-6) & WLAN/BT transmission

This P_{limit} values, corresponding to 1.0 or 2.5 W/kg (1-g or 10-g respectively) of SAR_{design_target} , for technologies and bands supported by EUT are derived in Part 0 report and summarized in Table 5-1. Note all P_{limit} power levels entered in Table 5-1 correspond to average power levels plus tolerance after accounting for duty cycle in the case of TDD modulation schemes (for e.g., GSM, LTE TDD).

Table 5-1 : P_{limit} for supported technologies and bands (P_{limit} in EFS file)

Exposure condition			Folder Open UMPC Body 1-g	Folder Open UMPC Extremity 10-g	Folder Closed Body-worn & Hotspot	Folder Closed Product Specific 10-g	Folder Open Head	Folder Closed Head	Pmax (Maximum tune-up Power) (dBm)	
Spatial-average			1g	10g	1g	10g	1g	1g		
Test distance (mm)			10	0	10	0	0	0		
Configuration			Folder Open	Folder Open	Folder Closed	Folder Closed	Folder Open	Folder Closed		
DSI:			0		1		2		3	
RF Air Interface	Antenna	Antenna Group	P _{limit} corresponding to 1.0 W/kg (SAR _{design_target}) (1g) / 2.5 W/kg (SAR _{design_target}) (10g)							
GSM 850	A, A+B	AG0	28.37		31.40		33.72	33.72	25.48	
GSM 1900	B	AG0	18.49		18.49		34.95	34.95	22.24	
WCDMA 2	B	AG0	19.00		19.00		33.98	33.98	23.80	
WCDMA 4	B	AG0	19.00		19.00		34.01	34.01	23.80	
WCDMA 5	A, A+B	AG0	25.84		28.28		32.87	32.87	24.50	
LTE B7	B	AG0	17.00		17.00		35.01	35.01	24.00	
LTE B12	A, A+B	AG0	27.11		28.83		32.29	32.29	24.50	
LTE B13	A, A+B	AG0	26.35		27.87		31.43	31.43	24.50	
LTE B14	A, A+B	AG0	26.11		27.89		31.55	31.55	24.50	
LTE B25(2)	B	AG0	19.00		19.00		33.49	33.49	24.00	
LTE B26(5)	A, A+B	AG0	26.63		28.59		30.95	30.95	24.50	
LTE B30	B	AG0	17.50		17.50		37.24	37.24	23.00	
LTE B41 pc3 (38)	B	AG0	17.00		17.00		38.74	38.74	22.00	
LTE B41 pc2	B	AG0	17.00		17.00		51.41	51.41	21.90	
LTE B48	F	AG0	18.00		18.00		24.09	24.09	21.00	
LTE B66(4)	B	AG0	19.00		19.00		34.31	34.31	24.00	
LTE B71	A, A+B	AG0	27.49		29.08		32.97	32.97	24.50	
NR Bn7	B	AG0	18.00		18.00		34.76	34.76	23.00	
NR Bn12	A, A+B	AG0	28.08		28.75		33.78	33.78	24.50	
NR Bn25(2)	B	AG0	19.00		19.00		34.94	34.94	23.50	
NR Bn26(5)	A, A+B	AG0	26.84		28.18		33.16	33.16	24.50	
NR Bn30	B	AG0	17.50		17.50		37.35	37.35	22.50	
NR Bn66	B	AG0	19.00		19.00		34.43	34.43	23.50	
NR Bn71	A, A+B	AG0	27.45		29.16		33.22	33.22	24.50	
LTE B7 Upper	F	AG1	19.00		19.00		18.00	23.00	24.00	
LTE B25(2) Upper	F	AG1	20.00		20.00		22.50	22.50	24.00	
LTE B30 Upper	F	AG1	20.50		20.50		26.42	26.42	23.00	
LTE B66(4) Upper	F	AG1	20.00		20.00		22.50	22.50	24.00	
LTE B41 Upper pc3	F	AG1	19.00		19.00		25.85	25.85	22.00	
LTE B41 Upper pc2	F	AG1	19.00		19.00		25.59	25.59	21.90	
NR Bn7 Upper	F	AG1	19.00		19.00		18.00	25.95	23.00	
NR Bn25(2) Upper	F	AG1	20.00		20.00		22.50	22.50	23.00	
NR Bn30 Upper	F	AG1	20.50		20.50		25.22	25.22	22.50	
NR Bn66 Upper	F	AG1	20.00		20.00		22.50	22.50	23.00	
NR Bn38	F	AG1	19.00		19.00		20.00	20.00	24.00	
NR Bn41 pc2 (SA) - SRS0 -	B	AG0	17.00		17.00		20.00	20.00	25.00	
NR Bn41 pc3 (SA) - SRS0 -	B	AG0	17.00		17.00		20.00	20.00	24.00	
NR Bn41 pc2/3 (SA) - SRS1 -	F	AG1	19.00		19.00		20.00	20.00	22.00	
NR Bn41 pc2/3 (SA) - SRS2 -	C	AG0	12.00		12.00		12.00	12.00	21.50	
NR Bn41 pc2/3 (NSA) - SRS2 -	H	AG1	12.00		12.00		12.00	12.00	18.00	
NR Bn41 pc2/3 (SA) - SRS3 -	H	AG1	12.00		12.00		12.00	12.00	16.00	
NR Bn41 pc2/3 (NSA) - SRS3 -	C	AG0	12.00		12.00		12.00	12.00	19.00	
NR Bn41 pc2/3 (NSA) - SRS0 -	F	AG1	19.00		19.00		20.00	20.00	24.00	
NR Bn41 pc2/3 (NSA) - SRS1 -	B	AG0	17.00		17.00		20.00	20.00	22.00	
NR Bn48 - SRS0 -	F	AG1	18.00		18.00		19.00	19.00	23.00	
NR Bn48 - SRS1 -	D	AG0	15.00		15.00		15.00	15.00	19.00	
NR Bn48 - SRS2 -	G	AG1	15.00		15.00		15.00	15.00	23.00	
NR Bn48 - SRS3 -	A	AG0	15.00		15.00		15.00	15.00	20.00	
NR Bn77 pc2 - SRS0 -	F	AG1	17.50		17.50		17.00	18.00	26.00	
NR Bn77 pc3 - SRS0 -	F	AG1	17.50		17.50		17.00	18.00	23.00	
NR Bn77 pc2/3 - SRS1 -	D	AG0	15.00		15.00		15.00	15.00	17.00	
NR Bn77 pc2/3 - SRS2 -	G	AG1	15.00		15.00		15.00	15.00	22.00	
NR Bn77 pc2/3 - SRS3 -	A	AG0	15.00		15.00		15.00	15.00	17.00	
DTS SISO Ant2	G	AG1	21.11		22.93		17.00	17.00	18.00	
DTS MIMO	H+G	AG1	21.19		22.10		17.00	17.00	18.00	
UNII-2A MIMO	H+J	AG1	16.00		16.00		24.93	24.93	17.00	
UNII-2C MIMO	H+J	AG1	16.00		16.00		22.16	22.16	17.00	
UNII-3 MIMO	H+J	AG1	16.00		16.00		22.86	22.86	17.00	
UNII-4 MIMO	H+J	AG1	16.00		16.00		23.53	23.53	17.00	
WiFi 6e	H+J	AG1	22.49		15.76		24.49	24.49	9.00	
Bluetooth Ant.1	H	AG1	25.46		29.18		28.17	28.17	17.00	
Bluetooth Ant.2	G	AG1	21.98		25.54		24.05	24.05	15.00	

* Maximum Tune-up Target Power, P_{max} is configured in NV settings in DUT to limit maximum average transmitting power. The DUT maximum allowed output power is equal to $P_{max} + 1.0$ dB device uncertainty.

Based on selection criteria described in Section 3.2.1, the selected technologies/bands for testing time-varying test sequences are highlighted in Table 5-1. During Part 2 testing, the *Reserve_power_margin* (dB) is set in EFS according to the manufacturer guide.

As Part 1 and Part 2 testing took place in parallel the selected technologies/bands were chosen based upon anticipated values encountered during pretesting before Tx powers were finalized.

The radio configurations used in Part 2 test for selected technologies, bands, DSIs and antennas are listed in Table 5-2. The corresponding worst-case radio configuration 1g SAR or 10g SAR values for selected technology/band/Dsi are extracted from Part 1 report and are listed in the last column of Table 5-2.

Based on equations (1a), (2a), (3a) and (4a), it is clear that Part 2 testing outcome is normalized quantity, which implies that it can be applied to any radio configuration within a selected technology/band/Dsi. Thus, as long as applying the worst-case SAR obtained from the worst radio configuration in Part 1 testing to calculate time-varying SAR exposure in equations (1a), (2a), (3a) and (4a), the accuracy in compliance demonstrate remains the same.

If DSI's P_{limit} is higher than P_{max}, then P_{limit} is operate as P_{max} power.

Table 5-2 : WWAN Radio configurations selected for Part 2 test

Test Case	Test Scenario	Tech	Band	Antenna	DSI	Channel	Freq. (MHz)	RB/RB Offset/Bandwidth (MHz)	Mode	SAR Exposure Scenario	Worst configurations	Part 1 Worst Case Measured SAR at Plimit (W/kg)
1	Test Sequence 1	GSM	1900	B	0	661	1880.0	-	GPRS 4 Slots	Extremity 10g (UMPC)	Bottom - 0mm	1.260
	Test Sequence 2											
2	Test Sequence 1	WCDMA	2	B	0	9538	1907.6	-	Rel 99	Extremity 10g (UMPC)	Bottom - 0mm	2.260
	Test Sequence 2											
3	Test Sequence 1	LTE	B7	B	0	20850	2510.0	1/49/20 MHz	QPSK	Body 1g SAR (UMPC)	Bottom - 10mm	0.627
	Test Sequence 2											
4	Test Sequence 1	NR	Bn41 (PC3)	B	0	518598	2593.0	1/1/100 MHz	DFT-s-OFDM QPSK	Extremity 10g (UMPC)	Bottom - 0mm	1.250
	Test Sequence 2											
5	Change in Call	LTE	B7	B	0	20850	2510.0	1/49/20 MHz	QPSK	Body 1g SAR (UMPC)	Bottom - 10mm	0.627
6	DSI Switch	LTE	B66	F	0	132572	1770.0	1/99/20 MHz	QPSK	Extremity 10g (UMPC)	Top - 0mm	1.540
					3	132572	1770.0	1/99/20 MHz	QPSK	Head (Phablet)	Right Tilt	0.783
7	Tech/Band/Antenna Switch	LTE	B7	B	0	20850	2510.0	1/49/20 MHz	QPSK	Body 1g (UMPC)	Bottom - 10mm	0.627
		WCDMA	5	A	0	4183	836.5	-	Rel 99	Extremity 10g (UMPC)	Left - 0mm	1.360
8	Time Window Switch	LTE	B25	F	0	26590	1905.0	1/0/20 MHz	QPSK	Extremity 10g (UMPC)	Top - 0mm	1.770
		LTE	B48	F	0	56207	3646.7	1/99/20 MHz	QPSK	Extremity 10g (UMPC)	Top - 0mm	2.400
9	SAR1 vs SAR2 (EN-DC)	LTE	B12	A	0	23095	707.5	1/49/10 MHz	QPSK	Extremity 10g (UMPC)	Left - 0mm	1.170
		NR	Bn25	B	0	376500	1882.5	1/1/40 MHz	DFT-s-OFDM QPSK	Extremity 10g (UMPC)	Bottom - 0mm	1.610

Reported SAR values in Part 1 SAR report are tested at $P_{limit} + \text{tolerance}$. Therefore, 100s(or 60s) average SAR is shown to be ± 1.0 dB from SAR design target of WWAN bands.

Based on the selection criteria described in Section 3.2, the radio configurations for the Tx varying transmission test cases listed in Section 2 are:

- Technologies and bands for time-varying Tx power transmission: The test case 1 ~ 4 listed in Table 5-2 are selected to test with the test sequences defined in Section 3.1 in both time-varying conducted power measurement and time-varying SAR measurement.
- Technology and band for change in call test: LTE Band 7 having the lowest P_{limit} among all technologies and bands (test case 5 in Table 5-2) is selected for performing the call drop test in conducted power setup.
- Technologies and bands for change in technology/band/Antenna test: Following the guidelines in Section 3.2.3 and 3.2.4, test case 7 in Table 5-2 is selected for handover test from a technology/band/Antenna in Within one technology group (LTE Band 7, DSI=0, Ant.B), to a technology/band/Antenna in the same DSI within another technology group (WCDMA Band 5, DSI=0, Ant.A) in conducted power setup.
- Technologies and bands for change in time-window: Based on selection criteria in Section 3.2.6 for a given in DSI = 0 test case 8 in Table 5-2 is selected for time window switch between 100s window (LTE Band 25, DSI=0, Ant.F) and 60s window (LTE Band 48, DSI=0, Ant.F) in conducted power setup.
- Technologies and bands for change in DSI: Based on selection criteria in Section 3.2.5, for a given technology and band, test case 6 in Table 5-2 is selected for DSI switch test by establishing a call in LTE Band 66 in DSI=0, and then handing over to DSI =3 exposure scenario in conducted power setup.
- Technologies and bands for switch in SAR exposure (EN-DC): Based on selection criteria in Section 3.2.7 Scenario 1, test case 9 in Table 5-2 is selected for SAR exposure switching test in one of the supported simultaneous WWAN transmission scenario, i.e., LTE + Sub6 NR active in the same 100s time window, in conducted power setup.

Table 5-2 : WLAN/BT Radio configurations selected for Part 2 test

Test Case	Test Scenario	Tech	Band	Antenna	DSI	Channel	Freq. (MHz)	RB/RB Offset /Bandwidth (MHz)	Mode	SAR Exposure Scenario	Worst configurations	Part 1 Worst Case Measured SAR at P _{limit} (W/kg)
10	Time-varying	WLAN	2.4GHz SISO	G	3	6	2437	20MHz	802.11b mode	Head (Phablet)	Left Tilt	0.210
11		WLAN	5GHz MIMO	J	0	155	5775	80MHz	802.11ac mode	Body 1g SAR (UMPC)	Rear - 10mm	0.742
12	Change in Call	WLAN	5GHz MIMO	J	0	155	5775	80MHz	802.11ac mode	Body 1g SAR (UMPC)	Rear - 10mm	0.742
13	Change in Band/Antenna	WLAN	2.4GHz MIMO	G	0	6	2437	20MHz	802.11ac mode	Body 1g SAR (UMPC)	Left - 10mm	0.520
		WLAN	5GHz MIMO	J	0	149	5745	20MHz	802.11ac mode	Body 1g SAR (UMPC)	Rear - 10mm	0.742
14	Change in DSI	WLAN	5GHz MIMO	J	0	155	5775	80MHz	802.11ac mode	Body 1g SAR (UMPC)	Rear - 10mm	0.742
		WLAN	5GHz MIMO	J	3	155	5775	80MHz	802.11ac mode	Head (Phablet)	Right Touch	0.233
15	DBS SAR vs SAR	WLAN	2.4GHz MIMO	G	0	6	2437	20MHz	802.11ac mode	Body 1g SAR (UMPC)	Left - 10mm	0.520
		WLAN	5GHz MIMO (Hotspot)	J	0	149	5745	20MHz	802.11ac mode	Body 1g SAR (UMPC)	Rear - 10mm	0.742
16	System Level Compliance Continuity	WWAN	LTE B48	F	0	56207	3646.7	1/99/20 MHz	QPSK	Extremity 10g SAR (UMPC)	Top - 0mm	2.400
		WLAN	5GHz MIMO	J	0	155	5775	80MHz	802.11ac mode	Body 1g SAR (UMPC)	Rear - 10mm	0.742
		BT	Bluetooth	H	0	39	2441	-	EDR	Extremity 10g SAR (UMPC)	Left - 0mm	0.516

Reported SAR values in Part 1 SAR report are tested at $P_{limit} + \text{tolerance}$. Therefore, 30s average SAR is shown to be ± 1.0 dB from SAR design target of WLAN bands.

Based on the selection criteria described in Section 3.2, the radio configurations for the Tx varying transmission test cases listed in Section 2 are:

- Technologies and bands for time-varying Tx power transmission: The test case 10 ~ 11 listed in Table 5-2 are selected to test with the test sequences defined in Section 3.1 in both time-varying conducted power measurement and time-varying SAR measurement.
- Technology and band for change in call test: 5GHz MIMO(802.11ac_VHT80) having the lowest P_{limit} among all technologies and bands (test case 12 in Table 5-2) is selected for performing the call drop test in conducted power setup.
- Technologies and bands for change in Band/Antenna test: Following the guidelines in Section 3.2.3 and 3.2.4, test case 13 in Table 5-2 is selected for handover test from a Band/Antenna in Within one technology group (2.4GHz MIMO(802.11ac_VHT20), DSI=0, Ant.G), to a technology/band/Antenna in the same DSI within another technology group (5GHz MIMO(802.11ac_VHT20), DSI=0, Ant.J) in conducted power setup.
- Technologies and bands for change in time-window switch test between WWAN and WLAN: According to Qualcomm document (80-W2112-5), If System Level Compliance Continuity (test case 16) verified, "Change in time-window switch test between WWAN and WLAN test" is not required.
- Technologies and bands for change in DSI: Based on selection criteria in Section 3.2.5, for a given technology and band, test case 14 in Table 5-2 is selected for DSI switch test by establishing a call in 5GHz MIMO(802.11ac_VHT80) in DSI=0, and then handing over to DSI =3 exposure scenario in conducted power setup.
- Technologies and bands for switch in SAR exposure (DBS): Based on selection criteria in Section 3.2.7 Scenario 1, test case 15 in Table 5-2 is selected for SAR exposure switching test in one of the supported simultaneous WLAN transmission scenario, i.e., DBS(2.4GHz Radio+5GHz Radio) active in the same 30s time window, in conducted power setup.
- System Level Compliance Continuity test (WWAN+WLAN+BT): Based on selection criteria in Section 3.2.8, test case 16 in Table 5-2 is selected for System Level Compliance Continuity test in one of the supported simultaneous WLAN+WLAN+BT transmission scenario.

5.2. LTE+mmW NR transmission

Based on the selection criteria described in Section 4.2, the selections for LTE and mmW NR validation test are listed in Table 5-3. The radio configurations used in this test are listed in Table 5-4.

Table 5-3 : Selections for LTE + mmW NR validation measurements

Transmission Scenario	Test	Technology and Band	mmW Beam
Time-varying Tx power test	1. cond. & Rad. Power meas. 2. PD meas.	LTE Band 66 and n261	Beam ID 165
Switch in SAR vs. PD	1. cond. & Rad. Power meas.	LTE Band 66 and n261	Beam ID 165
Beam switch test	1. cond. & Rad. Power meas.	LTE Band 66 and n261	Beam ID 27 to Beam ID 2
Favor Mode Switch	1. cond. & Rad. Power meas.	LTE Band 66 and n25	-
		LTE Band 66 and n261	Beam ID 165

Table 5-4 : Test configuration for LTE + mmW NR validation

Tech	Band	Antenna	DSI	Channel	Bandwidth (MHz)	RB Size	RB Offset	Freq (MHz)	Mode	UL Duty Cycle
LTE	66	Ant.B	0	19100	20	1	99	1720.0	QPSK	100.0%
NR	n25	Ant.F	0	376500	40	1	108	1882.5	DFT-s-OFDM, QPSK	100.0%
mmW NR	n261	K-patch	-	2077915	100	66	0	27924.96	CP-OFDM, QPSK	84.3%

Note 1, mmW NR was tested using 84.3% UL duty cycle setting test script provided by Qualcomm.

6. Conducted Power Test Results for Sub-6 Smart Transmit Feature Validation

6.1. Measurement setup

WWAN Bands Measurement setup

GSM / WCDMA / LTE test setup using The Rohde & Schwarz CMW500 callbox

The Rohde & Schwarz CMW500 callbox is used in this test.

Test setup Schematic	Test item(s)	Description(s)	Test setup photo
Figure B-1(a)	Time-varying Tx power transmission test (Section 3.3.1)	Single antenna measurement, one port (RF1 COM) of callbox	A.1
	Change in Call test (Section 3.3.2)		
	Change in DSI test (Section 3.3.5)		
	Change in time-window (Section 3.3.6)		
Figure B-1(b)	Change in antenna (Section 3.3.4)	two antenna measurement, one port (RF1 COM) of callbox	A.2
	Change in technology and band test (Section 3.3.3)		

LTE + Sub6 NR(NSA mode) test setup using The UXM callbox

The UXM callbox is used in this test.

Test setup Schematic	Test item(s)	Description(s)	Test setup photo
Figure B-1(a)	Time-varying Tx power transmission test (Section 3.3.1)	Single antenna measurement, one port (RF1 COM) of callbox	A.3
Figure B-1(c)	SAR exposure switch test (EN-DC) (Section 3.3.7)	two different techs measurement, two ports (RF1 & RF8 COM) of callbox	A.4

All the path losses from RF port of DUT to the callbox RF COM port and to the power meter are calibrated and automatically entered as offsets in the callbox and the power meter via test scripts on the PC used to control callbox and power meter.

Setup photos of Test setup Schematic are list in Appendix A.

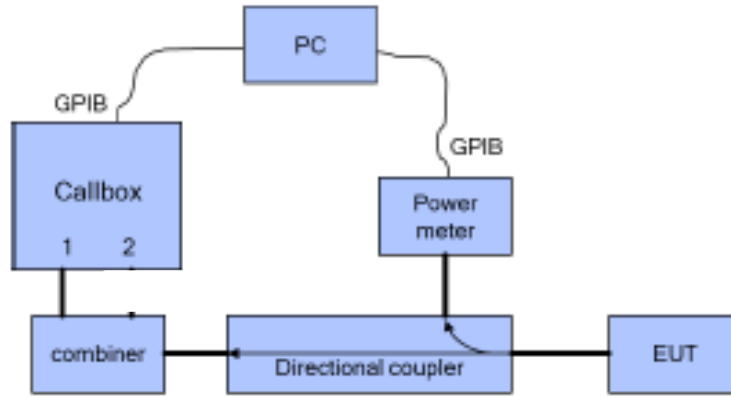


Figure B-1 (a)

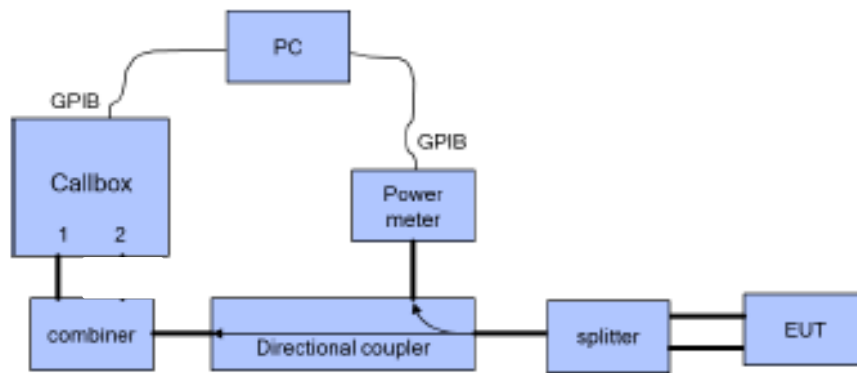


Figure B-1 (b)

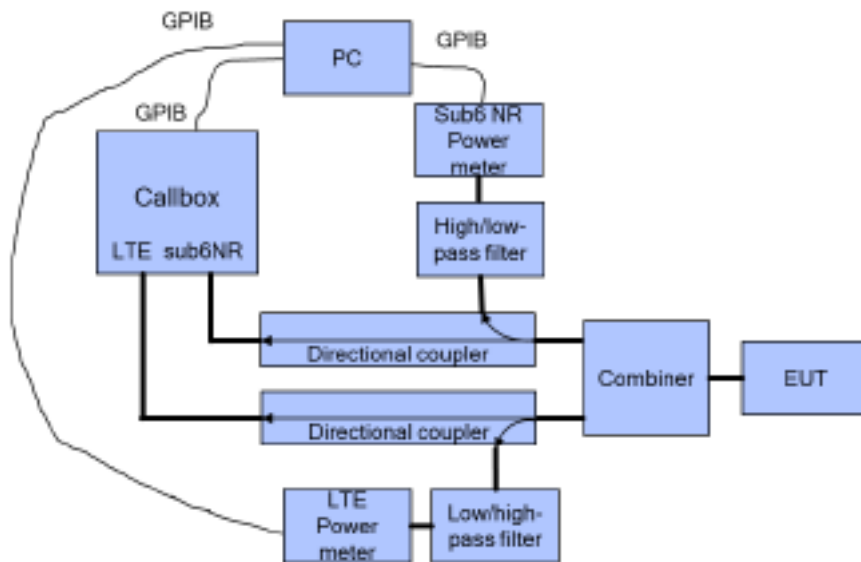


Figure B-1 (c)

Both the callbox and power meter are connected to the PC using GPIB cables. Two test scripts are custom made for automation, and the test duration set in the test scripts is 500 seconds.

For time-varying Tx power measurement, the PC runs the 1st test script to send GPIB commands to control the callbox's requested power versus time, while at the same time to record the conducted power measured at EUT RF port using the power meter. The commands sent to the callbox to request power are:

- 0 dBm for 100 seconds
- Test sequence 1 or test sequence 2 (defined in Section 3.1 and generated in Section 3.2.1), For 360 seconds
- Stay at the last power level of test sequence 1 or sequence 2 for the remaining time.

Power meter readings are periodically recorded every 100ms. A running average of this measured Tx power over 100 seconds is performed in the post-data processing to determine the 100s-time averaged power.

For call drop, technology/band/antenna switch, and DSI switch tests, after the call is established, the callbox is set to request the EUT's Tx power at 0dBm for 100 seconds while simultaneously starting the 2nd test script runs at the same time to start recording the Tx power measured at EUT RF port using the power meter. After the initial 100 seconds since starting the Tx power recording, the callbox is set to request maximum power from the EUT for the rest of the test. Note that the call drop/re-establish, or technology/band/antenna switch or DSI switch is manually performed when the Tx power of EUT is at $P_{reserve}$ level. See Section 3.3 for detailed test procedure of call drop test, technology/band/antenna switch test and DSI switch test.

WLAN Bands Measurement setup**WLAN test setup using The Rohde & Schwarz CMW500 callbox**

The Rohde & Schwarz CMW500 callbox is used in this test.

Test setup Schematic	Test item(s)	Description(s)	Test setup photo
Figure C-1(a)	Time-varying Tx power transmission test (Section 3.3.1)	Two antenna measurement, two port (RF1 & RF3)COM) of callbox	A.5
Figure C-1(b)	Time-varying Tx power transmission test (Section 3.3.1)	Three antenna measurement, three port (RF1 & RF3 & RF4 COM) of callbox	A.6
	Change in Call test (Section 3.3.2)		
	Change in DSI test (Section 3.3.5)		
Figure C-1(c)	Change in technology and band test (Section 3.3.3)	Four antenna measurement, three port (RF1 & RF3 & RF4 COM) of callbox	A.7
Figure C-1(d)	SAR exposure switch test (DSI) (Section 3.3.7)	Four antenna measurement, one port (RF1 COM) of call box1 and four port (RF1 & RF2 & RF3 & RF4 COM) of callbox2	A.8
Figure C-1(e)	System level compliance continuity (Section 3.3.8)	four antenna measurement, three port (RF1 & RF3 & RF4 COM) of callbox	A.9

All the path losses from RF port of DUT to the callbox RF COM port and to the power meter are calibrated and automatically entered as offsets in the callbox and the power meter via test scripts on the PC used to control callbox and power meter.

Setup photos of Test setup Schematic are list in Appendix A.

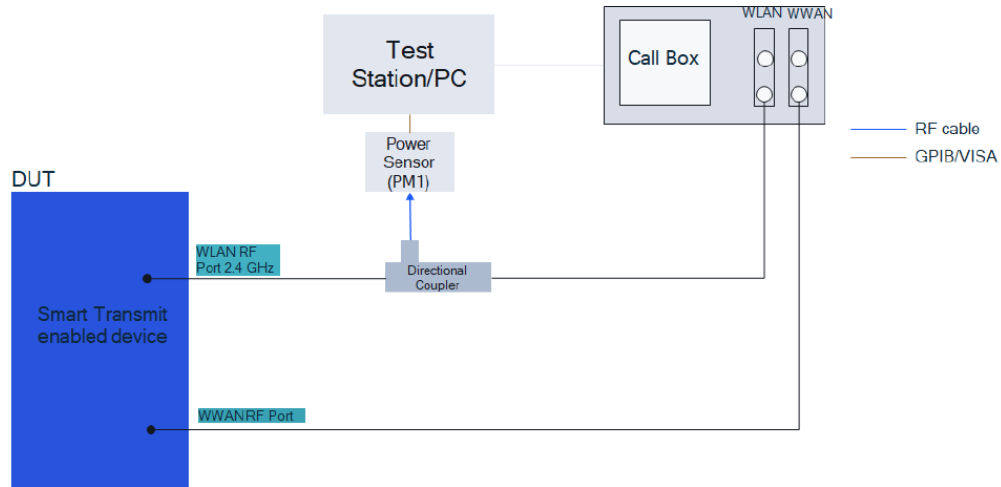


Figure C-1 (a)

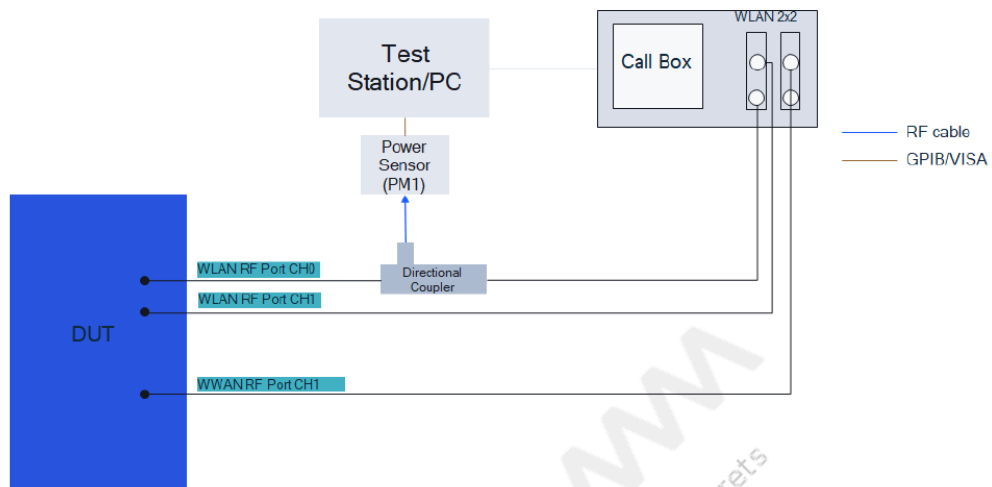


Figure C-1 (b)

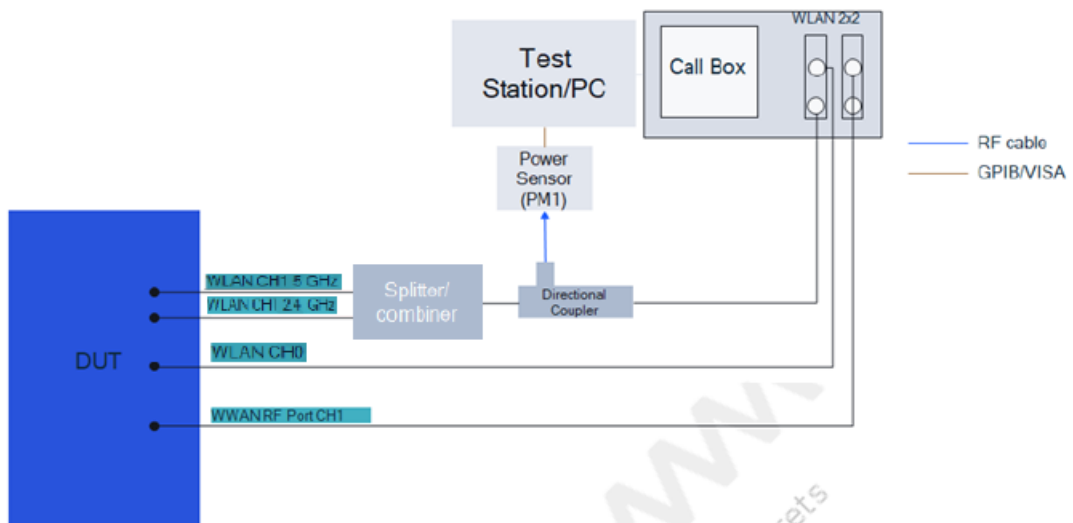


Figure C-1 (c)

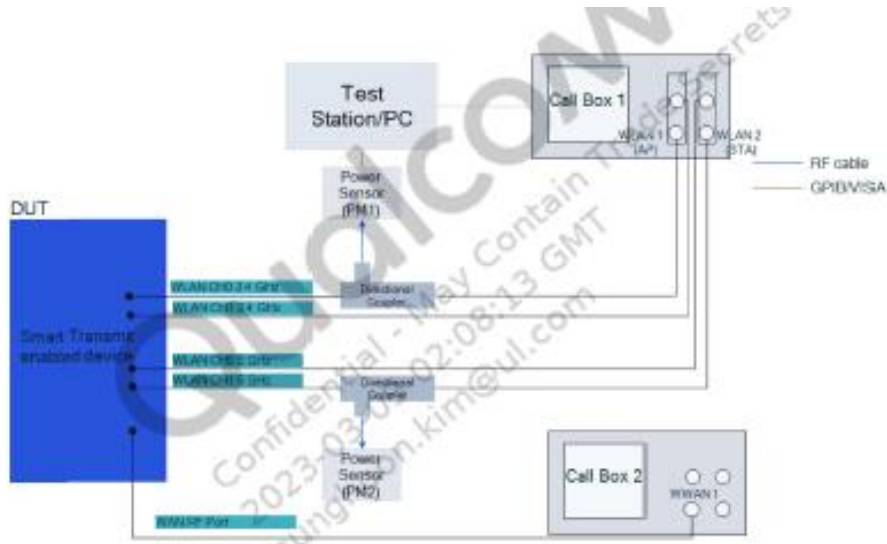


Figure C-1 (d)

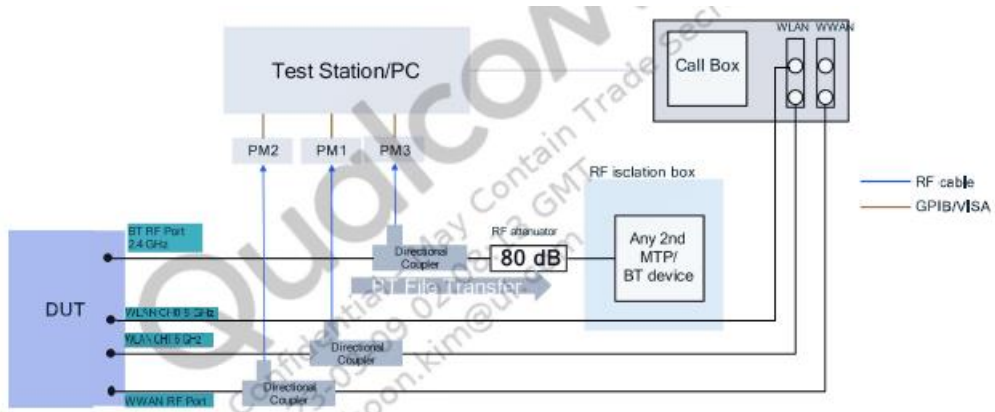


Figure C-1 (e)

Both the callbox and power meter are connected to the PC using LAN port. Two test scripts are custom made for automation, and the test duration set in the test scripts is about 500 seconds. For time-varying Tx power measurement, the PC runs the 1st test script to send LAN commands to control the callbox's requested power versus time, while at the same time to record the conducted power measured at EUT RF port using the power meter. The commands sent to the callbox to request power are:

WWAN Band measurement

- 0 dBm for 100 seconds
- Test sequence 1 or test sequence 2 (defined in Section 3.1 and generated in Section 3.2.1), For 360 seconds
- Stay at the last power level of test sequence 1 or sequence 2 for the remaining time.

WLAN Band measurement

- 0 dBm for 100 seconds
- Test sequence #1 (defined in Section 3.1 and generated in Section 3.2.1), For 200 seconds
- Stay at the last power level of test sequence #1 for the remaining time.

Power meter readings are periodically recorded every 100ms. A running average of this measured Tx power over 100 seconds is performed in the post-data processing to determine the 100s-time averaged power of WWAN Bands (the 30s-time averaged power of WLAN Bands).

For call drop, technology/band/antenna switch, and DSI switch tests, after the call is established, the callbox is set to request the EUT's Tx power at 0dBm for 100 seconds while simultaneously starting the 2nd test script runs at the same time to start recording the Tx power measured at EUT RF port using the power meter. After the initial 100 seconds since starting the Tx power recording, the callbox is set to request maximum power from the EUT for the rest of the test. Note that the call drop/re-establish, or technology/band/antenna switch or DSI switch is manually performed when the Tx power of EUT is at $P_{reserve}$ level. See Section 3.3 for detailed test procedure of call drop test, technology/band/antenna switch test and DSI switch test.

6.2. P_{limit} and P_{max} measurement results

This measured P_{limit} for all the selected radio configurations given in Table 5-2 are listed in below Table 6-1. P_{max} was also measured for radio configurations selected for testing time-varying Tx power transmission scenarios in order to generate test sequences following the test procedures in Section 3.1.

Table 6-1 : Measured P_{limit} and P_{max} of selected WWAN radio configurations
 Note: the device uncertainty of P_{max} is +1.0dB/-1.5dB as provided by manufacturer.

Test Case	Test Scenario	Tech	Band	Antenna	DSI	Channel	Freq. (MHz)	RB/RB Offset/Bandwidth (MHz)	Mode	SAR Exposure Scenario	Worst configurations	Part 1 Worst Case Measured SAR at P_{limit} (W/kg)	P_{limit} (dBm)	Measured P_{limit} (dBm)	Tune-up P_{max} (dBm)	Measured P_{max} (dBm)
1	Test Sequence 1	GSM	1900	B	0	661	1880.0	-	GPRS 4 Slots	Extremity 10g (UMPC)	Bottom - 0mm	1.260	18.49	17.93	21.49	21.56
	Test Sequence 2															
2	Test Sequence 1	WCDMA	2	B	0	9538	1907.6	-	Rel 99	Extremity 10g (UMPC)	Bottom - 0mm	2.260	19.00	19.41	23.80	24.37
	Test Sequence 2															
3	Test Sequence 1	LTE	B7	B	0	20850	2510.0	1/49/20 MHz	QPSK	Body 1g SAR (UMPC)	Bottom - 10mm	0.627	17.00	17.69	24.00	23.81
	Test Sequence 2															
4	Test Sequence 1	NR	Bn41 (PC3)	B	0	518598	2593.0	1/1/100 MHz	DFT-s-OFDM QPSK	Extremity 10g (UMPC)	Bottom - 0mm	1.250	17.00	17.13	24.00	23.84
	Test Sequence 2															
5	Change in Call	LTE	B7	B	0	20850	2510.0	1/49/20 MHz	QPSK	Body 1g SAR (UMPC)	Bottom - 10mm	0.627	17.00	17.69	24.00	23.81
6	DSI Switch	LTE	B66	F	0	132572	1770.0	1/99/20 MHz	QPSK	Extremity 10g (UMPC)	Top - 0mm	1.540	20.00	20.19	24.00	24.29
					3	132572	1770.0	1/99/20 MHz	QPSK	Head (Phablet)	Right Tilt	0.783	22.50	22.78	24.00	24.29
7	Tech/Band/Antenna Switch	LTE	B7	B	0	20850	2510.0	1/49/20 MHz	QPSK	Body 1g (UMPC)	Bottom - 10mm	0.627	17.00	17.69	24.00	23.81
		WCDMA	5	A	0	4183	836.5	-	Rel 99	Extremity 10g (UMPC)	Left - 0mm	1.360	24.50	23.67	24.50	23.67
8	Time Window Switch	LTE	B25	F	0	26590	1905.0	1/0/20 MHz	QPSK	Extremity 10g (UMPC)	Top - 0mm	1.770	20.00	19.78	23.00	23.87
		LTE	B48	F	0	56207	3646.7	1/99/20 MHz	QPSK	Extremity 10g (UMPC)	Top - 0mm	2.400	18.00	17.95	21.00	21.67
9	SAR1 vs SAR2 (EN-DC)	LTE	B12	A	0	23095	707.5	1/49/10 MHz	QPSK	Extremity 10g (UMPC)	Left - 0mm	1.170	24.50	23.84	24.50	23.84
		NR	Bn25	B	0	376500	1882.5	1/1/40 MHz	DFT-s-OFDM QPSK	Extremity 10g (UMPC)	Bottom - 0mm	1.610	19.00	19.74	23.50	23.16

Notes:

1. For GSM, LTE TDD Bands, Tests including duty-cycle transmit are normalized to frame average.
2. NR TDD P_{max} and P_{limit} are measured at 90% duty cycle in call box.

Table 6-1 : Measured P_{limit} and P_{max} of selected WLAN radio configurations
 Note: the device uncertainty of P_{max} is +1.0dB/-1.5dB as provided by manufacturer.

Test Case	Test Scenario	Tech	Band	Antenna	DSI	Channel	Freq. (MHz)	RB/RB Offset /Bandwidth (MHz)	Mode	SAR Exposure Scenario	Worst configurations	Part 1 Worst Case Measured SAR at Plimit (W/kg)	Plimit (dBm)	measured Plimit (dBm)	Pmax (dBm)	measured Pmax (dBm)
10	Time-varying	WLAN	2.4GHz SISO	G	3	6	2437	20MHz	802.11b mode	Head (Phablet)	Left Tilt	0.210	17.00	16.61	18.00	17.59
11		WLAN	5GHz MIMO	J	0	155	5775	80MHz	802.11ac mode	Body 1g SAR (UMPC)	Rear - 10mm	0.742	16.00	15.71	17.00	16.51
12	Change in Call	WLAN	5GHz MIMO	J	0	155	5775	80MHz	802.11ac mode	Body 1g SAR (UMPC)	Rear - 10mm	0.742	16.00	15.71	17.00	16.51
13	Change in Band/Antenna	WLAN	2.4GHz MIMO	G	0	6	2437	20MHz	802.11ac mode	Body 1g SAR (UMPC)	Left - 10mm	0.520	17.00	16.96	17.00	16.96
		WLAN	5GHz MIMO	J	0	149	5745	20MHz	802.11ac mode	Body 1g SAR (UMPC)	Rear - 10mm	0.742	16.00	15.82	17.00	16.58
14	Change in DSI	WLAN	5GHz MIMO	J	0	155	5775	80MHz	802.11ac mode	Body 1g SAR (UMPC)	Rear - 10mm	0.742	16.00	15.71	17.00	16.51
		WLAN	5GHz MIMO	J	3	155	5775	80MHz	802.11ac mode	Head (Phablet)	Right Touch	0.233	17.00	16.40	17.00	16.51
15	DBS SAR vs SAR	WLAN	2.4GHz MIMO	G	0	6	2437	20MHz	802.11ac mode	Body 1g SAR (UMPC)	Left - 10mm	0.520	17.00	16.96	17.00	16.96
		WLAN	5GHz MIMO (Hotspot)	J	0	149	5745	20MHz	802.11ac mode	Body 1g SAR (UMPC)	Rear - 10mm	0.742	16.00	15.82	17.00	16.58
16	System Level Compliance Continuity	WWAN	LTE B48	F	0	56207	3646.7	1/99/20 MHz	QPSK	Extremity 10g SAR (UMPC)	Top - 0mm	2.400	18.00	17.95	21.00	21.67
		WLAN	5GHz MIMO	J	0	155	5775	80MHz	802.11ac mode	Body 1g SAR (UMPC)	Rear - 10mm	0.742	16.00	15.71	17.00	16.51
		BT	Bluetooth	H	0	39	2441	-	EDR	Extremity 10g SAR (UMPC)	Left - 0mm	0.516	14.50	13.24		

Notes:

For Test Scenario.16 (System Level Compliance Continuity), BT mode was connect EDR mode during test. Therefore, Plimit was measured at EDR mode.

BT Plimit calculation Results

Bluetooth	
Measured_BT_power-as measured test tree (dBm)	11.93
BT_Duty_Cycle	0.78
BT_STANDALONE	0.95
Measured BT Plimit (dBm)	13.24

Notes:

BT Plimit calculation follow Appendix S in Qualcomm document (80-W2112-5).

6.3. Time-varying Tx power measurement results (test case 1–4 & 10-11 in Table 5-2)

The measurement setup is shown in Figures B-1(a) of GSM/WCDMA/LTE/NR and Figures C-1(a) of WLAN. The purpose of the time-varying Tx power measurement is to demonstrate the effectiveness of power limiting enforcement and that the time-averaged Tx power when represented in time-averaged 1gSAR or 10gSAR values does not exceed FCC limit as shown in Eq.(1a) and (1b), rewritten below:

$$1g_or_10gSAR(t) = \frac{conducted_Tx_power(t)}{conducted_Tx_power_P_{limit}} * 1g_or_10gSAR_P_{limit} \quad (1a)$$

$$\frac{\frac{1}{T_{SAR}} \int_{t-T_{SAR}}^t 1g_or_10gSAR(t) dt}{FCC\ SAR\ limit} \leq 1 \quad (1b)$$

Where, *conducted_Tx_power(t)*, *conducted_Tx_power_P_{limit}*, and *1g_or_10gSAR_P_{limit}* correspond to the measured instantaneous conducted Tx power, measured conducted Tx power at *P_{limit}*, and measured 1gSAR and 10gSAR value at *P_{limit}* reported in Part 1 test (listed in Table 5-2 of this report as well). Following the test procedure in Section 3.3, the conducted Tx power measurement for all selected configurations are reported in this section. In all the conducted Tx power plots, the dotted line represents the requested power by callbox (WWAN : test sequence 1 or test sequence 2 & WLAN : test sequence #1), the blue curve represents the instantaneous conducted Tx power measured using power meter, the green curve represents time-averaged power and red line represents the conducted power limit that corresponds to FCC limit of 1.6 W/kg for 1gSAR or 4.0 W/kg for 10gSAR.

Similarly, in all the 1g or 10gSAR plots (when converted using Eq. (1a)), the green curve represents the 100s/60s-time averaged 1gSAR or 10gSAR value calculated based on instantaneous 1gSAR or 10gSAR; and the red line limit represents the FCC limit of 1.6 W/kg for 1gSAR or 4.0 W/kg for 10gSAR.

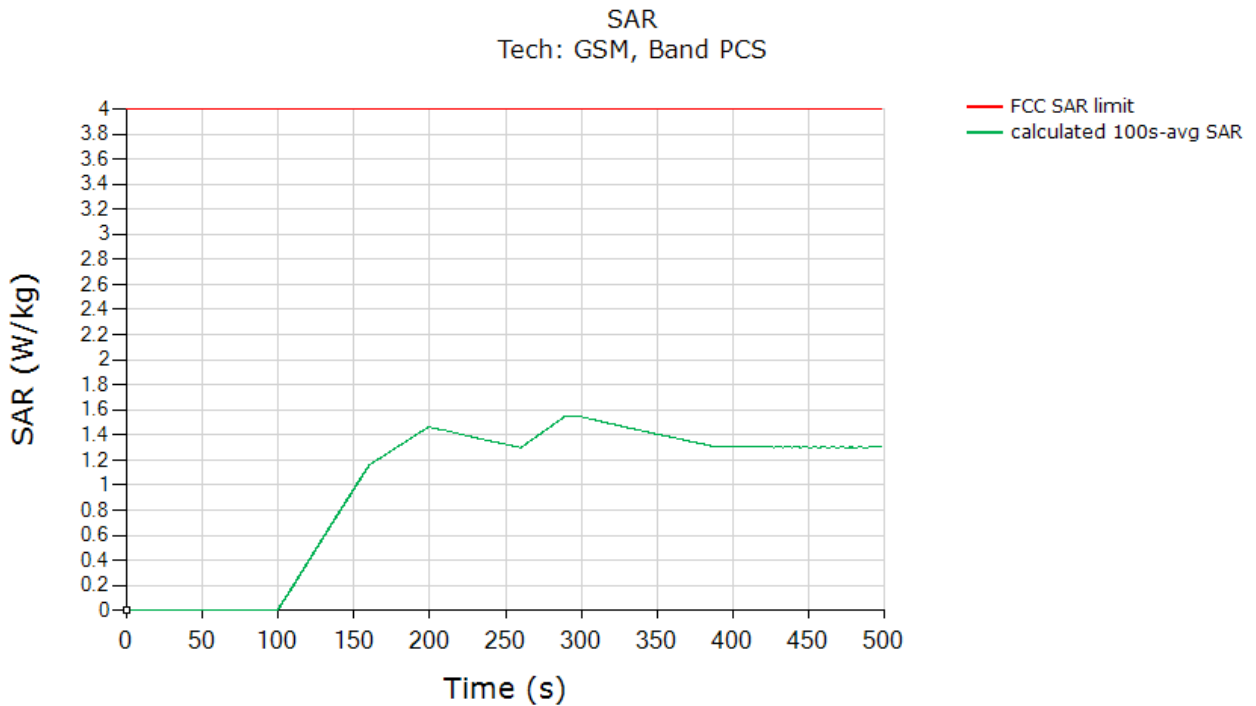
Time-varying Tx power measurements were conducted on test case #1 ~ #4 in Table 5-2, by generating test sequence 1 and test sequence 2 given in Section A using measured *P_{limit}* and measured P_{max} (last two columns of Table 6-1) for each of these test cases. Measurement results for test cases #1 ~ #4 are given in Sections 6.3.1 – 6.3.4.

Time-varying Tx power measurements were conducted on test case #10, #11 in Table 5-2, by generating test sequence #1 in Section A using measured *P_{limit}* and measured P_{max} (last two columns of Table 6-1) for each of these test cases. Measurement results for test cases #10, #11 are given in Sections 6.3.5 – 6.3.6.

6.3.1 GSM Band 1900

Test result for test sequence 1:

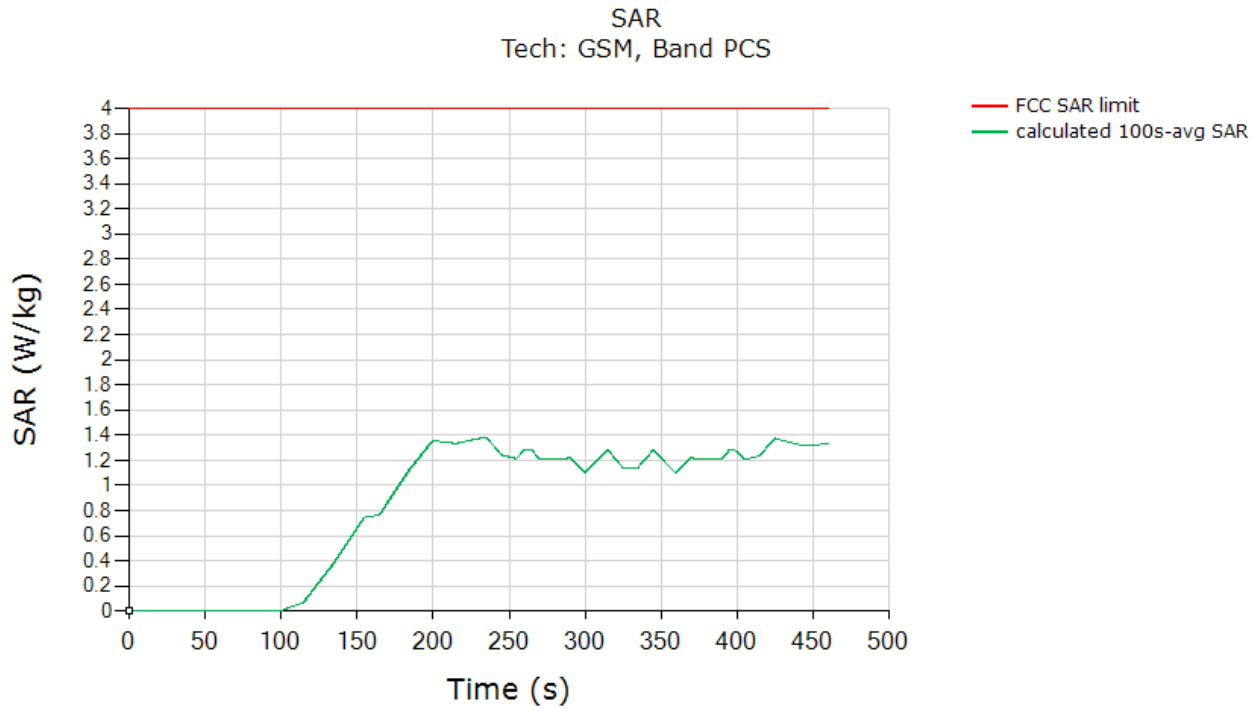
Time-averaged conducted Tx power is converted/calculated into time-averaged SAR using Equation (1a) and plotted below to demonstrate that the time-averaged SAR versus time does not exceed the FCC limit for SAR (1.6W/kg for 1g SAR or 4.0W/kg for 10g SAR):



	(W/kg)
FCC 10gSAR limit	4.0
Max 100s-time averaged 10gSAR (green curve)	1.547
Validated : Max time averaged SAR (green curve) is within 1 dB device uncertainty of measured SAR at P_{limit} (Table 5-2).	

Test result for test sequence 2:

Time-averaged conducted Tx power is converted/calculated into time-averaged SAR using Equation (1a) and plotted below to demonstrate that the time-averaged SAR versus time does not exceed the FCC limit for SAR (1.6W/kg for 1g SAR or 4.0W/kg for 10g SAR):

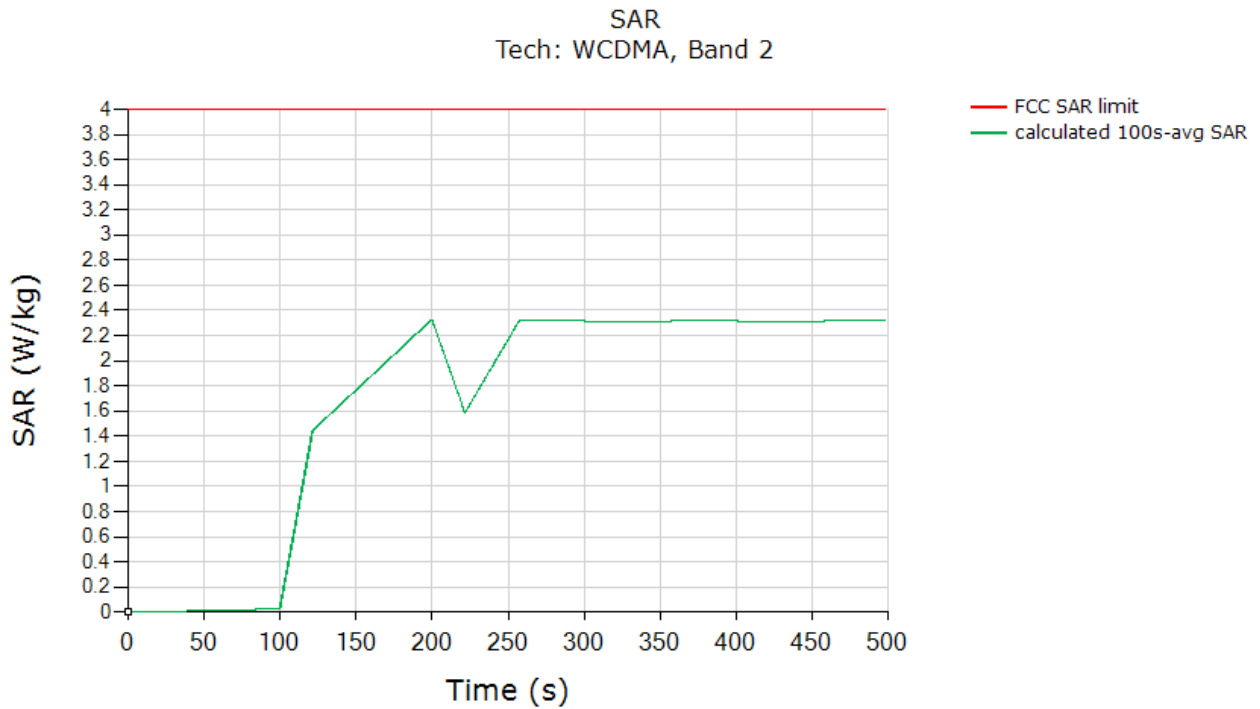


	(W/kg)
FCC 10gSAR limit	4.0
Max 100s-time averaged 1gSAR (green curve)	1.385
Validated : Max time averaged SAR (green curve) is within 1 dB device uncertainty of measured SAR at P_{limit} (Table 5-2).	

6.3.2 WCDMA Band II

Test result for test sequence 1:

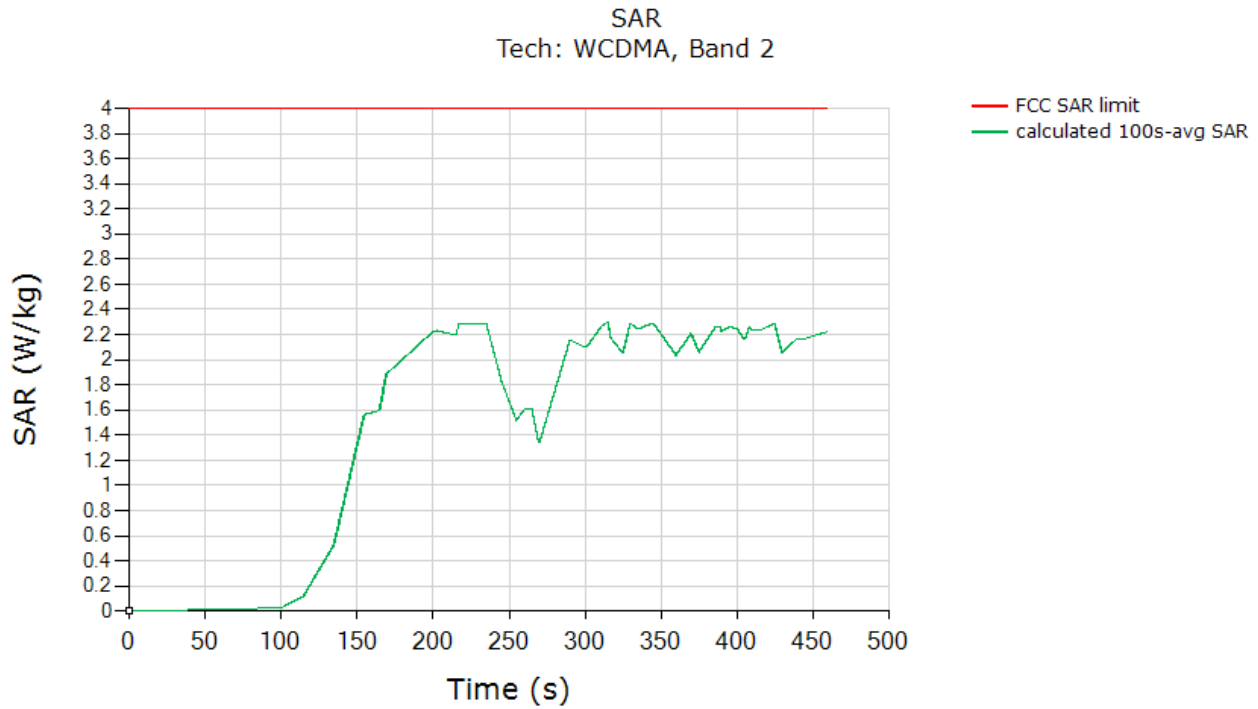
Time-averaged conducted Tx power is converted/calculated into time-averaged SAR using Equation (1a) and plotted below to demonstrate that the time-averaged SAR versus time does not exceed the FCC limit for SAR (1.6W/kg for 1g SAR or 4.0W/kg for 10g SAR):



	(W/kg)
FCC 10gSAR limit	4.0
Max 100s-time averaged 10gSAR (green curve)	2.327
Validated : Max time averaged SAR (green curve) is within 1 dB device uncertainty of measured SAR at P_{limit} (Table 5-2).	

Test result for test sequence 2:

Time-averaged conducted Tx power is converted/calculated into time-averaged SAR using Equation (1a) and plotted below to demonstrate that the time-averaged SAR versus time does not exceed the FCC limit for SAR (1.6W/kg for 1g SAR or 4.0W/kg for 10g SAR):

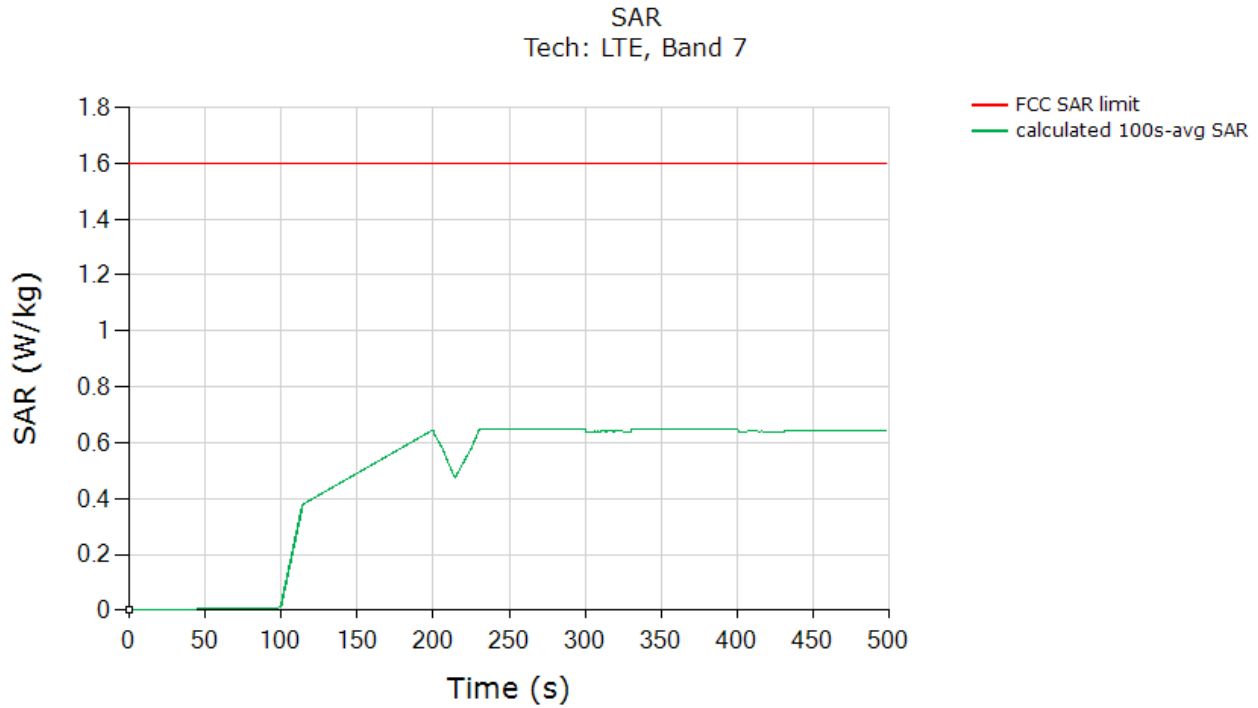


	(W/kg)
FCC 10gSAR limit	4.0
Max 100s-time averaged 10gSAR (green curve)	2.298
Validated : Max time averaged SAR (green curve) is within 1 dB device uncertainty of measured SAR at P_{limit} (Table 5-2).	

6.3.3 LTE Band 7

Test result for test sequence 1:

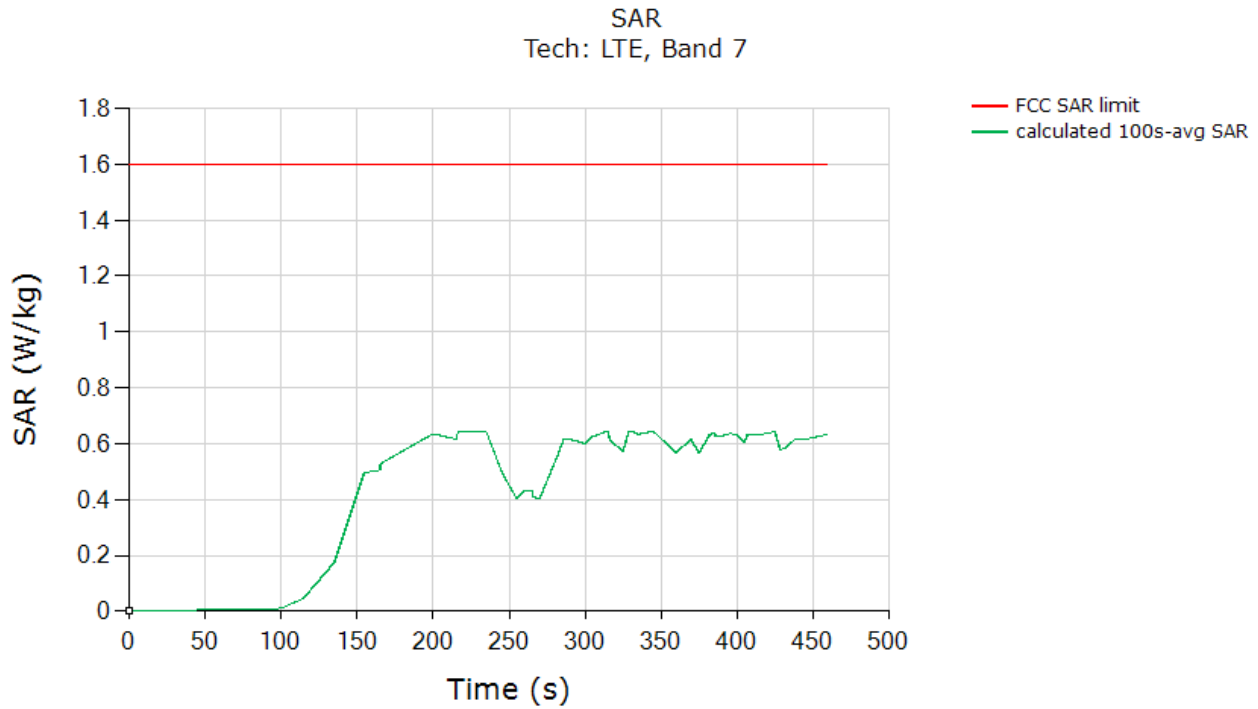
Time-averaged conducted Tx power is converted/calculated into time-averaged SAR using Equation (1a) and plotted below to demonstrate that the time-averaged SAR versus time does not exceed the FCC limit for SAR (1.6W/kg for 1g SAR or 4.0W/kg for 10g SAR):



	(W/kg)
FCC 1gSAR limit	1.6
Max 100s-time averaged 1gSAR (green curve)	0.646
Validated : Max time averaged SAR (green curve) is within 1 dB device uncertainty of measured SAR at P_{limit} (Table 5-2).	

Test result for test sequence 2:

Time-averaged conducted Tx power is converted/calculated into time-averaged SAR using Equation (1a) and plotted below to demonstrate that the time-averaged SAR versus time does not exceed the FCC limit for SAR (1.6W/kg for 1g SAR or 4.0W/kg for 10g SAR):

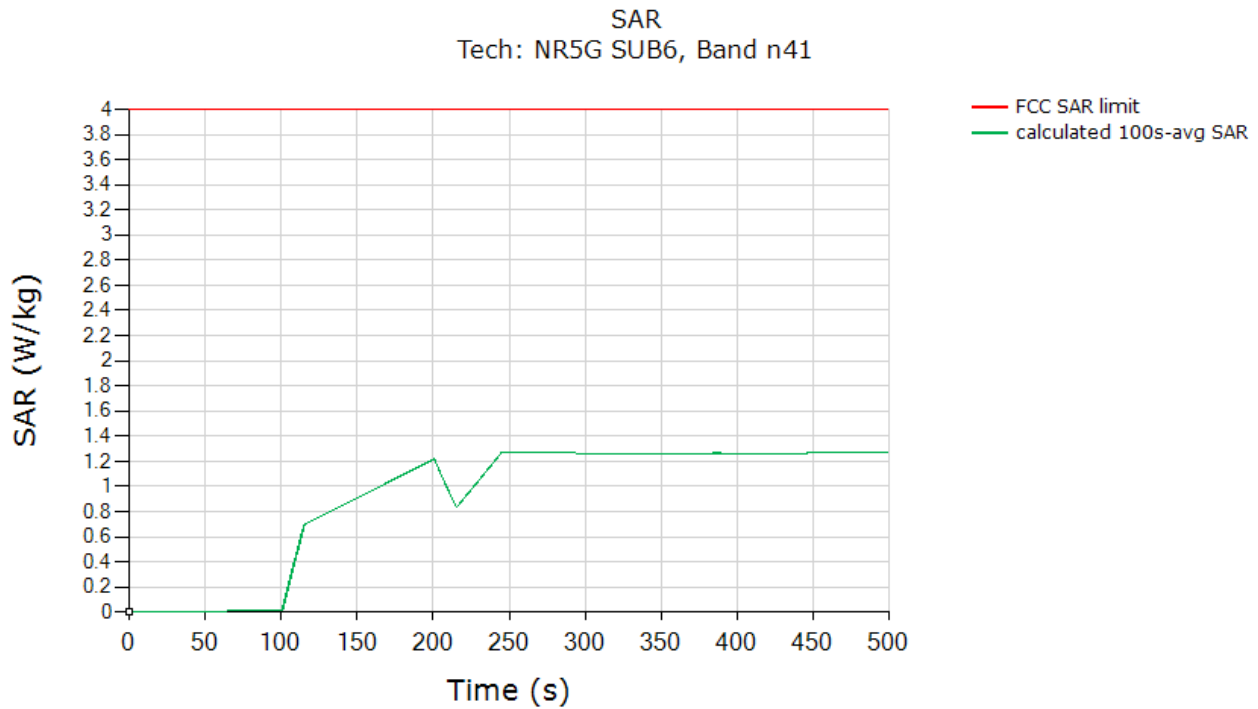


	(W/kg)
FCC 1gSAR limit	1.6
Max 100s-time averaged 1gSAR (green curve)	0.644
Validated : Max time averaged SAR (green curve) is within 1 dB device uncertainty of measured SAR at P_{limit} (Table 5-2).	

6.3.4 NR Band n41

Test result for test sequence 1:

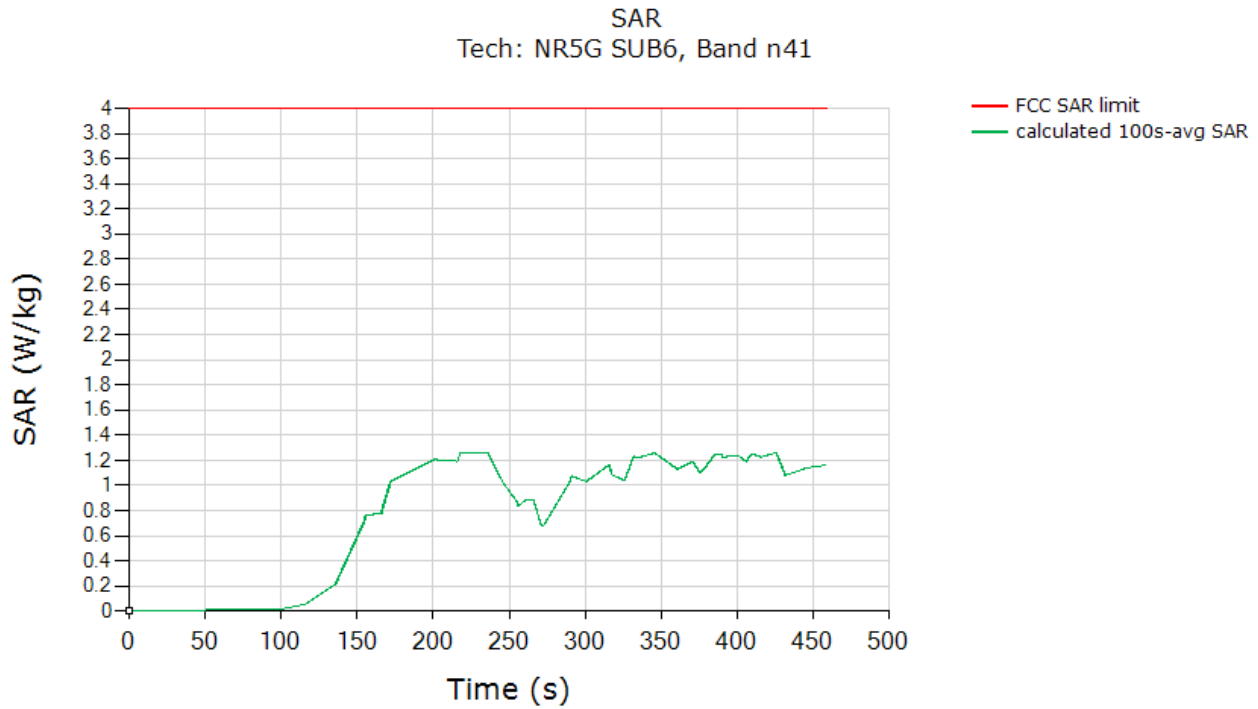
Time-averaged conducted Tx power is converted/calculated into time-averaged SAR using Equation (1a) and plotted below to demonstrate that the time-averaged SAR versus time does not exceed the FCC limit for SAR (1.6W/kg for 1g SAR or 4.0W/kg for 10g SAR):



	(W/kg)
FCC 10gSAR limit	4.0
Max 100s-time averaged 10gSAR (green curve)	1.270
Validated : Max time averaged SAR (green curve) is within 1 dB device uncertainty of measured SAR at P_{limit} (Table 5-2).	

Test result for test sequence 2:

Time-averaged conducted Tx power is converted/calculated into time-averaged SAR using Equation (1a) and plotted below to demonstrate that the time-averaged SAR versus time does not exceed the FCC limit for SAR (1.6W/kg for 1g SAR or 4.0W/kg for 10g SAR):

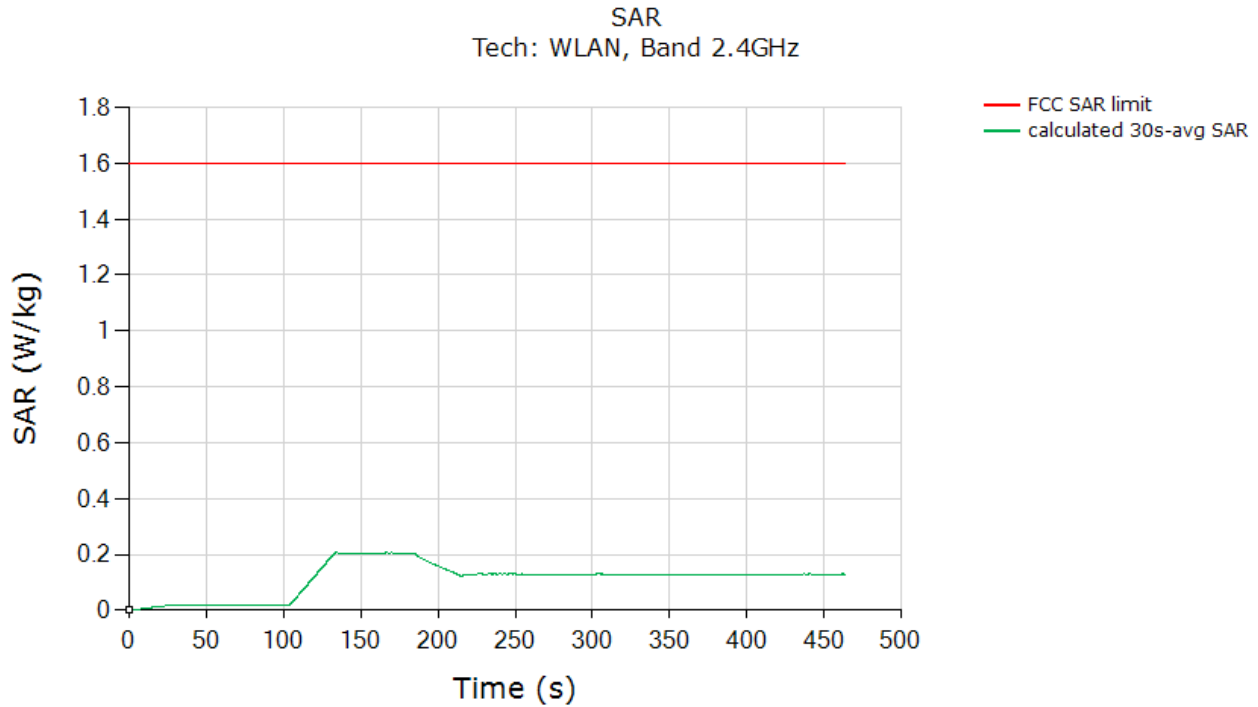


	(W/kg)
FCC 10gSAR limit	4.0
Max 100s-time averaged 10gSAR (green curve)	1.263
Validated : Max time averaged SAR (green curve) is within 1 dB device uncertainty of measured SAR at P_{limit} (Table 5-2).	

6.3.5 2.4GHz SISO (802.11b)

Test result for test sequence #1:

Time-averaged conducted Tx power is converted/calculated into time-averaged SAR using Equation (1a) and plotted below to demonstrate that the time-averaged SAR versus time does not exceed the FCC limit for SAR (1.6W/kg for 1g SAR or 4.0W/kg for 10g SAR):

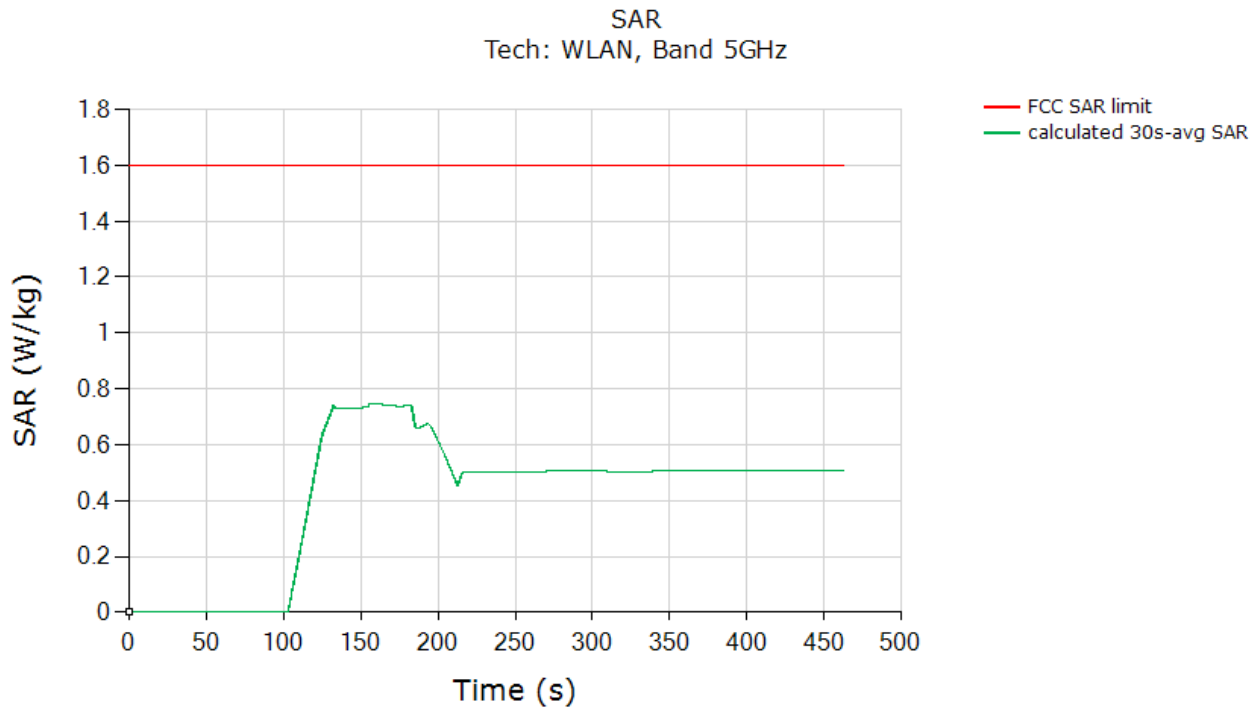


	(W/kg)
FCC 1gSAR limit	1.6
Max 30s-time averaged 1gSAR (green curve)	0.207
Validated : Max time averaged SAR (green curve) is within 1 dB device uncertainty of measured SAR at P_{limit} (Table 5-2).	

6.3.6 5GHz MIMO (802.11ac_VHT80)

Test result for test sequence #1:

Time-averaged conducted Tx power is converted/calculated into time-averaged SAR using Equation (1a) and plotted below to demonstrate that the time-averaged SAR versus time does not exceed the FCC limit for SAR (1.6W/kg for 1g SAR or 4.0W/kg for 10g SAR):



	(W/kg)
FCC 1gSAR limit	1.6
Max 30s-time averaged 1gSAR (green curve)	0.748
Validated : Max time averaged SAR (green curve) is within 1 dB device uncertainty of measured SAR at P_{limit} (Table 5-2).	

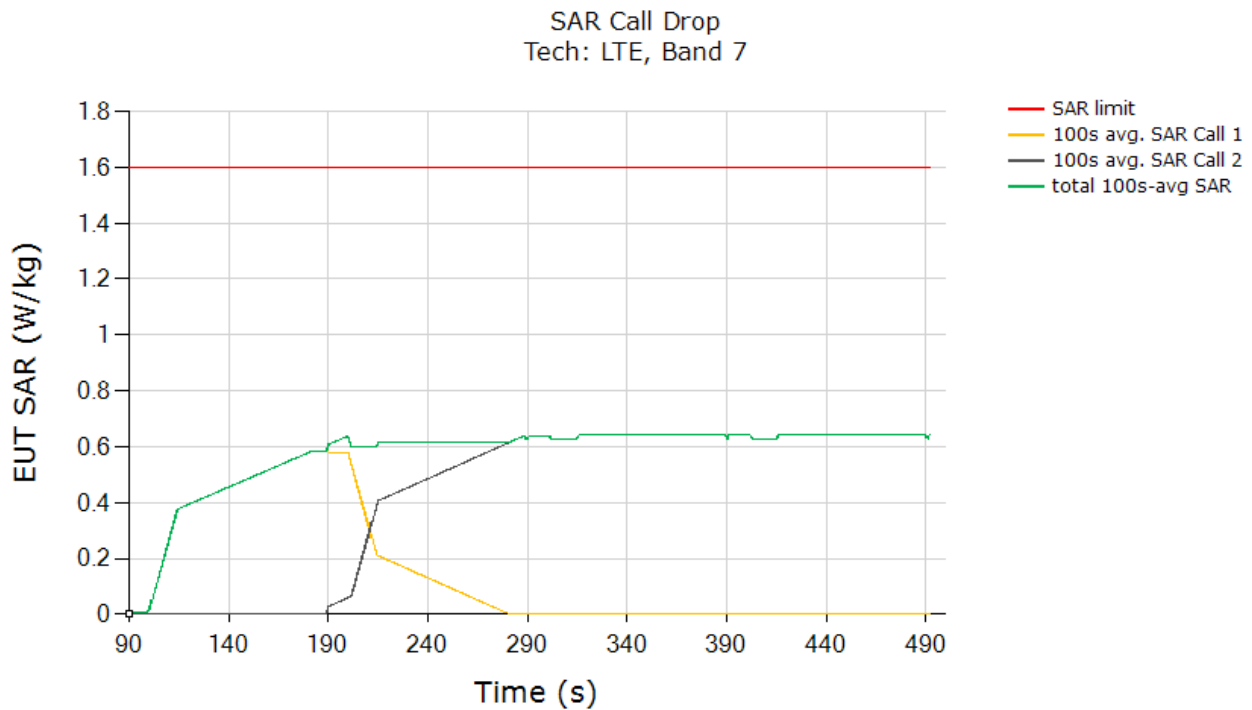
6.4. Change in Call Test Results

6.4.1. WWAN (test case 5 in Table 5-2)

This test was measured with LTE Band 7, Ant.B, DSI =0, and with callbox requesting maximum power. The call drop was manually performed when the EUT is transmitting at $P_{reserve}$ level as shown in the plot below (dotted black region). The measurement setup is shown in Figure B-1(a). The detailed test procedures is described in Section 3.3.2.

Call drop test result:

Time-averaged conducted Tx power is converted/calculated into time-averaged SAR using Equation (1a) and plotted below to demonstrate that the time-averaged SAR versus time does not exceed the FCC limit for SAR(1.6W/kg for 1g SAR or 4.0W/kg for 10g SAR):



	(W/kg)
FCC 1gSAR limit	1.6
Max 100s-time averaged 1gSAR (green curve)	0.641
Validated	

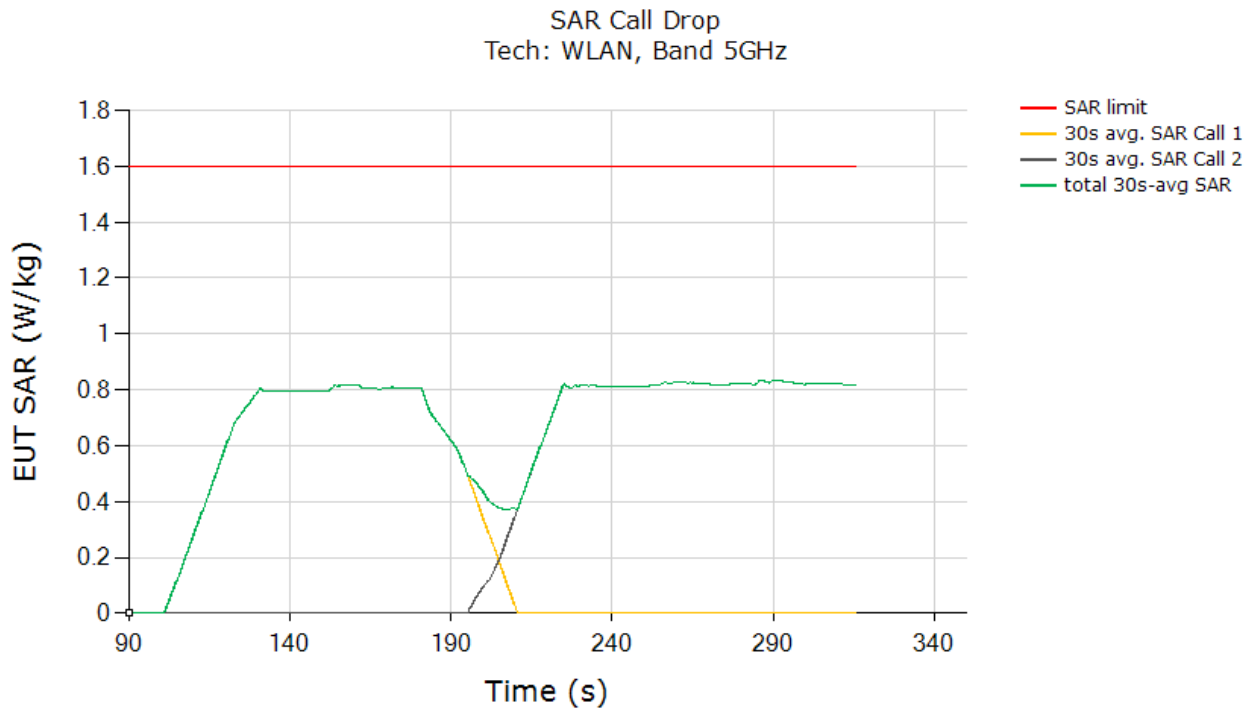
The test result validated the continuity of power limiting in call change scenario.

6.4.2. WLAN (test case 12 in Table 5-2)

This test was measured with 5GHz MIMO(802.11ac_VHT80), Ant.J, DSI =0, and with callbox requesting maximum power. The call drop was manually performed when the EUT is transmitting at $P_{reserve}$ level as shown in the plot below (dotted black region). The measurement setup is shown in Figure C-1(b). The detailed test procedures is described in Section 3.3.2.

Call drop test result:

Time-averaged conducted Tx power is converted/calculated into time-averaged SAR using Equation (1a) and plotted below to demonstrate that the time-averaged SAR versus time does not exceed the FCC limit for SAR(1.6W/kg for 1g SAR or 4.0W/kg for 10g SAR):



	(W/kg)
FCC 1gSAR limit	1.6
Max 30s-time averaged 1gSAR (green curve)	0.833
Validated	

The test result validated the continuity of power limiting in call change scenario.

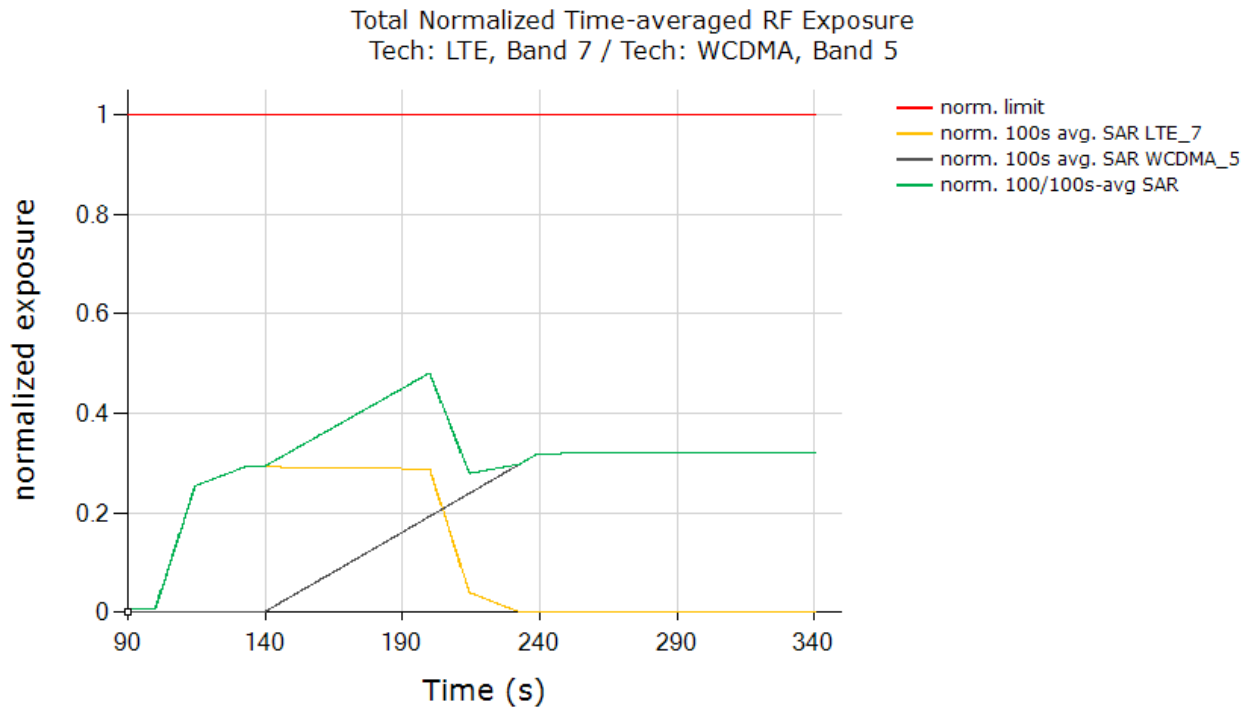
6.5. Change in technology/band/Antenna test results

6.5.1. WWAN (test case 7 in Table 5-2)

This test was conducted with callbox requesting maximum power, and with technology switch from LTE Band 7, Ant.B, DSI =0 to WCDMA Band 5, Ant.A, DSI = 0. Following procedure detailed in Section 3.3.3 & 3.3.4, and using the measurement setup shown in Figure B-1 (b), the technology/band switch was performed when the EUT is transmitting at $P_{reserve}$ level as shown in the plot below (dotted black region).

Test result for change in technology/band:

Time-averaged conducted Tx power measurement results were converted into time-averaged normalized SAR values using Equation (6a), (6b) and (6c), and plotted below to demonstrate that the time-average normalized SAR versus time does not exceed the normalized FCC limit of 1.0:



	(W/kg)
FCC normalized SAR limit	1.0
Max 100s-time averaged normalized SAR (green curve)	0.481
Validated	

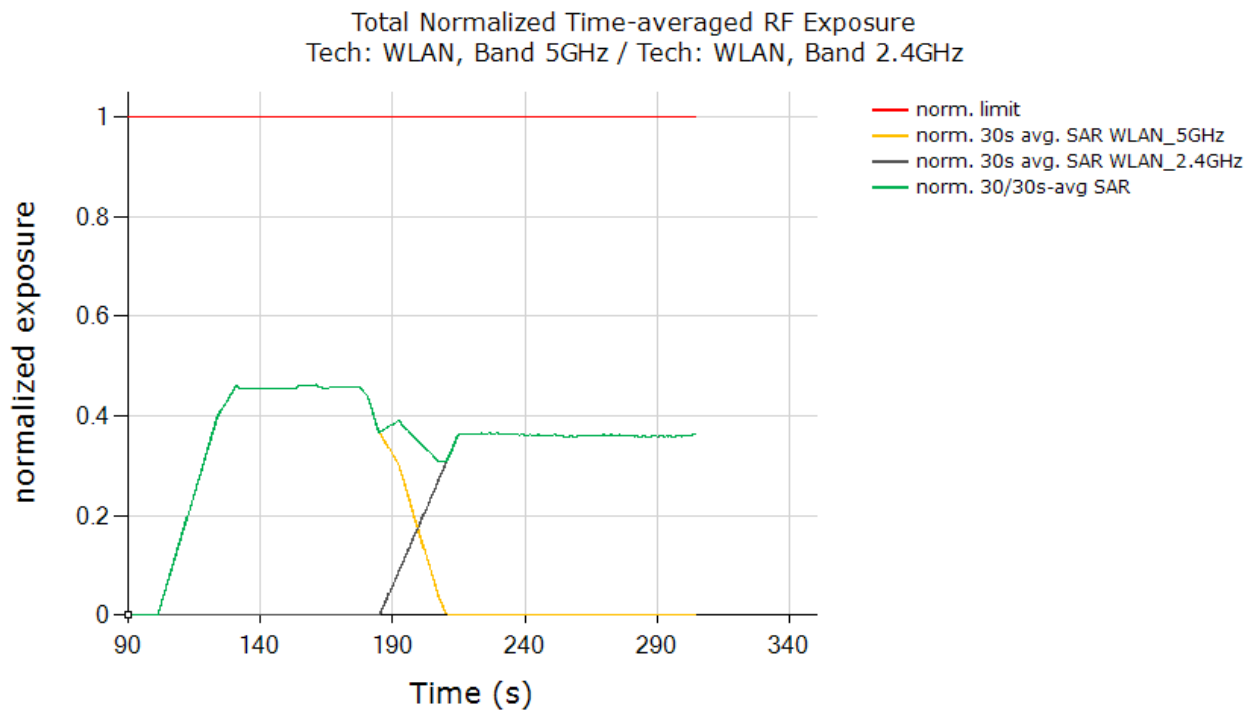
The test result validated the continuity of power limiting in technology/band switch scenario.

6.5.2. WLAN (test case 13 in Table 5-2)

This test was conducted with callbox requesting maximum power, and with technology switch from 2.4GHz MIMO(802.11ac), Ant.G, DSI =0 to 5GHz MIMO(802.11ac_VHT20), Ant.J, DSI = 0. Following procedure detailed in Section 3.3.3, and using the measurement setup shown in Figure C-1 (c), the band/Antenna switch was performed when the EUT is transmitting at $P_{reserve}$ level as shown in the plot below (dotted black region).

Test result for change in technology/band:

Time-averaged conducted Tx power measurement results were converted into time-averaged normalized SAR values using Equation (6a), (6b) and (6c), and plotted below to demonstrate that the time-average normalized SAR versus time does not exceed the normalized FCC limit of 1.0:



	(W/kg)
FCC normalized SAR limit	1.0
Max 30s-time averaged normalized SAR (green curve)	0.463
Validated	

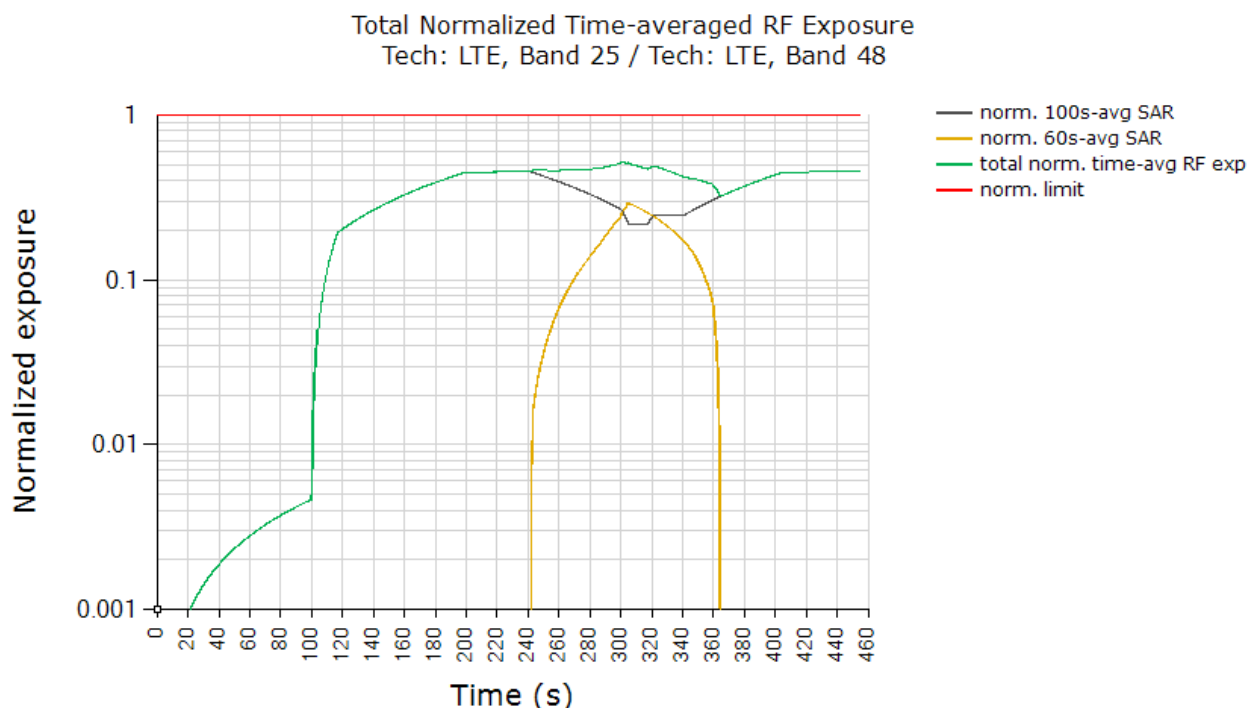
The test result validated the continuity of power limiting in technology/band switch scenario.

6.6. Change in Time Window/Antenna test results (test case 8 in Table 5-2)

This test was conducted with callbox requesting maximum power, and with time-window/antenna switch between LTE Band 25, Ant.F, DSI = 0 (100s window) and LTE Band 48, Ant.F, DSI = 0 (60s window). Following procedure detailed in Section 3.3.6, and using the measurement setup shown in Figure B-1(a), the time-window switch via band/antenna switch was performed when the EUT is transmitting at $P_{reserve}$ level.

Test case.1) Test result for change in time-window (from 100s to 60s to 100s):

All the conducted Tx power measurement results were converted into time-averaged normalized SAR values using Equation (7a), (7b) and (7c), and plotted below to demonstrate that the time-averaged normalized SAR versus time does not exceed the FCC limit of 1.0 unit. Equation (7a) is used to convert the Tx power of device to obtain 100s-averaged normalized SAR in LTE Band 66 as shown in black curve. Similarly, equation (7b) is used to obtain 60s-averaged normalized SAR in LTE Band 48 as shown in orange curve. Equation (7c) is used to obtain total time-averaged normalized SAR as shown in green curve (i.e., sum of black and orange curves).

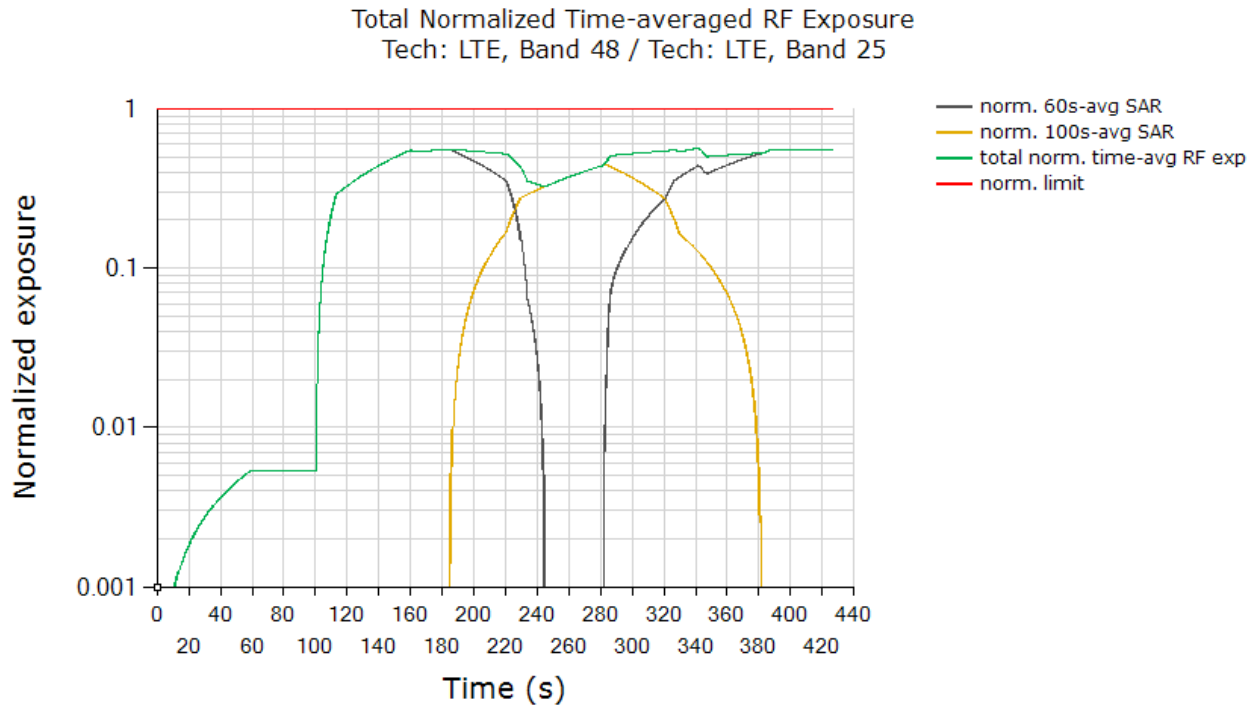


	(W/kg)
FCC normalized total exposure limit	1.0
Max time averaged normalized SAR (green curve)	0.552
Validated	

Plot Notes: Maximum power is requested by callbox for the entire duration of the test, with tech/band switches from 100s-to-60s window at ~245s time stamp, and from 60s-to-100s window at ~312s time stamp. Smart Transmit controls the Tx power during these time-window switches to ensure total time-averaged RF exposure, i.e., sum of black and orange curves given by equation (7c), is always compliant. In time-window switch test, at all times the total time-averaged normalized RF exposure (green curve) should not exceed normalized $SAR_{design_target} + 1.0$ dB device uncertainty. In this test, with a maximum normalized SAR of 0.552 being $\leq 0.79 (=1.0/1.6 + 1.0$ dB device uncertainty), the above test result validated the continuity of power limiting in time=window switch scenario.

Test case.2) Test result for change in time-window (from 60s to 100s to 60s):

All the conducted Tx power measurement results were converted into time-averaged normalized SAR values using Equation (7a), (7b) and (7c), and plotted below to demonstrate that the time-averaged normalized SAR versus time does not exceed the FCC limit of 1.0 unit. Equation (7a) is used to convert the Tx power of device to obtain 60s-averaged normalized SAR in LTE Band 48 as shown in black curve. Similarly, equation (7b) is used to obtain 100s-averaged normalized SAR in LTE Band 66 as shown in orange curve. Equation (7c) is used to obtain total time-averaged normalized SAR as shown in green curve (i.e., sum of black and orange curves).



	(W/kg)
FCC normalized total exposure limit	1.0
Max time averaged normalized SAR (green curve)	0.567
Validated	

Plot Notes: Maximum power is requested by callbox for the entire duration of the test, with tech/band switches from 60s-to-100s window at ~184s time stamp, and from 100s-to-60s window at ~292s time stamp. Smart Transmit controls the Tx power during these time-window switches to ensure total time-averaged RF exposure, i.e., sum of black and orange curves given by equation (7c), is always compliant. In time-window switch test, at all times the total time-averaged normalized RF exposure (green curve) should not exceed normalized SAR_{design_target} + 1.0 dB device uncertainty. In this test, with a maximum normalized SAR of 0.567 being ≤ 0.79 (=1.0/1.6 + 1.0 dB device uncertainty), the above test result validated the continuity of power limiting in time=window switch scenario.

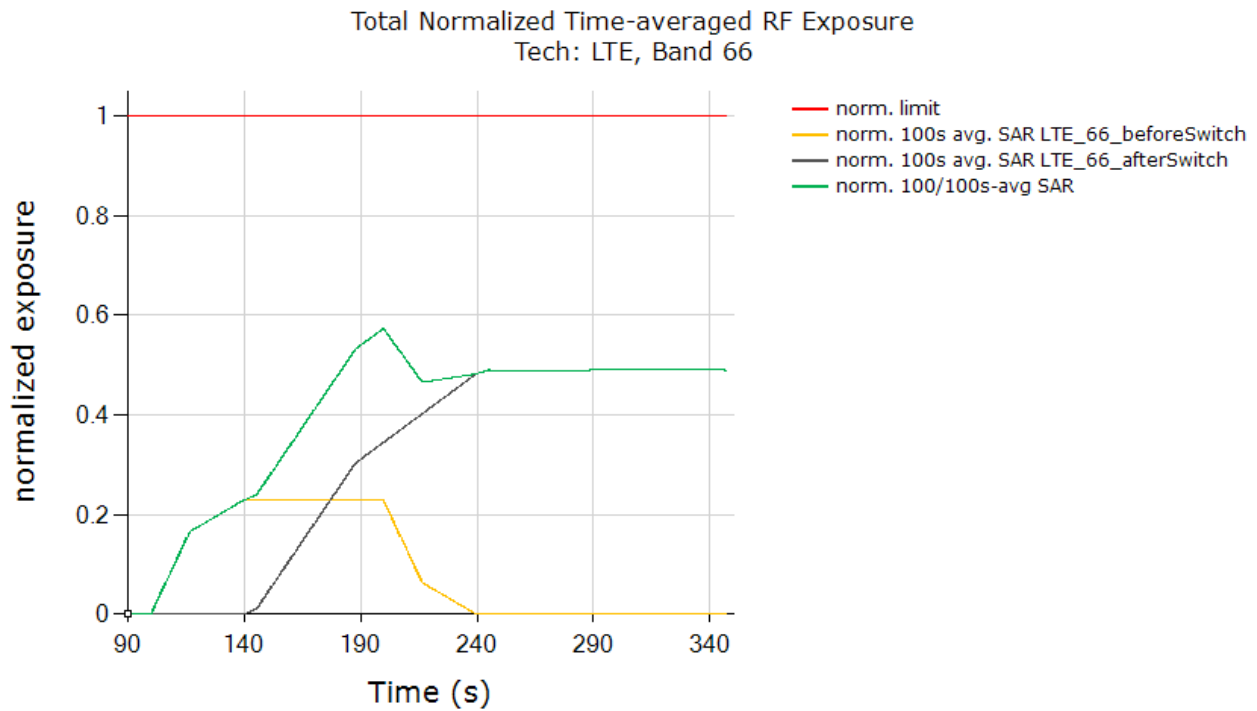
6.7. Change in DSI test results

6.7.1 WWAN (test case 6 in Table 5-2)

This test was conducted with callbox requesting maximum power, and with DSI switch from LTE Band 66 Ant.F DSI = 0 to DSI = 3. Following procedure detailed in Section 3.3.5 using the measurement setup shown in Figure B-1(a), the DSI switch was performed when the EUT is transmitting at $P_{reserve}$ level as shown in the plot below (dotted black circle).

Test result for change in DSI:

All the time-averaged conducted Tx power measurement results were converted into time-averaged normalized SAR values using Equation (6a), (6b) and (6c), and plotted below to demonstrate that the time-average normalized SAR versus time does not exceed the normalized FCC limit of 1.0 unit.



	(W/kg)
FCC normalized SAR limit	1.0
Max 100s-time averaged normalized SAR (green curve)	0.574
Validated	

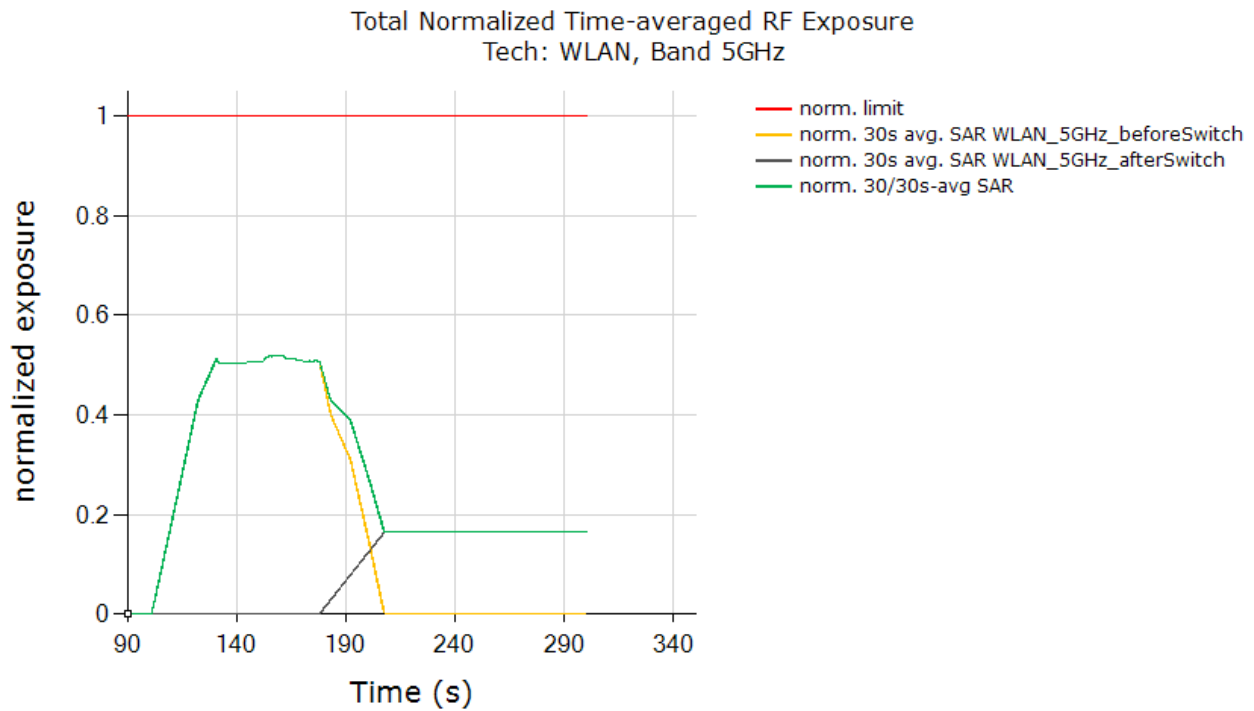
The test result validated the continuity of power limiting in DSI scenario.

6.7.2 WLAN (test case 14 in Table 5-2)

This test was conducted with callbox requesting maximum power, and with DSI switch from 5GHz MIMO(802.11ac_VHT80) Ant.J DSI = 0 to DSI = 3. Following procedure detailed in Section 3.3.5 using the measurement setup shown in Figure C-1(b), the DSI switch was performed when the EUT is transmitting at $P_{reserve}$ level as shown in the plot below (dotted black circle).

Test result for change in DSI:

All the time-averaged conducted Tx power measurement results were converted into time-averaged normalized SAR values using Equation (6a), (6b) and (6c), and plotted below to demonstrate that the time-average normalized SAR versus time does not exceed the normalized FCC limit of 1.0 unit.



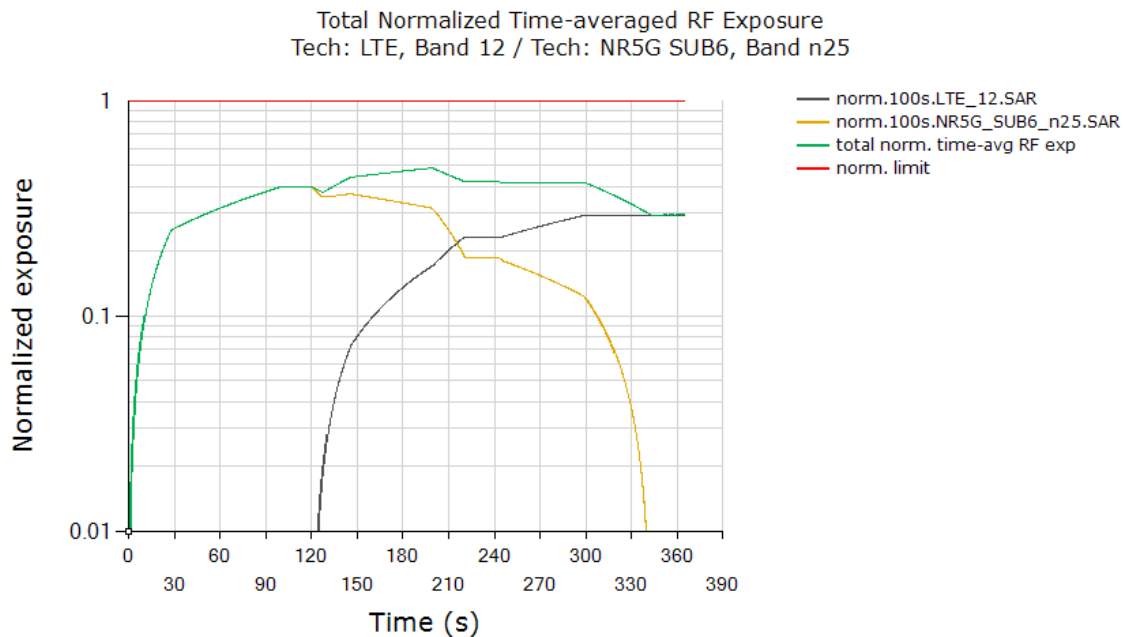
	(W/kg)
FCC normalized SAR limit	1.0
Max 30s-time averaged normalized SAR (green curve)	0.519
Validated	

The test result validated the continuity of power limiting in DSI scenario.

6.8. Switch in SAR exposure test result

6.8.1 WWAN (LTE+NR) (test case 9 in Table 5-2)

This test was conducted with callbox requesting maximum power, and with the EUT in LTE Band 12 + Sub6 NR Band n25 call. Following procedure detailed in Section 3.3.7 and Section B.2, and using the Measurement setup shown in Figure B-1(c) since LTE and Sub6 NR are sharing the same antenna port, the SAR exposure switch measurement is performed with the EUT in various SAR exposure scenarios, All the conducted Tx power measurement results were converted into time-averaged normalized SAR values using Equation (7a), (7b) and (7c), and plotted below to demonstrate that the time-averaged normalized SAR versus time does not exceed the FCC limit of 1.0 unit. Equation (7a) is used to convert the LTE Tx power of device to obtain 100s-averaged normalized SAR in LTE Band 12 as show in black curve. Similarly, equation (7b) is used to obtain 100s-averaged normalized SAR in Sub6 NR Band n25 as shown in orange curve. Equation (7c) is used to obtain total time-averaged normalized SAR as shown in green curve (i.e., sum of black and orange curves).

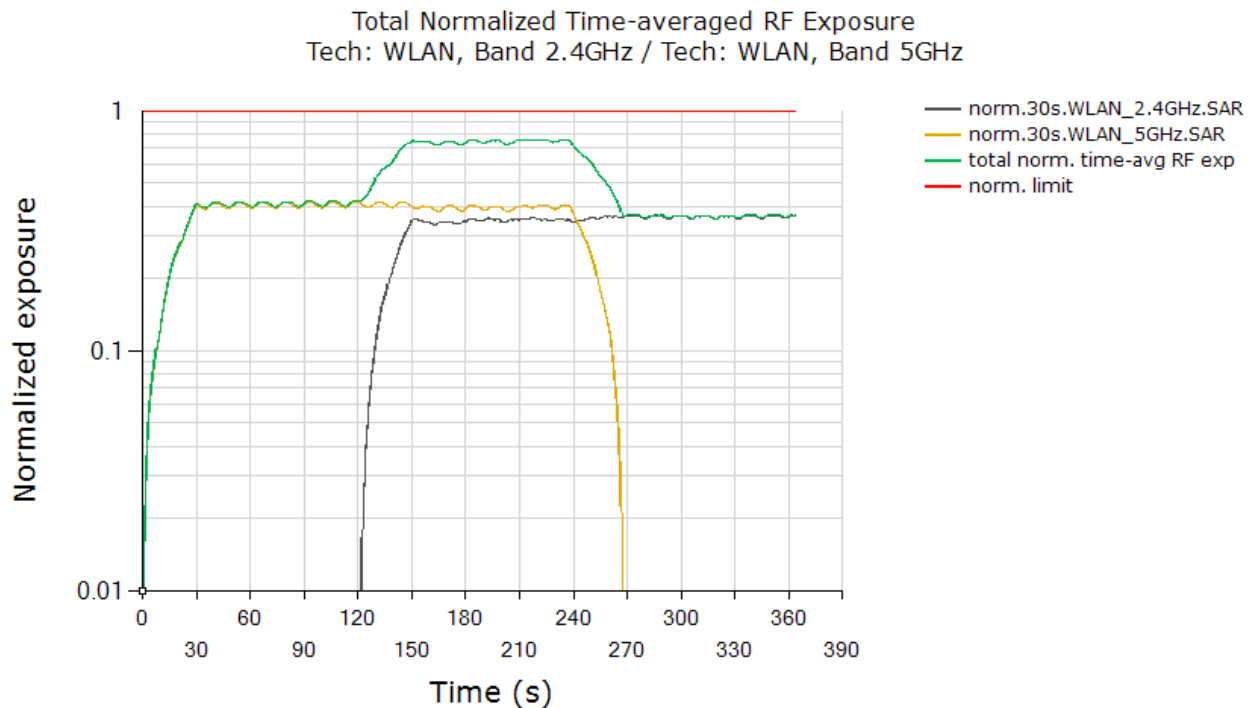


	(W/kg)
FCC normalized total exposure limit	1.0
Max 100s-time averaged normalized SAR (green curve)	0.488
Validated	

Plot Notes: Device starts predominantly in Sub6 NR SAR exposure scenario between 0s and 120s, and LTE SAR + Sub6 NR SAR exposure scenario between 120s and 240s, and in predominantly in LTE SAR exposure scenario after t=240s, Here, This corresponds to a normalized 10gSAR exposure value = 0.401 W/kg measured SAR at Sub6 NR $P_{limit} / 4.0$ W/kg limit = 0.403 ± 1.0dB device related uncertainty (see orange curve between 0s~120s). For predominantly LTE SAR exposure scenario, maximum normalized 10gSAR exposure should correspond to 100% exposure margin = 0.295 W/kg measured SAR at LTE $P_{limit} / 4.0$ W/kg limit = 0.293 ± 1.0dB device related uncertainty (see black curve after t = 240s). Additionally, in SAR exposure switch test, at all times the total time-averaged normalized RF exposure (green curve) should not exceed normalized $SAR_{design_target} + 1.0$ dB device uncertainty. In this test, with a maximum normalized SAR of 0.488 being ≤ 0.79 (= 1.0/1.6 + 1.0dB device uncertainty), the above test result validated the continuity of power limiting in SAR exposure switch scenario.

6.8.2 WLAN (2.4GHz Radio+5GHz Radio) (test case 15 in Table 5-2)

This test was conducted with callbox requesting maximum power, and with the EUT in 2.4GHz MIMO(802.11ac) + 5GHz MIMO(802.11ac_VHT20) call. Following procedure detailed in Section 3.3.7 and Section B.2, and using the Measurement setup shown in Figure C-1(d) since 2.4GHz MIMO(Ant.G) and 5GHz MIMO(Ant.J) are sharing the different antenna port, the SAR exposure switch measurement is performed with the EUT in various SAR exposure scenarios, All the conducted Tx power measurement results were converted into time-averaged normalized SAR values using Equation (7a), (7b) and (7c), and plotted below to demonstrate that the time-averaged normalized SAR versus time does not exceed the FCC limit of 1.0 unit. Equation (7a) is used to convert the WLAN Tx power of device to obtain 30s-averaged normalized SAR in 2.4GHz MIMO(802.11ac) as show in black curve. Similarly, equation (7b) is used to obtain 30s-averaged normalized SAR in 5GHz MIMO(802.11ac_VHT20) as shown in orange curve. Equation (7c) is used to obtain total time-averaged normalized SAR as shown in green curve (i.e., sum of black and orange curves).



	(W/kg)
FCC normalized total exposure limit	1.0
Max 100s-time averaged normalized SAR (green curve)	0.761
Validated	

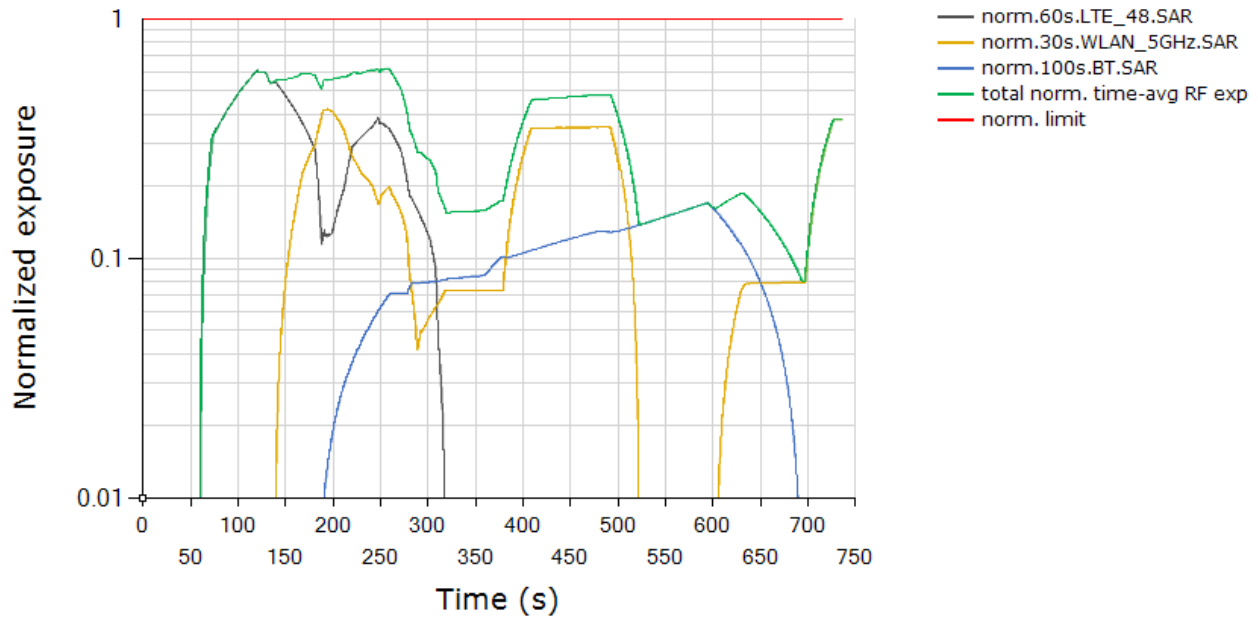
Plot Notes: Device starts predominantly in 5GHz MIMO(802.11ac_VHT20) SAR exposure scenario between 0s and 120s, and 2.4GHz MIMO(802.11ac) + 5GHz MIMO(802.11ac_VHT20) SAR exposure scenario between 120s and 240s, and in predominantly in 2.4GHz MIMO(802.11ac) exposure scenario after t=240s, in SAR exposure switch test, at all times the total time-averaged normalized RF exposure (green curve) should not exceed normalized SAR_design_target + 1.0dB device uncertainty. In this test, with a maximum normalized SAR of 0.761 being $\leq 0.79 (= 1.0/1.6 + 1.0\text{dB device uncertainty})$, the above test result validated the continuity of power limiting in SAR exposure switch scenario.

6.9. System Level Compliance Continuity test results (test case 16 in Table 5-2)

Following procedure detailed in Section 3.3.8 using the measurement setup shown in Figure C-1(e). Tech/Band/Ant/DSI and Parameters & Values used in the test are shown in the table;

Tech/Band/Ant/DSI	Parameters	Values	
	multi_Tx_factor	1.0	
LTE Band 48 Ant.F	meas. Pmax	21.67	dBm
	meas. Plimit	17.95	dBm
	meas. 10gSAR at Plimit	2.400	W/kg
	Time window applied for averaging	60s	
5GHz MIMO Ant.J (802.11ac_VHT80)	meas. Pmax	16.51	dBm
	meas. Plimit	15.71	dBm
	meas. 1gSAR at Plimit	0.742	W/kg
	Time window applied for averaging	30s	
BT (EDR) Ant.H	meas. Plimit	13.24	dBm
	meas. 1gSAR at Plimit	0.516	W/kg
	Time window applied for averaging	100s	

Total Normalized Time-averaged RF Exposure
Tech: WLAN, Band 5GHz / Tech: LTE, Band 48 / Tech: BT



Max total time averaged normalized SAR (green curve)	0.611
Validated	

In this test, the total time-averaged normalized RF exposure (green curve) did not exceed normalized limit of 1.0 at all times, the above test result validated the total RF exposure compliance in system level compliance continuity test scenario.

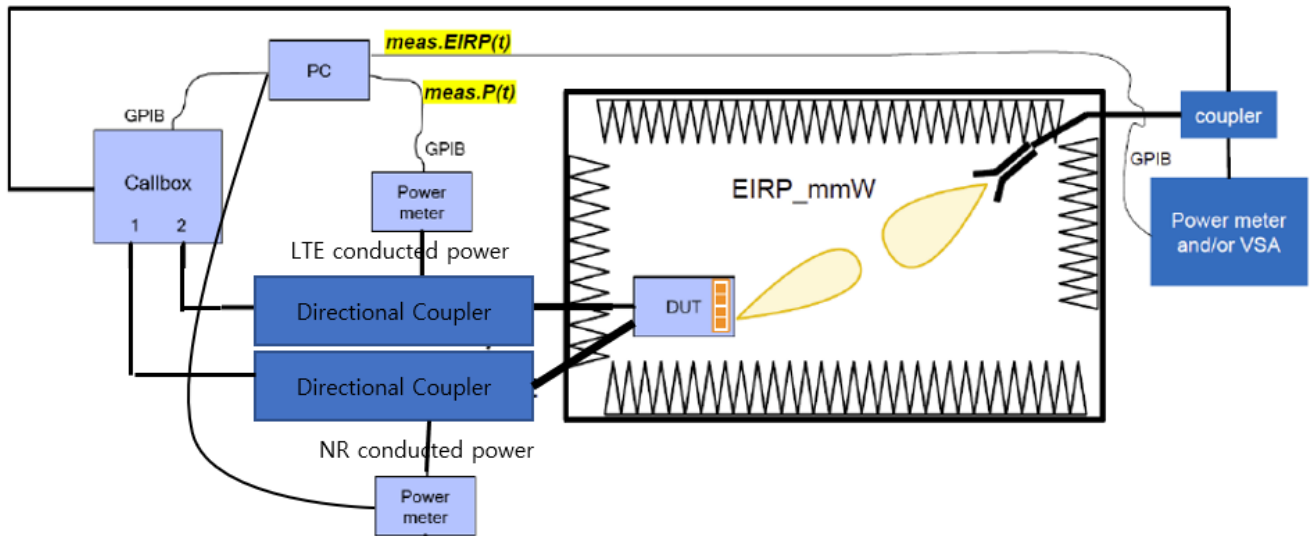


Figure C-2 Switch between sub6 and mmW favor modes measurement setup

Both the callbox and power meters are connected to the PC using USB cables. Test scripts are custom made for automation of establishing LTE + mmW call, LTE + sub6 NR call, and sub6 NR + mmW call conducted Tx power recording for LTE, Sub6 NR and radiated Tx power recording for mmW. These tests are manually stopped after desired time duration. Test script is programmed to set LTE Tx power to all-down bits on the callbox immediately after the mmW link is established, and programmed to set toggle between all-up and all-down bits depending on the transmission scenario being evaluated. Similarly, test script is also programmed to send beam switch command manually to the EUT via USB connection. For all the tests, the callbox is set to request maximum Tx power in mmW NR radio from EUT all the time.

Test configurations for this validation are detailed in Section 5.2. Test procedures are listed in Section 4.4.

7.2. mmW NR radiated power test results

To demonstrate the compliance, the connected Tx power of LTE Band 66 in DSI = 0 is converted to 1gSAR exposure by applying the corresponding worst-case 1gSAR value at P_{limit} as reported in Part 1 report and listed in Table 5-2 of this report.

Similarly, following Step 4 in Section 4.3.1 and 4.4, radiated Tx power of mmW Band n261 for the beams tested is converted by applying the corresponding worst-case 4cm²PD values measured in UL lab, and listed in below Table 8-1. The measured EIRP at *input.power.limit* for the beams tested in this section are also listed in Table 8-1. Qualcomm Smart Transmit feature operates based on time-averaged Tx power reported on a per symbol basis, which is independent of modulation, channel and bandwidth (RBs), therefore the worst-case 4cm²PD was conducted with the EUT in FTM mode, with CW modulation and 100% duty cycle.

Both the worst-case 1gSAR and 4cm²PD values used in this section are listed in Table 8-1. The measured EIRP at *input.power.limit* for the beams tested in this section are also listed in Table 8-1.

Table 8-1: EIRP measured at *input.power.limit* for the selected configurations

Test Case	Test Scenario	Antenna	mmW Band	mmW Beam ID	input.power.limit (dBm)	Configuration	Meas. 4cm ² PD at input.power.limit (W/m ²)	Meas. EIRP at input.power.limit (dBm)
1	Max.Power Test	K-patch	n261	Beam ID 165	1.2	Phablet-Rear	4.93	19.20
2	SAR vs. PD Switch	K-patch	n261	Beam ID 165	1.2	Phablet-Rear	4.93	19.20
3	Beam Switch	K-patch	n261	Beam ID 27	4.5	Phablet-Rear	4.57	19.10
				Beam ID 2	11.9	Phablet-Rear	4.48	15.20
4	Favor Mode Switch	K-patch	n261	Beam ID 165	1.2	Phablet-Rear	4.93	19.20

Tech	Antenna	Band	DSI	Configuration	meas. P _{limit} (dBm)	meas 1g SAR at P _{limit} (W/kg)
LTE Anchor	Ant.B	66	0	Bottom	19.08	0.629
NR	Ant.F	n25	0	Top	20.29	0.591

The 4cm²-averaged PD distributions for the highest PD value per band, as listed in Table 8-1, are plotted below:

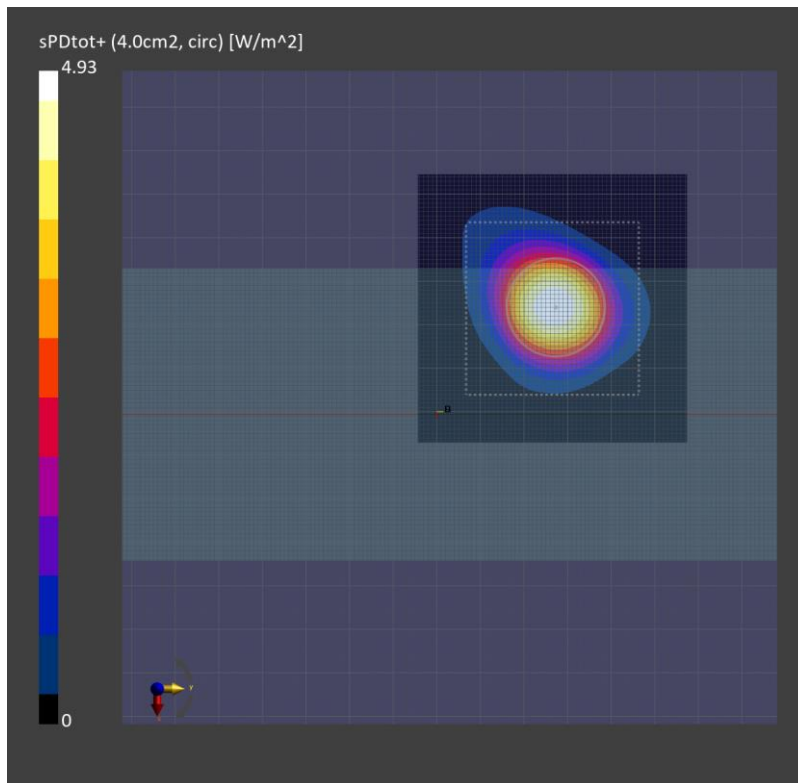


Figure C-3 4cm²-averaged power density distribution measured at *input.power.limit* of 1.2 dBm on the Rear Surface n261 beam ID 165.

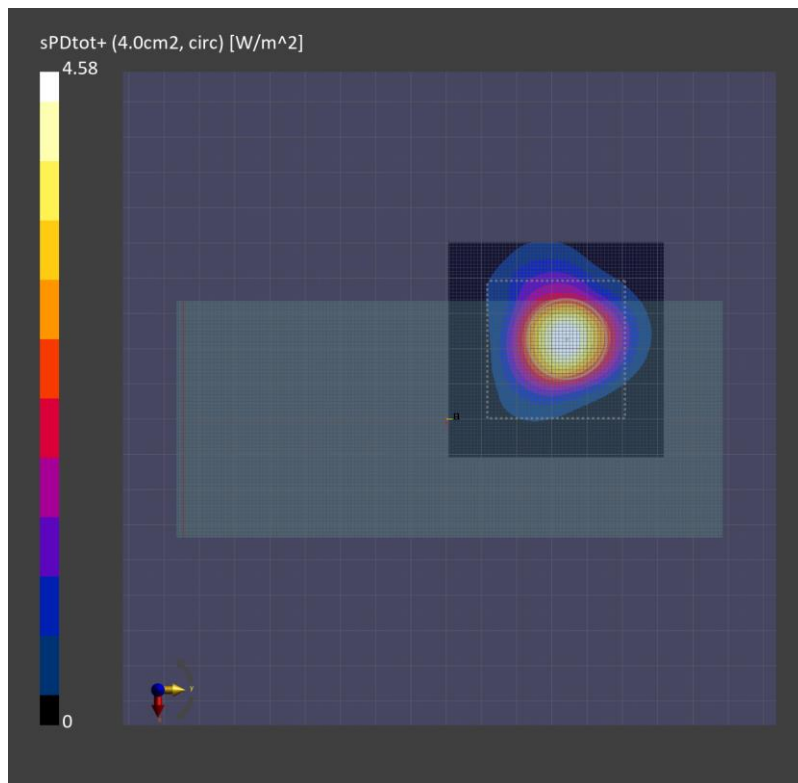


Figure C-3 4cm²-averaged power density distribution measured at *input.power.limit* of 4.5 dBm on the Rear Surface n261 beam ID 27.

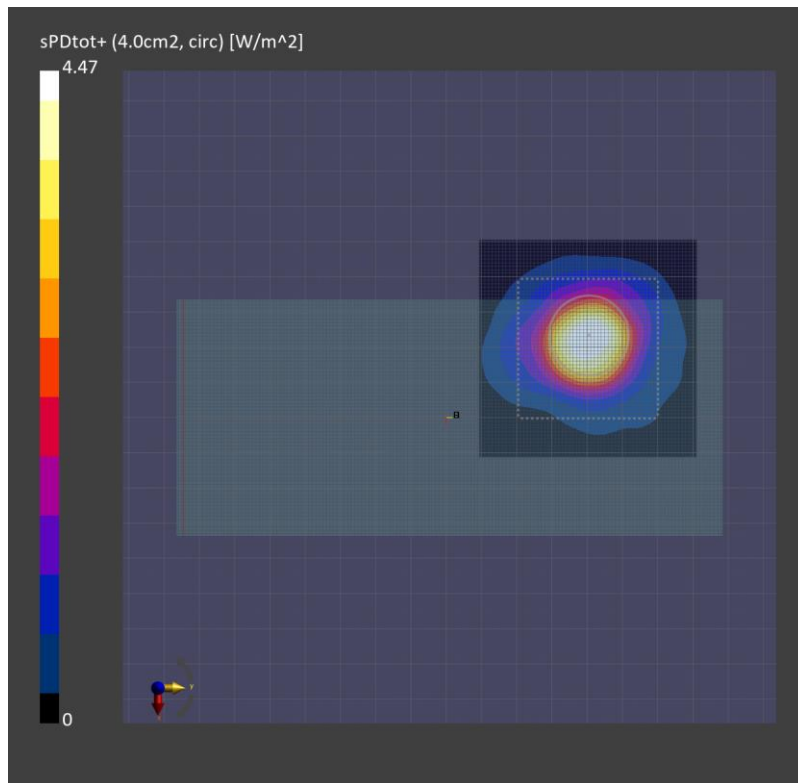


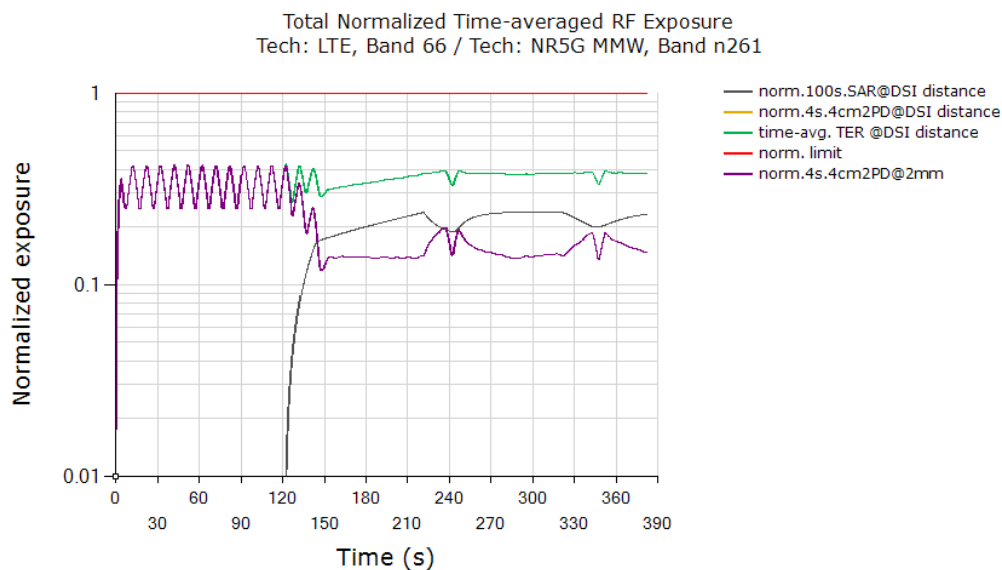
Figure C-4 4cm²-averaged power density distribution measured at *input.power.limit* of 11.9 dBm on the Rear Surface n261 beam ID 2.

7.2.1 Maximum Tx power test results for n261

This test was measured with LTE Band 66 and mmW band n261 Beam ID 165, by following the detailed test procedure described in Section 4.3.1.

Time-averaged conducted Tx power for LTE Band 66 and radiated Tx power for mmW Band n261 Beam ID 165 are converted into time-averaged 1gSAR and time-averaged 4cm²PD using Equation (2a) and (2b), which are divided by FCC 1gSAR limit 1.6 W/kg and 4cm²PD limit of 10 W/m², respectively, to obtain normalized exposures versus time. **Plot** shows (a) normalized time-averaged 1gSAR versus time, (b) normalized time-averaged 4cm²-avg.PD versus time, (c) sum of normalized time-averaged 1gSAR and normalized time-averaged 4cm²-avg.PD:

Plot : Normalized time-averaged exposure for LTE (1gSAR) and mmW (4cm²PD), as well as total normalized time-averaged exposure versus time:



FCC requirement for total RF exposure (normalized)	1.0
Max total normalized time-averaged RF exposure (green curve)	0.427
Validated	

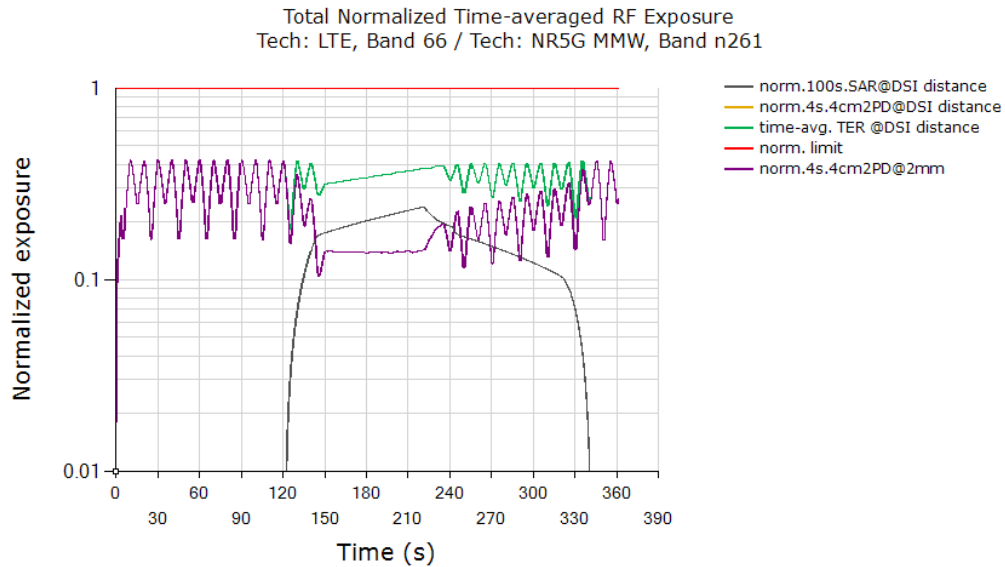
Plot notes: As soon as 5G mmW NR call was established, LTE was placed in all-down bits immediately. Between 0s ~ 120s, mmW exposure is the dominant contributor. Here, Smart Transmit feature allocates a maximum of 100% for mmW. From Table 8-1, this corresponds to a normalized 4cm²PD exposure value for Beam ID 165 of $(100\% * 6.31 \text{ W/m}^2)/(10 \text{ W/m}^2) = 63.1\% \pm 2.0\text{dB}$ device related uncertainty (See green/orange curve between 0s ~ 120s). At ~120s time mark, LTE is set to all-up bits, taking away margin from mmW exposure gradually. Towards the end of test, LTE is the dominant contributor towards RF exposure, i.e., corresponding normalized 1gSAR exposure value of $(100\% * 0.629 \text{ W/kg})/(1.6 \text{ W/kg}) = 39.3\% \pm 1.0\text{dB}$ design related uncertainty (See black curve approaching this level toward end of the test).

As can be seen, the power limiting enforcement is effective and the total normalized time-averaged RF exposure does not exceed 1.0. Therefore, Qualcomm Smart Transmit time averaging feature is validated.

7.2.2 Switch in SAR vs. PD exposure test results for n261

This test was measured with LTE Band 66 and mmW band n261 Beam ID 165, by following the detailed test procedure is described in Section 4.3.2.

Plot : Normalized time-averaged exposure for LTE (1gSAR) and mmW (4cm²PD), as well as total normalized time-averaged exposure versus time:



FCC requirement for total RF exposure (normalized)	1.0
Max total normalized time-averaged RF exposure (green curve)	0.422
Validated	

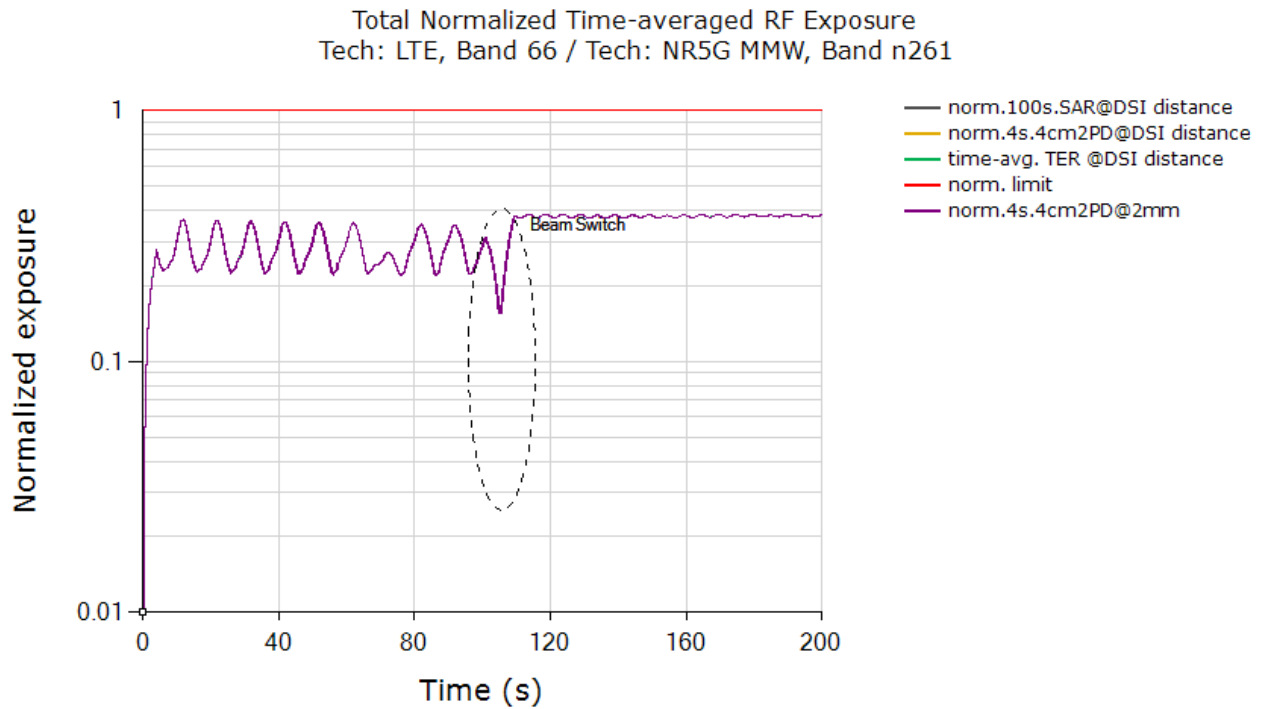
Plot notes: As soon as 5G mmW NR call was established, LTE was placed in all-down bits immediately. Between 0s ~ 120s, mmW exposure is the dominant contributor. Here, Smart Transmit feature allocates a maximum of 100% for mmW. From Table 8-1, this corresponds to a normalized 4cm²PD exposure value for Beam ID 145 of $(100\% * 6.31 \text{ W/m}^2)/(10\text{W/m}^2) = 63.1\% \pm 2.0\text{dB}$ device related uncertainty (See orange/green curve between 0s ~ 120s). At ~ 120s time mark, LTE is set to all-up bits, taking away margin from mmW exposure gradually (orange curve for mmW exposure goes down while black curve for LTE exposure goes up). At ~ 200s time mark, LTE is set to all-down bits, which results in mmW getting back RF margin slowly as seen by gradual increase in mmW exposure (orange curve for mmW exposure goes up while black curve for LTE exposure goes down). The calculated maximum RF exposure from LTE corresponds to normalized 1gSAR exposure value of $(100\% * 0.629 \text{ W/kg})/(1.6 \text{ W/kg}) = 39.3\% \pm 1.0\text{dB}$ design related uncertainty (note that this level will be achieved by green and black curves if LTE remains in all-up bits for longer time duration which was already demonstrated in maximum Tx power test in Section 8.2.1).

As can be seen, the power limiting enforcement is effective during transmission when SAR and PD exposures are switched, and the total normalized time-averaged RF exposure does not exceed 1.0. Therefore, Qualcomm Smart Transmit time averaging feature is validated.

7.2.3 Change in Beam test results for n261

This test was measured with LTE Band 66 and mmW Band n261, with beam switch from Beam ID 27 to Beam ID 2, by following the test procedure is described in Section 4.3.3.

Plot: Normalized time-averaged exposure for mmW (4cm²PD), as well as total normalized time-averaged exposure versus time:



FCC requirement for total RF exposure (normalized)	1.0
Max total normalized time-averaged RF exposure (green curve)	0.385
Validated	

Plot notes: 5G mmW NR call was established at ~1s time mark and LTE was placed in all-down bits immediately after 5G mmW NR call was established. For the rest of this test, mmW exposure is the dominant contributor as LTE is left in all-down bits. Here, Smart Transmit feature allocates a maximum of 100% for mmW. From Table 8-1, exposure between 1s ~ 100s corresponds to a normalized 4cm²PD exposure value for Beam ID 27 of $(100\% * 4.57 \text{ W/m}^2) / (10 \text{ W/m}^2) = 45.7\% \pm 2.0\text{dB}$ device related uncertainty. At ~100s time mark (shown in black dotted ellipse), the normalized 4cm²PD exposure value for n261 Beam ID 2 = $(100\% * 4.48 \text{ W/m}^2) / (10 \text{ W/m}^2) = 44.8\% \pm 2.0\text{dB}$ device related uncertainty. Additionally, during the switch, the ratio between the averaged radiated powers of the two beams (yellow curve) should correspond to the difference in EIRPs measured at each corresponding *input.power.limit* for these beams listed in Table 8-1.

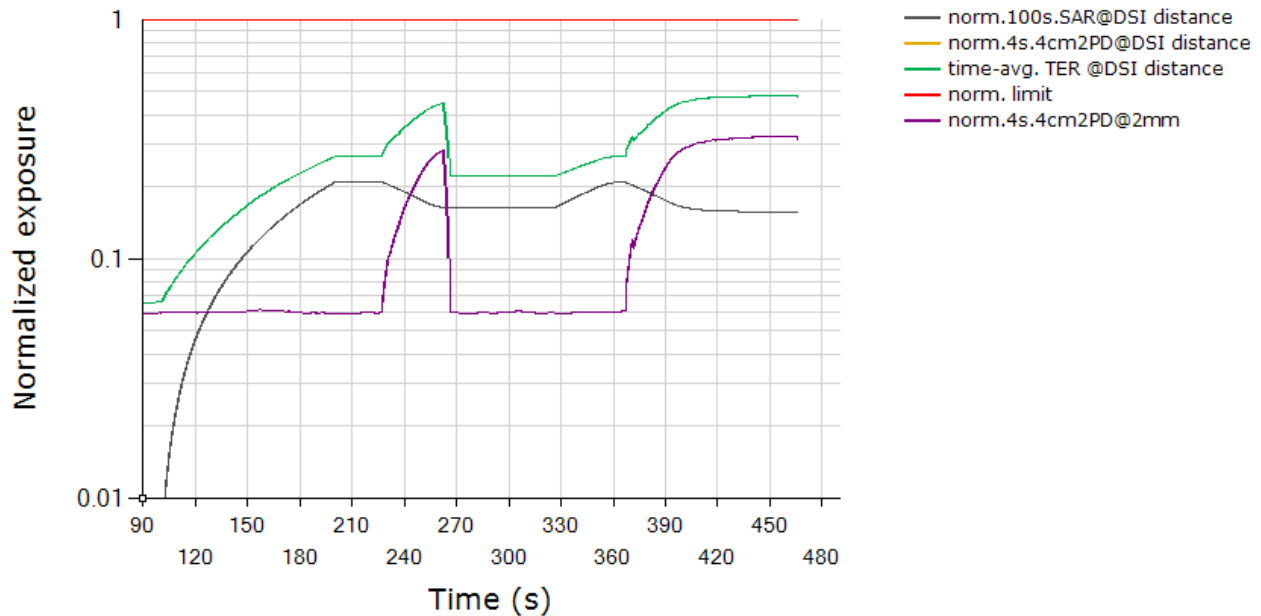
7.2.4 Switch sub6 and mmW favor modes test results for n261

This test was measured with below configurations by following the test procedures is described in Section 4.4.

Tech/Band/Ant/DSI	Parameters	Values	
LTE Band 66 Ant.B	meas. Pmax	23.61	dBm
	meas. Plimit	19.08	dBm
	meas. 1gSAR at Plimit	0.629	W/kg
	Time window applied for averaging	100s	
LTE + FR2 call start time instant		~ 230s	
FR2 n261 K Patch	meas. Beam ID	165	
	input.power.limit	1.2	dBm
	meas. EIRP @ input.power.limit	19.2	dBm
	meas. 4cm2PD at input.power.limit	4.93	W/m2
	Time window applied for averaging	4s	
LTE + FR2 to LTE + FR1 handover time instant		~ 260s	
FR1 Band n25 Ant.F	meas. Pmax	22.78	dBm
	meas. Plimit	20.29	dBm
	meas. 1gSAR at Plimit	0.591	W/kg
	Time window applied for averaging	100s	
LTE + FR1 to LTE + FR2 handover time instant		~ 380 s	

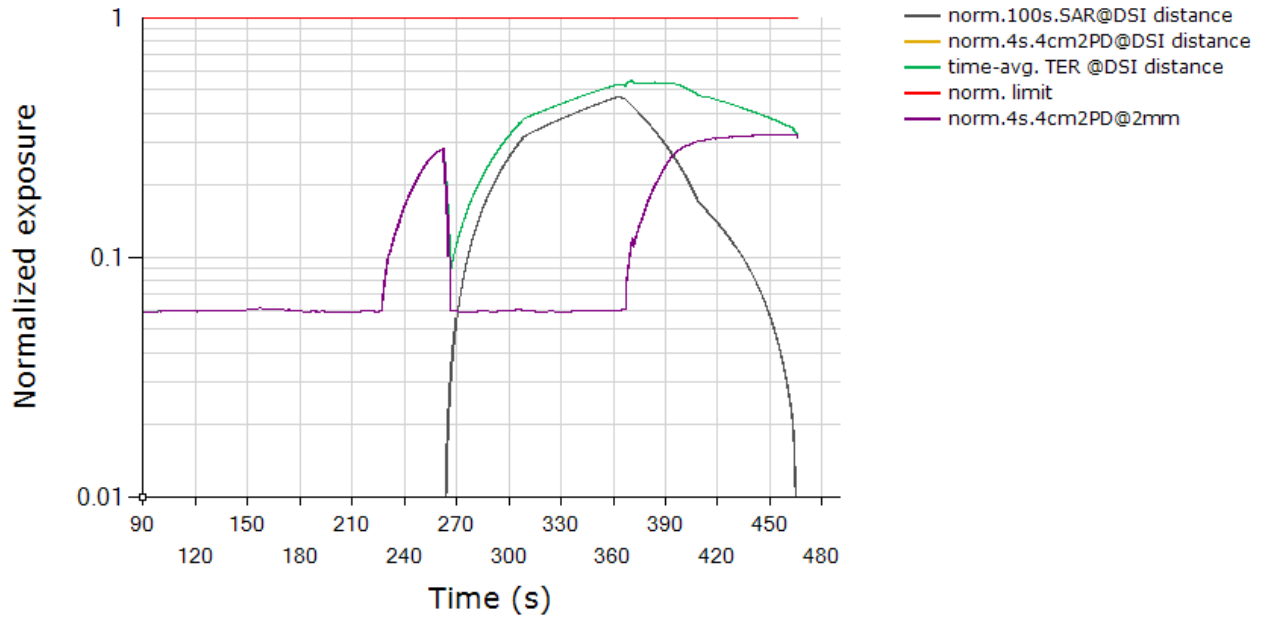
Plot : Normalized time-averaged exposure for LTE (1gSAR) and mmW (4cm²PD), as well as total normalized time-averaged exposure versus time:

Total LTE + FR2 Normalized Time-averaged RF Exposure
 Tech: LTE, Band 66 / Tech: NR5G MMW, Band n261



Plot: Normalized time-averaged exposure for NR (1gSAR) and mmW (4cm²PD), as well as total normalized time-averaged exposure versus time:

Total FR1 + FR2 Normalized Time-averaged RF Exposure
 Tech: NR5G SUB6, Band n25 / Tech: NR5G MMW, Band n261



	(W/kg)
Max norm.100s-avg.LTE.1gSAR + norm.4s-avg.FR2.4cm2PD	0.484
Max norm.100s-avg.FR1.1gSAR + norm.4s-avg.FR2.4cm2PD	0.550
Validated	

As the total normalized time-averaged RF exposure versus time didn't exceed the normalized limit of 1.0 for both the plots, the above test result validated the time-averaged RF exposure compliance continuity when switching between sub6 favor mode and mmW favor mode.

8. Test Equipment

The measuring equipment used to perform the tests documented in this report has been calibrated in accordance with the manufacturers' recommendations, and is traceable to recognized national standards.

Conducted test

Name of Equipment	Manufacturer	Type/Model	Serial No.	Cal. Due Date
UXM 5G Wireless Test Platform	Keysight	E7515B	MY59150850	1-9-2024
Base Station Simulator	R & S	CMW500	169803	1-5-2024
Base Station Simulator	R & S	CMW500	169799	8-2-2023
Directional Coupler	MINI-CIRCUITS	ZUDC20-183+	N/A	8-2-2023
Directional Coupler	MINI-CIRCUITS	ZUDC20-183+	N/A	8-2-2023
Directional Coupler	KRYTAR	100318010	215542	1-5-2024
Resistive Power Splitter	WEINSCHEL	1534	S0244	1-5-2024
Resistive Power Splitter	WEINSCHEL	1534	S0244	1-5-2024
Band Pass Filter	MINI-CIRCUITS	VBFZ-2340-S+	S0240	1-6-2024
Power Sensor	R & S	NRP8S	104520	8-3-2023
Power Sensor	R & S	NRP8S	104521	8-3-2023
Power Sensor	R & S	NRP8S	111164	8-3-2023
Step Attenuator	AGILENT	8494B	MY42155316	8-2-2023
Semi-anechoic chamber	octoScope	OB-26	OB2690605-01	N/A

Radiated test

Name of Equipment	Manufacturer	Type/Model	Serial No.	Cal. Due Date
mmW Chamber	BOJAY	BJ-8827-UL2	ZHBJ2008-BU1-F253779	N/A
UXM 5G Wireless Test Platform	Keysight	E7515B	MY58010202	1-9-2024
mmWave Transceiver	Keysight	M1740A	MY58270356	1-9-2024
mmWave Transceiver	Keysight	M1740A	MY59291461	1-27-2024
Common Interface Unit	Keysight	E7770A	MY58290155	N/A
Power Sensor	R&S	NRP8S	111164	8-3-2023
Power Sensor	R&S	NRP8S	104521	8-3-2023
Power Sensor	R&S	NRP50S	101284	8-3-2023
Directional Coupler	KRYTAR	110067006	205759	8-3-2023
Directional Coupler	KRYTAR	1850	164428	8-1-2023
Directional Coupler	KRYTAR	1850	164430	8-1-2023

9. Conclusions

Qualcomm Smart Transmit feature employed in Samsung device (FCC ID: A3LSMF946U) has been validated through the conducted/radiated power measurement (as demonstrated in Section 6 & 7).

As demonstrated in this report, the power limiting enforcement is effective and the total normalized time-averaged RF exposure does not exceed 1.0 for all the transmission scenarios described in Section 2. Therefore, the EUT complies with FCC RF exposure requirement.

Section A. Test Sequences

Sub.6 radio.

1. Test sequence is generated based on below parameters of the EUT:

- a. Measured maximum power (P_{max})
- b. Measured Tx_power_at_SAR_design_target (P_{limit})
- c. Reserve_power_margin (dB)
 - $P_{reserve}$ (dBm) = measured P_{limit} (dBm) – Reserve_power_margin (dB)
- d. SAR_time_window (100s for FCC)

2. **Sub.6 radio Test Sequence 1** Waveform:

Based on the parameter above, the Test Sequence 1 is generated with one transmission between high and low Tx powers. Here, high power = P_{max} ; low power = $P_{max}/2$, and the transition occurs after 80 seconds at high power P_{max} . As long as the power enforcement is taking into effective during one 100s/60s time window, the validation test with this defined test sequence 1 is valid, otherwise, select other radio configuration (band/DSI within the same technology group) having lower P_{limit} for this test. The test sequence 1 waveform is shown below:

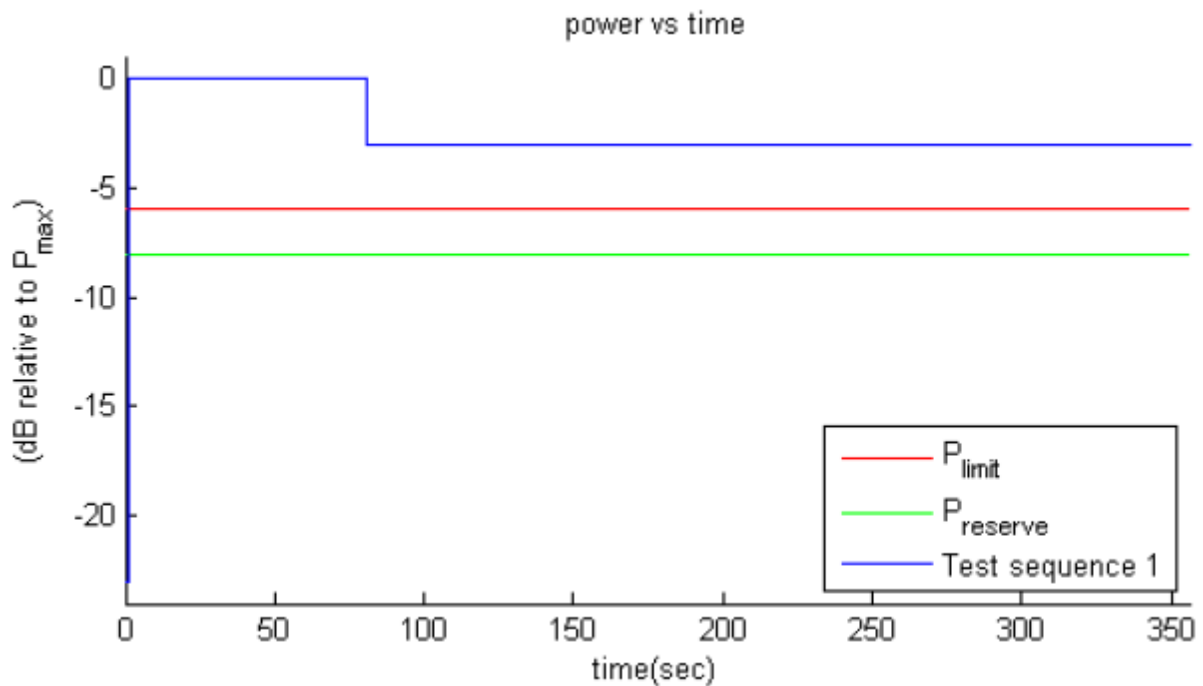


Figure A-1: Test sequence 1 waveform

3. **Sub.6 radio Test Sequence 2** Waveform:

Based on the parameters in Figure A-1, the Test Sequence 2 is generated as described in Table A-1, which contains two 170 second-long sequences (yellow and green highlighted rows) that are mirrored around the center row of 20s, resulting in a total duration of 360 seconds:

Table A-1: Test sequence 2

Time duration (seconds)	dB relative to P_{limit} or $P_{reserve}$
15	$P_{reserve} - 2$
20	P_{limit}
20	$(P_{limit} + P_{max})/2$ averaged in mW and rounded to nearest 0.1 dB step
10	$P_{reserve} - 6$
20	P_{max}
15	P_{limit}
15	$P_{reserve} - 5$
20	P_{max}
10	$P_{reserve} - 3$
15	P_{limit}
10	$P_{reserve} - 4$
20	$(P_{limit} + P_{max})/2$ averaged in mW and rounded to nearest 0.1 dB step
10	$P_{reserve} - 4$
15	P_{limit}
10	$P_{reserve} - 3$
20	P_{max}
15	$P_{reserve} - 5$
15	P_{limit}
20	P_{max}
10	$P_{reserve} - 6$
20	$(P_{limit} + P_{max})/2$ averaged in mW and rounded to nearest 0.1 dB step
20	P_{limit}
15	$P_{reserve} - 2$

The test Sequence 2 waveform is shown in Figure A-2.

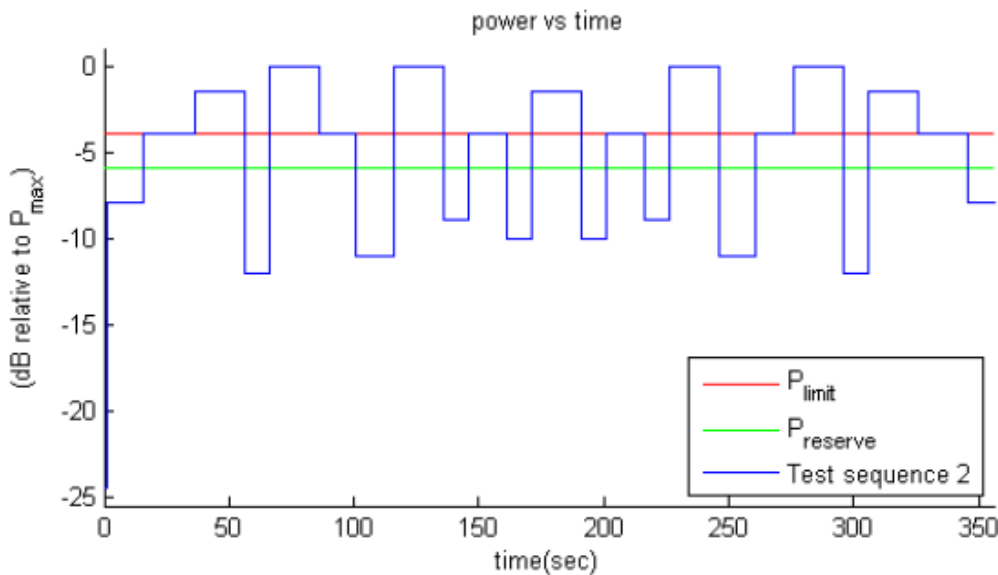


Figure A-2: Test sequence 2 waveform

WLAN radio Test Sequence 1

Time duration (seconds)	Duty cycle (%)
80	100%
120	50%

Section B. Test Procedures for LTE + Sub6 NR

Section B provides the test procedures for validating Qualcomm Smart Transmit feature for LTE + Sub6 NR non-standalone (NSA) mode transmission scenario, where sub-6GHz LTE link acts as an anchor, and Sub6 NR standalone mode (SA) transmission scenario.

B.1 Time-varying Tx power test for sub6 NR in NSA mode and SA mode

Follows Section 3.2.1 to select test configurations for time-varying test. This test is performed with two pre-defined test sequences (described in Section 3.1) applied to Sub6 NR (with LTE on all-down bits or low power for the entire test after establishing the LTE + Sub6 NR call with the callbox). Follow the test procedures described in Section 3.3.1 to demonstrate the effectiveness of power limiting enforcement and that the time averaged Tx power of Sub6 NR when converted into 1g or 10gSAR values does not exceed the regulatory limit at all times (See Eq. (1a) and (1b)). Sub6 NR response to test sequence 1 and test sequence 2 will be similar to other technologies (say, LTE), and are shown in Sections 6.3.7 and 6.3.8.

B.2 Switch in SAR exposure between LTE vs. Sub6 NR during transmission

This test is to demonstrate that Smart Transmit feature accurately accounts for switching in exposures among SAR for LTE radio only, SAR from both LTE radio and sub6 NR, and SAR from sub6 NR only scenarios, and ensures total time-averaged RF exposure compliance with FCC limit.

Test procedure:

1. Measure conducted Tx power corresponding to P_{limit} for LTE and sub6 NR in selected band. Test condition to measure conducted P_{limit} is:
 - Establish device in call with the callbox for LTE in desired band. Measure conducted Tx power corresponding to LTE P_{limit} with Smart Transmit enable and *Reserve_power_margin* set to 0 dB, callbox set to request maximum power.
 - Repeat above step to measure conducted Tx power corresponding to Sub6 NR P_{limit} . If testing LTE + Sub6 NR in non-standalone mode, then establish LTE + Sub6 NR call with callbox and request all down bits for radio1 LTE. In this scenario, with callbox requesting maximum power from Sub6 NR, measured conducted Tx power corresponds to radio2 P_{limit} (as radio1 LTE is at all-down bits).
2. Set *Reserve_power_margin* to actual (intended) value with EUT setup for LTE_Sub6 NR call. First, establish LTE connection in all-up bits with the callbox, and then Sub6 NR connection is added with callbox requesting UE to transmit at maximum power in Sub6 NR. As soon as the Sub6 NR connection is established, request all-down bits on LTE link (otherwise, Sub6 NR will not have sufficient RF exposure margin to sustain the call with LTE in all-up bits). Continue LTE(all-down bits) + Sub6 NR transmission for more than one time-window duration to test predominantly Sub6 NR SAR exposure scenario (as SAR exposure is negligible from all-down bits in LTE). After at least one time-window, request LTE to go all-up bits to test LTE SAR and Sub6 NR SAR exposure scenario. After at least one more time-window, drop (or request all-down bits) Sub6 NR transmission to test predominantly LTE SAR exposure scenario. Continue the test for at least one more time-window. Record the conducted Tx powers for both LTE and Sub6 NR for the entire duration of this test.

3. Once the measurement is done, extract instantaneous Tx power versus time for both LTE and Sub6 NR links. Similar to technology/band switch test in Section 3.3.3, convert the conducted Tx power for both these radios into 1g or 10gSAR value (see Eq. (6a) and (6b)) using corresponding technology/band P_{limit} measured in Step 1, and then perform 100s running average to determine time-averaged 1g or 10gSAR versus time as illustrated in Figure A-1. Note that here it is assumed both radios have Tx frequencies < 3GHz, otherwise, 60s running average should be performed for radios having Tx frequency between 3GHz and 6GHz.

4. Make one plot containing: (a) instantaneous 1g or 10gSAR versus time determined in Step 3, (b) computed time-averaged 1g or 10gSAR versus time determined in Step 3, and (c) corresponding regulatory 1g or 10gSAR_{limit} of 1.6 W/kg or 4.0 W/kg, and (d) corresponding normalized regulatory 1g or 10gSAR_{limit} of 1.0.

The validation criteria is, at all times, the time-averaged 1g or 10gSAR versus time shall not exceed the regulatory 1g or 10gSAR_{limit} limit.

Appendixes

Refer to separated files for the following appendixes.

4790748041-S1 FCC Report RF exposure Part2_App A_Test setup photos

End OF REPORT